



TPS65911x Integrated Power Management Unit Top Specification

1 Device Overview

1.1 Features

The Purpose of the TPS65911 Device is to Provide the Following Resources:

- Embedded Power Controller (EPC) with EEPROM Programmability
- Two Efficient Step-Down DCDC Converters for Processor Cores (VDD1, VDD2)
- One Efficient Step-Down DCDC Converter for I/O Power (VIO)
- One Controller for External FETs (VDDCtrl)
- Dynamic Voltage Scaling for Processor Cores
- Eight LDO Voltage Regulators and one RTC LDO (Supply for Internal RTC)
- One High-Speed I²C Interface for General-Purpose Control Commands (CTL-I²C)
- Two Independent Enable Signals for Controlling Power Resources (EN1, EN2). Alternatively, these Pins can be Used as a High-Speed I²C Interface Dedicated for Voltage Scaling for VDD1 and VDD2.
- Thermal Shutdown Protection and Hot-Die Detection
- A Real-Time Clock (RTC) Resource with:
 - Oscillator for 32.768-kHz Crystal or 32-kHz Built-in RC Oscillator
 - Date, Time, and Calendar
 - Alarm Capability
- Nine Configurable GPIOs with Multiplexed Feature Support:
 - Four can be used as Enable for External Resources, Included into Power-up Sequence and Controlled by State-Machine.
 - As GPI, GPIOs Support Logic-Level Detection and can Generate Maskable Interrupt for Wake-up.
 - Two of the GPIOs have 10-mA Current Sink Capability for Driving LEDs.
 - DCDCs Switching Synchronization through an External 3-MHz Clock.
- Two Reset Inputs, for Cold Reset (HDRST) and a Power Initialization Reset (PWRDN) for Thermal Reset Input
- 32-kHz Clock and Reset (NRESPWRON) for System and an Additional Output for Reset Signal
- Watchdog
- Two ON and OFF LED Pulse Generators and One PWM Generator
- Two Comparators for System Control, Connected to VCCS Pin
- A JTAG[®] and Boundary Scan, but not Accessible in Functional Mode (Test Purpose)

1.2 Applications

- Portable and Handheld Systems

1.3 Description

The TPS65911 is an integrated Power Management IC available in 98-pin 0.65-mm pitch BGA package and dedicated to applications powered by one Li-Ion or Li-Ion polymer battery cell or 3-series Ni-MH cells or a 5 V input, and which require multiple power rails. The device provides three step-down converters, one controller for external FETs to support high current rail, eight LDOs, and is designed to be flexible PMIC for supporting different processors and applications.

Two of the step-down converters provide power for dual processor cores and support dynamic voltage scaling by a dedicated I²C interface for optimum power savings. The third converter provides power for the I/Os and memory in the system.

The device includes eight general-purpose LDOs providing a wide range of voltage and current capabilities. Five of the LDOs support 1.0 to 3.3 V with 100-mV step and three (LDO1, LDO2, LDO4) support 1.0 to 3.3 V with 50-mV step. All LDOs are fully controllable by the I²C interface.

In addition to the power resources, the device contains an EPC to manage the power sequencing requirements of systems and an RTC. Power sequencing is programmable by EEPROM.



Table 1-1. Device Information

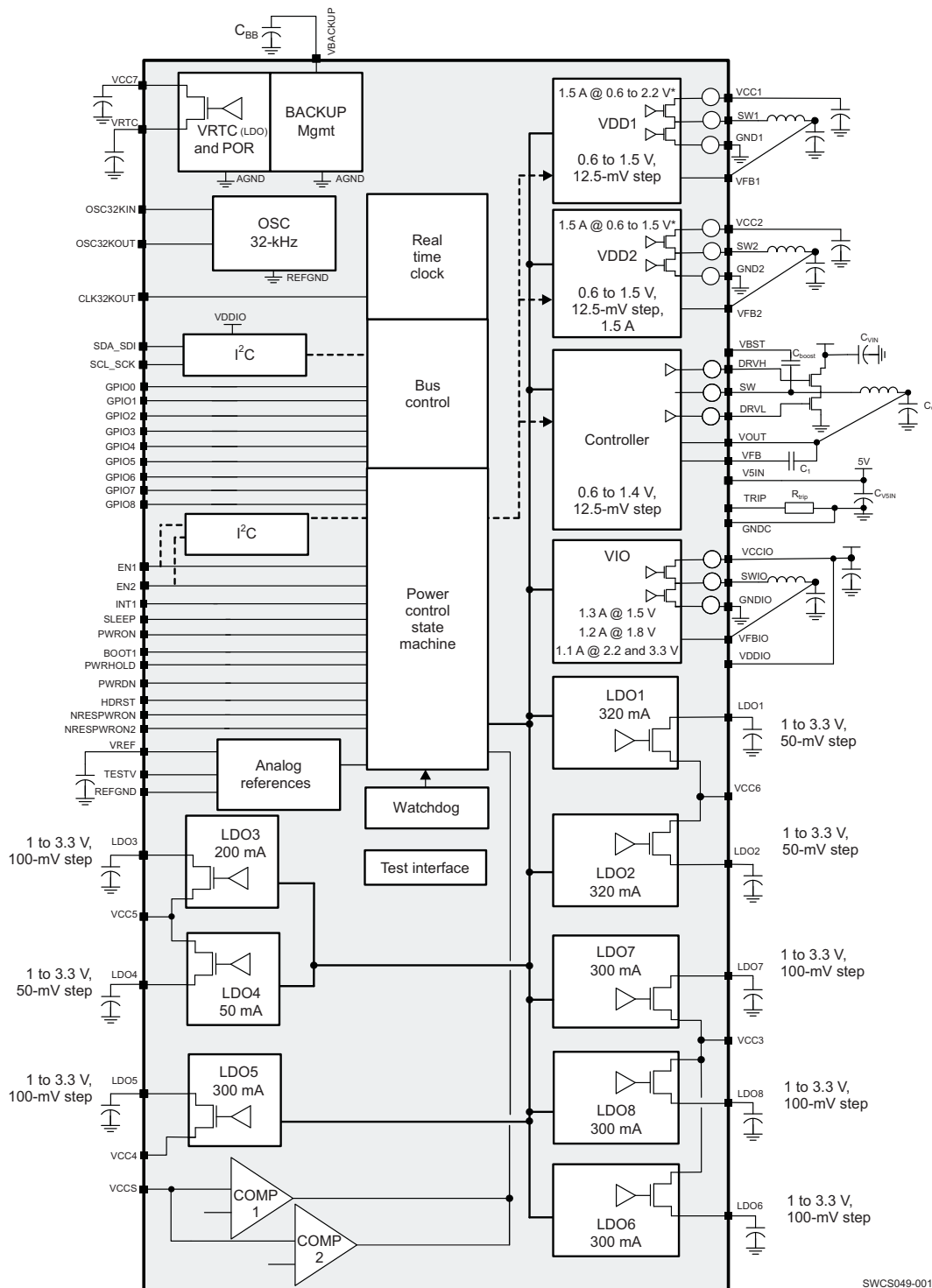
PART NUMBER	PACKAGE	BODY SIZE
TPS659110 ⁽¹⁾⁽²⁾	BGA (98)	9,00 mm x 6,00 mm
TPS659112 ⁽¹⁾	BGA (98)	9,00 mm x 6,00 mm
TPS659113 ⁽¹⁾⁽²⁾	BGA (98)	9,00 mm x 6,00 mm
TPS659116 ⁽²⁾	BGA (98)	9,00 mm x 6,00 mm
TPS65911062 ⁽¹⁾⁽²⁾	BGA (98)	9,00 mm x 6,00 mm

(1) For various part numbers, contact your TI representative.

(2) Please refer to the corresponding user's guide for the complete EEPROM setting before ordering.

1.4 Functional Block Diagram

Figure 1-1 shows the top-level diagram of the device.



For details on supported levels, see Section 5.16, Section 5.17, and Table 8-1.

Figure 1-1. Top-Level Functional Block Diagram

2 Revision History

This data sheet revision history highlights the technical changes made to the SWCS049 device-specific data sheet. From a more detailed list of revision notes, see [Section 13](#).

Changes from Revision L (June 2010) to Revision M		Page
• Added TPS65911062		5
• Added /P to ordering type		5

3 Device Comparison

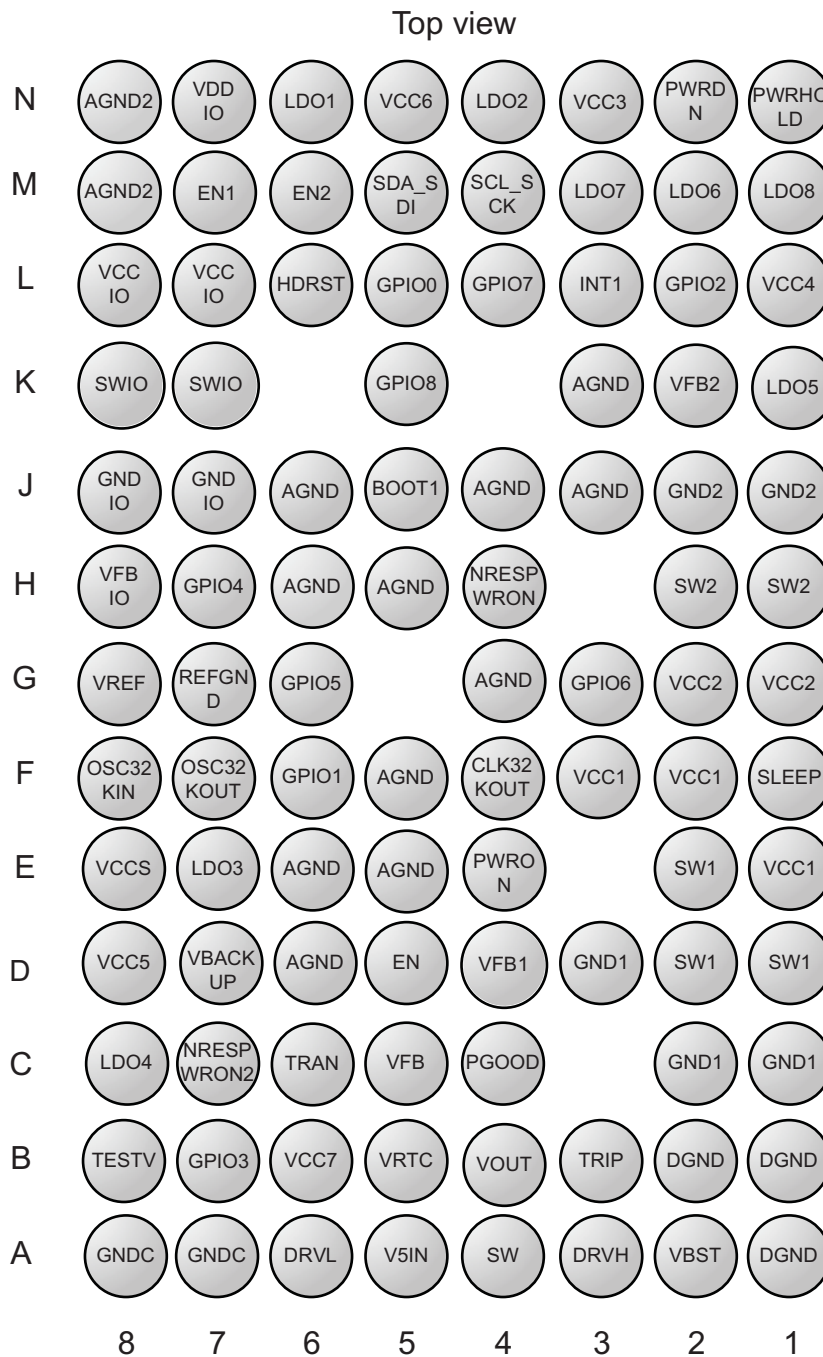
3.1 Device Comparison Table

Part Number	Ordering	Memory Support (DDR3 or DDR2)	Processors
TPS659110 ⁽¹⁾⁽²⁾	TPS6591102A2ZRC/R	DDR2	NVIDIA T30
	TPS6591104A2ZRC/R	DDR3	NVIDIA T30
TPS659112 ⁽¹⁾	TPS659112A2ZRC/R	N/A	DM8168, DM8167, C6A8168, C6A8167, AM3894, AM3892
TPS659113 ⁽¹⁾⁽²⁾	TPS659113A2ZRC/R	N/A	DM8148, DM8147, DM8146, C6A8148, C6A8147, C6A8143, AM3874, AM3872, AM3871
TPS659116 ⁽¹⁾	TPS659116A2ZRC/R	N/A	Open silicon – Cavium
TPS65911062 ⁽¹⁾⁽²⁾	PTPS65911062A2ZRC/R/P	N/A	NVIDIA T30

(1) Please refer to the corresponding user's guide for the complete EEPROM setting before ordering.

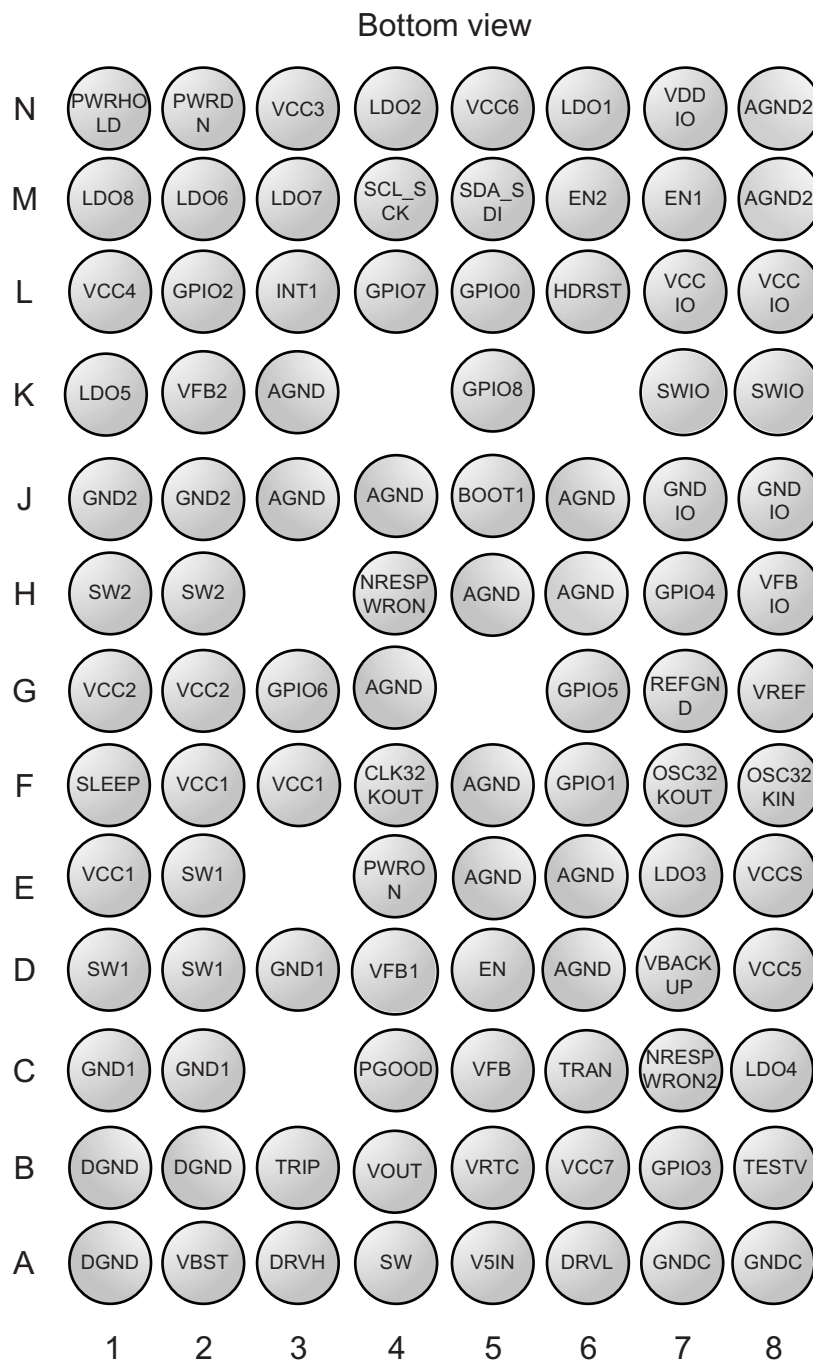
(2) For various part numbers, contact your TI representative.

4 Terminal Configuration and Functions



SWCS049-002

Figure 4-1. Ball Assignment - Top View



SWCS049-003

Figure 4-2. Ball Assignment - Bottom View

Table 4-1. Terminal Functions

NAME	BGA PIN	SUPPLIES	TYPE	I/O	DESCRIPTION	PU / PD
VDDIO	N7	VDDIO/DGND	Power	I	Digital I/O supply	No
SDA_SDI	M5	VDDIO/DGND	Digital	I/O	I ² C bi-directional data signal / Serial Peripheral Interface Data Input (multiplexed)	External PU
SCL_SCK	M4	VDDIO/DGND	Digital	I/O	I ² C bi-directional clock signal / Serial Peripheral Interface Clock Input (multiplexed)	External PU
SLEEP	F1	VDDIO/DGND	Digital	I	ACTIVE-SLEEP state transition control signal	Programmable PD (default active)
PWRHOLD	N1	VRTC/DGND	Digital	I	Switch-on, switch off control signal / GPI	Programmable PD (default active)
PWRON	E4	VCC7/DGND	Digital	I	External switch-on control(ON button)	Programmable PU (default active)
NRESPWRON	H4	VDDIO/DGND	Digital	O	Power off reset	PD active during device OFF state
INT1	L3	VDDIO/DGND	Digital	O	Interrupt flag	No
NRESPWRON2	C7	VRTC/DGND	Digital	O, OD	2nd NRESPWRON output	PD active during device OFF state. External pullup in ACTIVE
BOOT1	J5	VRTC/DGND	Digital	I	Power-up sequence selection	No
CLK32KOUT	F4	VDDIO/DGND	Digital	O	32-kHz clock output	PD disable in ACTIVE or SLEEP state
OSC32KIN	F8	VRTC/REFGND	Analog	I	32-kHz crystal oscillator	No
OSC32KOUT	F7	VRTC/REFGND	Analog	I	32-kHz crystal oscillator	No
VREF	G8	VCC7/REFGND	Analog	O	Bandgap voltage	No
REFGND	G7	REFGND	Analog	I/O	Reference ground	No
TESTV	B8	VCC7/AGND	Analog	O	Analog test output (DFT)	No
VBACKUP	D7	VBACKUP/AGND	Power	I	Backup Battery input	No
VCC1	E1/F2/F3	VCC1/GND1	Power	I	VDD1 DCDC power Input	No
GND1	C1/C2/D3	VCC1/GND1	Power	I/O	VDD1 DCDC Power ground	No
SW1	D1/D2/E2	VCC1/GND1	Power	O	VDD1 DCDC switched output	No
VFB1	D4	VCC7/DGND	Analog	I	VDD1 feedback voltage	PD 5uA
VCC2	G1/G2	VCC2/GND2	Power	I	VDD2 DCDC power Input	No
GND2	J1/J2	VCC2/GND2	Power	I/O	VDD2 DCDC Power ground	No
SW2	H1/H2	VCC2/GND2	Power	O	VDD2 DCDC switched output	No
VFB2	K2	VCC7/DGND	Analog	I	VDD2 DCDC feedback voltage	PD 5uA

Table 4-1. Terminal Functions (continued)

NAME	BGA PIN	SUPPLIES	TYPE	I/O	DESCRIPTION	PU / PD
VCCIO	L7/L8	VCCIO/GNDIO	Power	I	VIO DCDC power Input	No
GNDIO	J7/J8	VCCIO/GNDIO	Power	I/O	VIO DCDC Power ground	No
SWIO	K7/K8	VCCIO/GNDIO	Power	O	VIO DCDC switched output	No
VFBIO	H8	VCC7/DGND	Analog	I	VIO feedback voltage	PD 5uA
VCC3	N3	VCC3/AGND2	Power	I	LDO6, LDO7, LDO8 power Input	No
LDO8	M1	VCC3/REFGND	Power	O	LDO Regulator output	PD 5uA
LDO7	M3	VCC3/REFGND	Power	O	LDO Regulator output	PD 5uA
LDO6	M2	VCC3/REFGND	Power	O	LDO Regulator output	PD 5uA
VCC4	L1	VCC4/AGND2	Power	I	LDO5 power Input	No
LDO5	K1	VCC4/REFGND	Power	O	LDO Regulator output	PD 5uA
VCC5	D8	VCC5/AGND	Power	I	LDO3, LDO4 power Input	No
LDO3	E7	VCC5/REFGND	Power	O	LDO Regulator output	PD 5uA
LDO4	C8	VCC5/REFGND	Power	O	LDO Regulator output	PD 5uA
VRTC	B5	VCC7/REFGND	Power	O	LDO Regulator output	PD 5uA
VCC6	N5	VCC6/AGND2	Power	I	LDO1, LDO2 power Input	No
LDO1	N6	VCC6/REFGND	Power	O	LDO Regulator output	No
LDO2	N4	VCC6/REFGND	Power	O	LDO Regulator output	No
VCC7	B6	VCC7/REFGND	Power	I	VRTC power Input and analog references supply	No
AGND	D6/E5/E6/ F5/G4/H5/ H6/J3/J4/ J6/K3	AGND	Power	I/O	Analog ground	No
AGND2	M8/N8	AGND	Power	I/O	Analog ground	No
DGND	A1/B1/B2	DGND	Power	I/O	Digital ground	No
EN2	M6	VDDIO/DGND	Digital	I/O	Enable for supplies/ voltage scaling dedicated I ² C data	External PU
EN1	M7	VDDIO/DGND	Digital	I/O	Enable for supplies/ voltage scaling dedicated I ² C clock	External PU
GPIO0	L5	VCC7/DGND	Digital	I/O	GPIO, push-pull/ OD as output	OD: external PU
GPIO1	F6	VRTC/DGND	Digital	I/O, OD	GPIO/ LED1 output	OD: External PU
GPIO2	L2	VRTC/DGND	Digital	I/O, OD	GPIO/ DCDC clock synchronization	OD: External PU

Table 4-1. Terminal Functions (continued)

NAME	BGA PIN	SUPPLIES	TYPE	I/O	DESCRIPTION	PU / PD
GPIO3	B7	VRTC/DGND	Digital	I/O, OD	GPIO/ LED2 output	OD: External PU
GPIO4	H7	VRTC/DGND	Digital	I/O, OD	GPIO	OD: External PU
GPIO5	G6	VRTC/DGND	Digital	I/O, OD	GPIO	OD: external PU
GPIO6	G3	VRTC/DGND	Digital	I/O, OD	GPIO	OD: External PU
GPIO7	L4	VRTC/DGND	Digital	I/O, OD	GPIO	OD: External PU
GPIO8	K5	VRTC/DGND	Digital	I/O, OD	GPIO	OD: External PU
PWRDN	N2	VRTC/DGND	Analog	I	Reset input e.g for thermal reset	
HDRST	L6	VRTC/DGND	Digital	I	Cold reset	PD
VCCS	E8	VCC7/DGND	Analog	I/O	Input for two comparators	
VBST	A2	VBST/GNDC	Analog	I	VDDCtrl, Supply for high-side FET driver	
DRVH	A3	VBST/GNDC	Analog	O	VDDCtrl, High-side FET driver output	
SW	A4	VBST/GNDC	Analog	I	VDDCtrl, Switch node	
V5IN	A5	V5IN/GNDC	Power	I	VDDCtrl, 5V input	
DRVL	A6	V5IN/GNDC	Analog	O	VDDCtrl, FET driver output	
VOUT	B4	VOUT/GNDC	Analog	I	VDDCtrl, Feedback input	
TRIP	B3	V5IN/GNDC	Analog	I	VDDCtrl, OCL detection threshold pin	
VFB	C5	VOUT/GNDC	Analog	I	VDDCtrl, slew rate control capacitance	
PGOOD	C4	VCC7/GNDC	Analog	O, OD	VDDCtrl, internal signal, leave floating (controller trimming only)	
GNDC	A7/A8	GNDC	Power	I/O	VDDCtrl, Controller gnd	
TRAN	C6	VCC7/GNDC	Analog	I	Internal functional pin, leave floating (controller trimming only)	
EN	D5	VCC7/GNDC	Analog	I	Internal functional pin, leave floating	

5 Specifications

5.1 Absolute Maximum Ratings

Stresses beyond those listed under below may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated below are not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The absolute maximum ratings for the TPS65911 device, over operating free-air temperature range (unless otherwise noted), are listed below.

PARAMETER	MIN	MAX	UNIT
Voltage range on pins or balls VCC1, VCC2, VCCIO, VCC3, VCC4, VCC5, VCC7, VBACKUP, V5IN, TRIP	–0.3	7	V
Voltage range on pins or balls VCC6	–0.3	3.6	V
Voltage range on pins or balls VDDIO	–0.3	3.6	V
Voltage range on pins or balls VBST	–0.3	37	V
Voltage range on pins or balls SW	–5	30	V
Voltage range on pins or balls SW1, SW2, SWIO	–0.3	7	V
Voltage range on pins or balls VFB1,VFB2,VFBIO	–0.3	3.6	V
Voltage range on pins or balls VOUT, VFB	–0.3	7	V
Voltage range on pins or balls OSC32KIN,OSC32KOUT, BOOT1	–0.3	VRTCMAX + 0.3	V
Voltage range on pins or balls SDA, SDI, SCL, SCK, EN2, EN1, SLEEP, INT1, CLK32KOUT, NRESPWRON	–0.3	VDDIOMAX + 0.3	V
Voltage range on pins or balls PWRON	–0.3	7	V
Voltage range on pins or balls PWRHOLD, GPIO0	–0.3	7	V
Voltage range on balls GPIO1, GPIO2, GPIO3, GPIO4, GPIO5, GPIO6, GPIO7, GPIO8 ⁽¹⁾	–0.3	7	V
Voltage range on balls HDRST	–0.3	7	V
Voltage range on balls NRESPWRON2 ⁽¹⁾	–0.3	7	V
Voltage range on ball PWRDN ⁽²⁾	–0.3	7	V
Voltage range on ball VCCS	–0.3	7	V
Functional junction temperature range	–45	150	°C
Peak output current on all other terminals than power resources	–5.0	5.0	mA

(1) I/O supplied from VRTC but which can be driven from VCC7 or to VCC7 voltage level.

(2) Input supplied from VRTC but can be driven from VCC7 voltage level.

5.2 Handling Ratings

			MIN	MAX	UNIT
T _{stg}	Storage temperature range		–65	150	°C
V _{ESD}	Electrostatic discharge (ESD) performance:	Human Body Model (HBM), per ANSI/ESDA/JEDEC JS001 ⁽¹⁾	–2	2	kV
		Charged Device Model (CDM), per JESD22-C101 ⁽²⁾	–500	500	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP155 states that 250-V HBM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

Lists of the recommended operating maximum ratings, over operating free-air temperature range (unless otherwise noted), for the TPS65911 device are given below.

Note: VCC7 should be connected to highest supply that is connected to device VCCx pin.

Exception: VCC4, VCC5, and V5IN inputs can be higher than VCC7. VCCS can be higher than VCC7 if VMBBUF_BYPASS = 0 (buffer is enabled).

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Input voltage range on pins or balls VCC1, VCC2, VCCIO, VCC5, VCC7, VCCS, VCC4, VBACKUP		2.7	3.8	5.5	V
Input voltage range on pins or balls VCC3		1.7	3.8	5.5	V
Input voltage range on pins or balls VDDIO		1.65	1.8/3.3	3.45	
Input voltage range on pins or balls VCC6		1.4	3.3	3.6	V
Input voltage range on pin or ball V5IN		4.5		6.5	V
Input voltage range on pin or ball VBST		–0.1		3.45	V
Input voltage range on pin or ball SW (<30% of repetitive period)		–1		28	V
Input voltage range on pin or ball TRIP, VFB		–0.1		6.5	V
Input voltage range on pins or balls PWRON		0	3.8	5.5	V
Input voltage range on pins or balls SDA_SDI, SCL_SCK, EN2, EN1, SLEEP, INT1, CLK32KOUT		1.65	VDDIO	3.45	V
Input voltage range on pins or balls PWRHOLD, HDRST		1.65	VRTC	5.5	V
Input voltage range on balls GPIO0, GPIO1, GPIO2, GPIO3, GPIO4, GPIO5, GPIO6, GPIO7, GPIO8, PWRDN		1.65	VRTC	5.5	V
Input voltage range on ball VCCS		0		5.5	V
Ambient temperature range		–40	27	85	°C
Junction temperature Tj		–40	27	125	°C
Storage temperature range		–65	27	150	°C
Lead temperature (soldering, 10 sec)			260		°C

5.4 Thermal Characteristics

over operating free-air temperature range (unless otherwise noted)

THERMAL METRIC		°C/W ⁽¹⁾
R θ_{JA}	Junction-to-free air	32
R $\theta_{JC(TOP)}$	Junction-to-case top	18
R θ_{JB}	Junction-to-board	16
Ψ_{JT}	Junction-to-package top	0.2
Ψ_{JB}	Junction-to-board	12
R $\theta_{JC(BOTTOM)}$	Junction-to-case bottom	N/A

(1) These values are based on a JEDEC-defined 2S2P system (with the exception of the Theta JC [R θ_{JC}] value, which is based on a JEDEC-defined 1S0P system) and will change based on environment as well as application. For more information, see these EIA/JEDEC standards:

- JESD51-2, *Integrated Circuits Thermal Test Method Environmental Conditions - Natural Convection (Still Air)*
- JESD51-3, *Low Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages*
- JESD51-7, *High Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages*
- JESD51-9, *Test Boards for Area Array Surface Mount Package Thermal Measurements*

Power dissipation of 2 W and an ambient temperature of 70°C is assumed.

5.5 External Component Recommendation

For crystal oscillator components, see [Section 5.12](#).

Note: VCC7 supply should have enough capacitance to ensure that when supply is switched off, voltage will not fall at a rate faster than 10 mV/ms. This ensures that RTC domain data will be maintained

PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
Power References					
VREF filtering capacitor $C_{O(VREF)}$	Connected from VREF to REFGND		100		nF
VDD1 SMPS					
Input capacitor $C_{I(VCC1)}$	X5R or X7R dielectric		10		μ F
Output filter capacitor $C_{O(VDD1)}$	X5R or X7R dielectric	4	10	12	μ F
C_O filter capacitor ESR	$f = 3$ MHz		10	300	m Ω
Inductor $L_{O(VDD1)}$			2.2		μ H
L_O inductor dc resistor DCR_L				125	m Ω
VDD2 SMPS					
Input capacitor $C_{I(VCC2)}$	X5R or X7R dielectric		10		μ F
Output filter capacitor $C_{O(VDD2)}$	X5R or X7R dielectric	4	10	12	μ F
C_O filter capacitor ESR	$f = 3$ MHz		10	300	m Ω
Inductor $L_{O(VDD2)}$			2.2		μ H
L_O inductor dc resistor DCR_L				125	m Ω
VIO SMPS					
Input capacitor $C_{I(VCCIO)}$	X5R or X7R dielectric		10		μ F
Output filter capacitor $C_{O(VIO)}$	X5R or X7R dielectric	4	10	12	μ F
C_O filter capacitor ESR	$f = 3$ MHz		10	300	m Ω
Inductor $L_{O(VIO)}$			2.2		μ H
L_O inductor dc resistor DCR_L				125	m Ω
VDDCtrl SMPS					
Input capacitor C_{VIN}			4×10		μ F
High side drive boost capacitor C_{boost}			0.1		μ F
Input capacitor for V5IN supply C_{V5IN}			1		μ F
Output filter capacitor $C_{O(VDDCtrl)}$			330		μ F
C_O Filter capacitor ESR			9	15	m Ω
Inductor $L_{O(VDDCtrl)}$			2.7		μ H
L_O Inductor DC resistor DCR_L			20		m Ω
R_{trip}			40		k Ω
C_1			330		pF
FET FDMC7660					
LDO1					
Input capacitor $C_{I(VCC6)}$	X5R or X7R dielectric		4.7		μ F
Output filtering capacitor $C_{O(LDO1)}$		0.8	2.2	2.64	μ F
C_O filtering capacitor ESR		0		500	m Ω
LDO2					
Output filtering capacitor $C_{O(LDO2)}$		0.8	2.2	2.64	μ F
C_O filtering capacitor ESR		0		500	m Ω
LDO3					
Input capacitor $C_{I(VCC5)}$	X5R or X7R dielectric		4.7		μ F
Output filtering capacitor $C_{O(LDO3)}$		0.8	2.2	2.64	μ F
C_O filtering capacitor ESR		0		500	m Ω
LDO4					
Output filtering capacitor $C_{O(LDO4)}$		0.8	2.2	2.64	μ F
C_O filtering capacitor ESR		0		500	m Ω

External Component Recommendation (continued)

For crystal oscillator components, see [Section 5.12](#).

Note: VCC7 supply should have enough capacitance to ensure that when supply is switched off, voltage will not fall at a rate faster than 10 mV/ms. This ensures that RTC domain data will be maintained

PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
LDO5					
Input capacitor $C_{I(VCC4)}$	X5R or X7R dielectric		4.7		μF
Output filtering capacitor $C_{O(LDO5)}$		0.8	2.2	2.64	μF
C_O filtering capacitor ESR		0		500	m Ω
LDO6					
Input capacitor $C_{I(VCC3)}$	X5R or X7R dielectric		4.7		μF
Output filtering capacitor $C_{O(LDO6)}$		0.8	2.2	2.64	μF
C_O filtering capacitor ESR		0		500	m Ω
LDO7					
Output filtering capacitor $C_{O(LDO7)}$		0.8	2.2	2.64	μF
C_O filtering capacitor ESR		0		500	m Ω
LDO8					
Output filtering capacitor $C_{O(LDO8)}$		0.8	2.2	2.64	μF
C_O filtering capacitor ESR		0		500	m Ω
VRTC LDO					
Input capacitor $C_{I(VCC7)}$	X5R or X7R dielectric		4.7		μF
Output filtering capacitor $C_{O(VRTC)}$		0.8	2.2	2.64	μF
C_O filtering capacitor ESR		0		500	m Ω
Backup Battery					
Backup battery capacitor C_{BB}		5	10	2000	mF
Series resistors	5 to 15 mF	10		1500	Ω

5.6 I/O Pullup And Pulldown Characteristics

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
SDA_SDI, SCL_SCK, SDASR_EN2, SCLSR_EN1 external pullup resistor	Connected to VDDIO		1.2		kΩ
SDA_SDI, SCL_SCK, SDASR_EN2, SCLSR_EN1 Programmable pullup (DFT, default inactive)	Grounded, VDDIO = 1.8 V	–45%	8	+45%	kΩ
SLEEP, PWRHOLD, programmable pulldown (default active)	@ 1.8 V, VRTC = 1.8 V	2	4.5	10	μA
NRESPWRON, NRESPWRON2 pulldown	@ 1.8 V, VCC7 = 5.5 V, OFF state	2	4.5	10	μA
32KCLKOUT pulldown (disabled in ACTIVE-SLEEP state)	@ 1.8 V, VRTC = 1.8 V, OFF state	2	4.5	10	μA
PWRON programmable pullup (default active)	Grounded, VCC7 = 5.5 V	–40	–31	–15	μA
GPIO0-8 programmable pulldown (default active except GPIO0)	@ 1.8 V, VRTC = 1.8 V, OFF state	2	4.5	10	μA
GPIO0-8 external pullup resistor	Connected to VDDIO	–20%	120	+20%	kΩ
HDRST programmable pulldown (default active)	@ 1.8 V, VRTC = 1.8 V	2	4.5	10	μA

- (1) The internal pullups on the CTL-I²C and SR-I²C balls are used for test purposes or when the SR-I²C interface is not used. Discrete pullups to the VIO supply must be mounted on the board in order to use the I²C interfaces. The internal I²C pullups must not be used for functional applications

5.7 Digital I/O Voltage Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER		MIN	TYP	MAX	UNIT
Related I/Os: PWRON					
Low-level input voltage V_{IL}				$0.3 \times V_{BAT}$	V
High-level input voltage V_{IH}		$0.7 \times V_{BAT}$			V
Related I/Os: PWRHOLD, GPIO0-8, PWRDN					
Low-level input voltage V_{IL}				0.45	V
High-level input voltage V_{IH}		1.3		V_{BAT}	V
Related I/Os: BOOT1					
Low level input – Impedance between BOOT1 and GND				10	k Ω
High level input – Impedance between BOOT1 and VRTC				10	k Ω
HiZ level input – Impedance between BOOT1 and GND		500			k Ω
Related I/Os: SLEEP					
Low-level input voltage V_{IL}				$0.35 \times V_{DDIO}$	V
High-level input voltage V_{IH}		$0.65 \times V_{DDIO}$			V
Related I/Os: HDRST					
Low-level input voltage V_{IL}				$0.35 \times V_{RTC}$	V
High-level input voltage V_{IH}		$0.65 \times V_{RTC}$			V
Related I/Os: NRESPWRON, INT1, 32KCLKOUT					
Low-level output voltage V_{OL}	$I_{OL} = 100 \mu A$			0.2	V
	$I_{OL} = 2 \text{ mA}$			0.45	V
High-level output voltage V_{OH}	$I_{OH} = 100 \mu A$	$V_{DDIO} - 0.2$			V
	$I_{OH} = 2 \text{ mA}$	$V_{DDIO} - 0.45$			V
RELATED I/O'S: GPIO0 (PUSH-PULL MODE)					
Low-level output voltage V_{OL}	$I_{OL} = 100 \mu A$			0.2	V
	$I_{OL} = 2 \text{ mA}$			0.45	V
High-level output voltage V_{OH}	$I_{OH} = 100 \mu A$	$V_{CC7} - 0.2$			V
	$I_{OH} = 2 \text{ mA}$	$V_{CC7} - 0.45$			V
Related Open-Drain I/Os: GPIO0, GPIO4, GPIO5, GPIO6, GPIO8, NRESPWRON2					
Low-level output voltage V_{OL}	$I_{OL} = 100 \mu A$			0.2	V
	$I_{OL} = 2 \text{ mA}$			0.45	V
Related Open-Drain I/Os: GPIO2, GPIO7					
Low-level output voltage V_{OL}	$I_{OL} = 100 \mu A$			0.2	V
	$I_{OL} = 1.9 \text{ mA}$			0.45	V
RELATED OPEN-DRAIN I/O'S: GPIO1, GPIO3					
Low-level output voltage V_{OL}	$I_{OL} = 100 \mu A$			0.2	V
	$I_{OL} = 2 \text{ mA}$			0.4	V
I²C-Specific Related I/Os: SCL, SDA, EN1, EN2					
Low-level input voltage V_{IL}		-0.5		$0.3 \times V_{DDIO}$	V
High-level input voltage V_{IH}		$0.7 \times V_{DDIO}$			V
Hysteresis		$0.1 \times V_{DDIO}$			V
Low-level output voltage V_{OL} @ 3mA (sink current), $V_{DDIO} = 1.8 \text{ V}$				$0.2 \times V_{DDIO}$	V
Low-level output voltage V_{OL} @ 3mA (sink current), $V_{DDIO} = 3.3 \text{ V}$				$0.4 \times V_{DDIO}$	V

5.8 I²C Interface And Control Signals

over operating free-air temperature range (unless otherwise noted)

NO.	PARAMETER	TEST CONDITIONS ⁽¹⁾ ⁽²⁾	MIN	TYP	MAX
		INT1 rise and fall times, $C_L = 5$ to 35 pF	5	10	ns
		NRESPWRON rise and fall times, $C_L = 5$ to 35 pF	5	10	ns
SLAVE HIGH-SPEED MODE					
		SCL/EN1 and SDA/EN2 rise and fall time, $C_L = 10$ to 100 pF	10	80	ns
		Data rate		3.4	Mbps
I3	$t_{su}(SDA-SCLH)$	Setup time, SDA valid to SCL high	10		ns
I4	$t_h(SCLL-SDA)$	Hold time, SDA valid from SCL low	0	70	ns
I7	$t_{su}(SCLH-SDAL)$	Setup time, SCL high to SDA low	160		ns
I8	$t_h(SDAL-SCLL)$	Hold time, SCL low from SDA low	160		ns
I9	$t_{su}(SDAH-SCLH)$	Setup time, SDA high to SCL high	160		ns
SLAVE FAST MODE					
		SCL/EN1 and SDA/EN2 rise and fall time, $C_L = 10$ to 400 pF	$20 + 0.1 \times C_L$	250	ns
		Data rate		400	Kbps
I3	$t_{su}(SDA-SCLH)$	Setup time, SDA valid to SCL high	100		ns
I4	$t_h(SCLL-SDA)$	Hold time, SDA valid from SCL low	0	0.9	μs
I7	$t_{su}(SCLH-SDAL)$	Setup time, SCL high to SDA low	0.6		μs
I8	$t_h(SDAL-SCLL)$	Hold time, SCL low from SDA low	0.6		μs
I9	$t_{su}(SDAH-SCLH)$	Setup time, SDA high to SCL high	0.6		μs
SLAVE STANDARD MODE					
		SCL/EN1 and SDA/EN2 rise and fall time, $C_L = 10$ to 400 pF		250	ns
		Data rate		100	Kbps
I3	$t_{su}(SDA-SCLH)$	Setup time, SDA valid to SCL high	250		ns
I4	$t_h(SCLL-SDA)$	Hold time, SDA valid from SCL low	0		μs
I7	$t_{su}(SCLH-SDAL)$	Setup time, SCL high to SDA low	4.7		μs
I8	$t_h(SDAL-SCLL)$	Hold time, SCL low from SDA low	4		μs
I9	$t_{su}(SDAH-SCLH)$	Setup time, SDA high to SCL high	4		μs
SWITCHING CHARACTERISTICS					
SLAVE HIGH-SPEED MODE					
I1	$t_w(SCLL)$	Pulse duration, SCL low	160		ns
I2	$t_w(SCLH)$	Pulse duration, SCL high	60		ns
SLAVE FAST MODE					
I1	$t_w(SCLL)$	Pulse duration, SCL low	1.3		μs
I2	$t_w(SCLH)$	Pulse duration, SCL high	0.6		μs
SLAVE STANDARD MODE					
I1	$t_w(SCLL)$	Pulse duration, SCL low	4.7		μs
I2	$t_w(SCLH)$	Pulse duration, SCL high	4		μs

(1) The input timing requirements are given by considering a rising or falling time of: 80 ns in high-speed mode (3.4 Mbps) 300 ns in fast-speed mode (400 kbps) 1000ns in Standard mode (100 kbps)

(2) SDA is SDA_SDI or EN2 signal, SCL is SCL_SCK or EN1 signal

5.9 Power Consumption

over operating free-air temperature range (unless otherwise noted)

All current consumption measurements are relative to the FULL chip, all VCC inputs set to VBAT voltage, COMP2 is off.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Device BACKUP state	CK32K clock and RTC digital running (RTC_PWDN = 0) VBAT = 2.4 V, VBACKUP = 0 V, VBAT = 0 V, VBACKUP = 3.2 V, V5IN = 0 V		13 7	18 10	μA
Device OFF state	CK32K clock running, V5IN = 0 VBAT = 3.8 V VBAT = 5 V VBAT = 3.8 V, RTC digital running (RTC_PWDN = 0) VBAT = 3.8 V, digital running (RTC_PWDN = 0), Backup Battery Charger on, VBACKUP = 3.2 V		13 17 16 26	18 23 22 32	μA
Device SLEEP state	VBAT = 3.8 V, CK32K clock running: 3 DCDCs on, 5 LDOs and VRRTC on, no load 3 DCDCs on, 3 LDOs and VRRTC on, no load VBAT = 3.8 V, CK32K clock and RTC digital running (RTC_PWDN = 0): 3 DCDCs on, 5 LDOs and VRRTC on, no load Additional current from V5IN = 5 V, if VDDCtrl is on, no load		292 279 295 320	 500	μA
Device ACTIVE state	VBAT = 3.8 V, CK32K clock running: 3 DCDCs on, 5 LDOs and VRRTC on, no load 3 DCDCs on, 3 LDOs and VRRTC on, no load 3 DCDCs on PWM mode (VDD1_PSKIP = VDD2_PSKIP = VIO_PSKIP = 0), 5 LDOs and VRRTC on, no load Additional current from V5IN = 5 V, if VDDCtrl is on, no load		1.2 1.05 23.6 0.32	 0.5	mA

5.10 Power References And Thresholds

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output reference voltage (VREF terminal)	Device in active or low-power mode	–1%	0.85	+1%	V
Main battery charged threshold VMBCH (programmable)	Measured on VCCS terminal Triggering monitored through NRESPRWON VMBCH_SEL=11000 to 11111 VMBCH_SEL=10111 ... VMBCH_SEL=01110 ... VMBCH_SEL=00101 VMBCH_SEL=00001 to 00100 VMBCH_SEL= 00000	–2%	3.5 3.45 ... 3 ... 2.55 2.5 bypassed	+2%	V
Main Battery Charged Hysteresis Threshold VMBDCH	Measured on VCCS terminal		VMBCH – 100 mV		V

Power References And Thresholds *(continued)*

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Main battery discharged threshold VMBDCH2 (programmable)	Measured on VCC7 terminal (MTL prg) Triggering monitored through INT1 VMBDCH2_SEL=11000 to 11111 VMBDCH2_SEL=10111 ... VMBDCH2_SEL=01110 ... VMBDCH2_SEL=00101 VMBDCH2_SEL=00001 to 00100 VMBDCH2_SEL= 00000	-2%	3.5 3.45 ... 3 ... 2.55 2.5 bypassed	+2%	V
Main Battery DisCharged Hysteresis Threshold VMBCH2	Measured on VCCS terminal		VMBDCH2 – 100 mV		V
Main battery low threshold VMBLO (MB comparator)	measured on VCC7 terminal (monitored on terminal NRESPWRON) MTL programming	2.5 2.4	2.6 2.5	2.7 2.6	V
Main battery high threshold VMBHI	VBACKUP = 0 V, Measured on terminal VCC7 (MB comparator) VBACKUP = 3.2 V, Measured on terminal VCC7 (trigger monitored through VCCS Idd, UPR comparator)	2.6 2.5	2.75 2.55	3 3	V
Main battery not present threshold VBNPR	Measured on terminal VCC7 (Triggering monitored on terminal VRTC)	1.9	2.1	2.2	V
Ground current (analog references + comparators + backup battery switch)	V _{CCx} = VBAT = 3.8 V except VCC6 = 3.6 V Device in OFF state Device in ACTIVE or SLEEP state COMP2 consumption when enabled Buffer consumption if COMP1 or COMP2 is active and buffer enabled		8 15 5 8		μA

5.11 Thermal Monitoring And Shutdown

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Hot-die temperature rising threshold	THERM_HDSEL[1:0] = 00 THERM_HDSEL[1:0] = 01 THERM_HDSEL[1:0] = 10 THERM_HDSEL[1:0] = 11	113	117 121 125 130	136	°C
Hot-die temperature hysteresis			10		°C
Thermal shutdown temperature rising threshold		136	148	160	°C
Thermal shutdown temperature hysteresis			10		°C
Ground current	Device in ACTIVE state, Temp = 27°C, VCC7 = 3.8 V		6		μA

5.12 32-kHz RTC Clock

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
CLK32KOUT rise and fall time	C _L = 35 pF			10	ns
Bypass Clock (OSC32KIN: input, OSC32KOUT floating)					
Input bypass clock frequency	OSCKIN input		32		kHz
Input bypass clock duty cycle	OSCKIN input	40%		60%	
Input bypass clock rise and fall time	10% – 90%, OSC32KIN input		10	20	ns
CLK32KOUT duty cycle	Logic output signal	40%		60%	
Bypass clock setup time	32KCLKOUT output			1	ms
Ground current	Bypass mode			1.5	μA
Crystal oscillator (connected from OSC32KIN to OSC32KOUT)					
Crystal frequency	@ specified load cap value		32.768		kHz
Crystal tolerance	@ 27°C	–20	0	20	ppm
Frequency temperature coefficient	Oscillator contribution (not including crystal variation)	–0.5		0.5	ppm/°C
Secondary temperature coefficient		–0.04	–0.035	–0.03	ppm/°C ²
Voltage coefficient		–2		2	ppm/V
Max crystal series resistor	@ Fundamental frequency			90	kΩ
Crystal load capacitor	According to crystal data sheet	6		12.5	pF
Load crystal oscillator C _{oscin} , C _{oscout}	parallel mode including parasitic PCB capacitor	12		25	pF
Quality factor		8000		80000	
Oscillator startup time	On power on			2	s
Ground current			1.5		μA
RC oscillator (OSC32KIN: grounded, OSC32KOUT floating)					
Output frequency	CK32KOUT output		32		kHz
Output frequency accuracy	@ 25°C	–15%	0%	+15%	
Cycle jitter (RMS)	Oscillator contribution			+10%	
Output duty cycle		+40%	+50%	+60%	
Settling time				150	μs
Ground current	Active @ fundamental frequency		4		μA

5.13 Backup Battery Charger

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Backup battery charging current	VBACKUP = 0 to 2.8 V, BBCHEN = 1	350	650	900	μA
End-of-charge backup battery voltage	VCC5 = 3.6 V, I _{VBACKUP} = –10 μA, BBSEL = 10	–3%	3.15	+3%	V
	VCC5 = 3.6 V, I _{VBACKUP} = –10 μA, BBSEL = 00	–3%	3	+3%	
	VCC5 = 3.6 V, I _{VBACKUP} = –10 μA, BBSEL = 01	–3%	2.52	+3%	
	VCC5 = 3.6 V, I _{VBACKUP} = –10 μA, BBSEL = 11	VBAT – 0.3 V		VBAT	
	VCC5 = 3.0 V, I _{VBACKUP} = –10 μA, BBSEL = 10	VBAT – 0.2 V		VBAT	
Ground current	On mode		10		μA

5.14 VRTC LDO

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input voltage V _{IN} (VCC7)	On mode	2.5		5.5	V
	Backup mode	1.9		3	
DC output voltage V _{OUT}	On mode, 3.0 V < V _{IN} < 5.5 V	1.78	1.83	1.88	V
	Backup mode, 2.3 V ≤ V _{IN} ≤ 2.6 V	1.72	1.78	1.84	
Rated output current I _{OUTmax}	On mode	20			mA
	Backup mode	0.1			
DC load regulation	On mode, I _{OUT} = I _{OUTmax} to 0			100	mV
	Backup mode, I _{OUT} = I _{OUTmax} to 0			100	
DC line regulation	On mode, V _{IN} = 3.0 V to V _{INmax} @ I _{OUT} = I _{OUTmax}			2.5	mV
	Backup mode, V _{IN} = 2.3 V to 5.5 V @ I _{OUT} = I _{OUTmax}			100	
Transient load regulation	On mode, V _{IN} = V _{INmin} + 0.2 V to V _{INmax}			50 ⁽¹⁾	mV
	I _{OUT} = I _{OUTmax} /2 to I _{OUTmax} in 5 μs and I _{OUT} = I _{OUTmax} to I _{OUTmax} /2 in 5 μs				
Transient line regulation	On mode, V _{IN} = V _{INmin} + 0.5 V to V _{INmin} in 30 μs			25 ⁽¹⁾	mV
	And V _{IN} = V _{INmin} to V _{INmin} + 0.5 V in 30 μs, I _{OUT} = I _{OUTmax} /2				
Turn-on time	I _{OUT} = 0, V _{IN} rising from 0 up to 3.6 V, @ V _{OUT} = 0.1 V up to V _{OUTmin}		2.2		ms
Ripple rejection	V _{IN} = V _{INDC} + 100 mV _{pp} tone, V _{INDC+} = V _{INmin} + 0.1 V to V _{INmax} @ I _{OUT} = I _{OUTmax} /2				dB
	f = 217 Hz		55		
	f = 50 kHz		35		
Ground current	Device in ACTIVE state		23		μA
	Device in BACKUP or OFF state		3		

(1) These parameters are not tested. They are used for design specification only.

5.15 VIO SMPS

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input voltage (VCCIO and VCC7) V_{IN}	$V_{OUT} = 1.5\text{ V}, 1.8\text{ V}, \text{ or } 2.5\text{ V}$ $V_{OUT} = 3.3\text{ V}$	2.7 V_{OUT}		5.5 5.5	V
DC output voltage (V_{OUT})	PWM mode ($VIO_PSKIP = 0$) or pulse skip mode $I_{OUT} = 0$ to I_{MAX} $VSEL = 00$ $VSEL = 01$ $VSEL = 10$ $VSEL = 11$ Power down	–3% –3% –3% –3%	1.5 1.8 2.5 3.3 0	+3% +3% +3% +3%	V
Rated output current I_{OUTmax}	VIO output voltage = 1.5 V with $ILMAX[1:0] = 11$ VIO output voltage = 1.8 V with $ILMAX[1:0] = 11$ VIO output voltage = 2.2 V with $ILMAX[1:0] = 11$ VIO output voltage = 3.3 V with $ILMAX[1:0] = 11$	1300 1200 1100 1100			mA
P-channel MOSFET On-resistance $R_{DS(ON), PMOS}$	$V_{IN} = V_{INmin}$ $V_{IN} = 3.8\text{ V}$		300 250	400	mΩ
P-channel leakage current $I_{LK, PMOS}$	$V_{IN} = V_{INmax}, SWIO = 0\text{ V}$			2	μA
N-channel MOSFET On-resistance $R_{DS(ON), NMOS}$	$V_{IN} = V_{MIN}$ $V_{IN} = 3.8\text{ V}$		300 250	400	mΩ
N-channel leakage current $I_{LK, NMOS}$	$V_{IN} = V_{INmax}, SWIO = V_{INmax}$			2	μA
PMOS current limit (high-side)	Source current load: $V_{IN} = V_{INmin}$ to $V_{INmax}, ILMAX[1:0] = 00$ $V_{IN} = V_{INmin}$ to $V_{INmax}, ILMAX[1:0] = 01$ $V_{IN} = V_{INmin}$ to $V_{INmax}, ILMAX[1:0] = 10$	650 1200 1700			mA
NMOS current limit (low-side)	Source current load: $V_{IN} = V_{INmin}$ to $V_{INmax}, ILMAX[1:0] = 00$ $V_{IN} = V_{INmin}$ to $V_{INmax}, ILMAX[1:0] = 01$ $V_{IN} = V_{INmin}$ to $V_{INmax}, ILMAX[1:0] = 10$ Sink current load: $V_{IN} = V_{INmin}$ to $V_{INmax}, ILMAX[1:0] = 00$ $V_{IN} = V_{INmin}$ to $V_{INmax}, ILMAX[1:0] = 01$ $V_{IN} = V_{INmin}$ to $V_{INmax}, ILMAX[1:0] = 10$	650 1200 1700 800 1200 1700			mA
DC load regulation	On mode, $I_{OUT} = 0$ to I_{OUTmax}			20	mV
DC line regulation	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = I_{OUTmax}$			20	mV
Transient load regulation	$V_{IN} = 3.8\text{ V}, V_{OUT} = 1.8\text{ V}$ $I_{OUT} = 0$ to 500 mA, Max slew = 100 mA/μs $I_{OUT} = 700$ to 1200 mA, Max slew = 100 mA/μs			50	mV
t on, off to on	$I_{OUT} = 200\text{ mA}$		350		μs
Overshoot	SMPS turned on		3%		
Power-save mode Ripple voltage	PFM (Pulse skip mode) mode, $I_{OUT} = 1\text{ mA}$		$0.025 \times V_{OUT}$		V _{PP}
Switching frequency		2.7	3	3.3	MHz
Duty cycle				100%	
Minimum On Time $T_{ON(MIN)}$ P-channel MOSFET			35		ns
Discharge resistor for power-down sequence R_{DIS}			30	50	Ω
VFBIO internal resistance		0.5	1		MΩ

VIO SMPS (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Ground current (I_Q)	Off			1	
	PWM mode, $I_{OUT} = 0$ mA, $V_{IN} = 3.8$ V, $VIO_PSKIP = 0$		7500		μ A
	PFM (Pulse Skipping) mode, no switching, 3-MHz clock on		250		
	Low-power (pulse skipping) mode, no switching ST[1:0]=11		63		
Conversion efficiency	PWM mode, $DCR_L < 50$ m Ω , $V_{OUT} = 1.8$ V, $V_{IN} = 3.6$ V:				
	$I_{OUT} = 10$ mA		40%		
	$I_{OUT} = 100$ mA		83%		
	$I_{OUT} = 400$ mA		85%		
	$I_{OUT} = 800$ mA		80%		
	$I_{OUT} = 1200$ mA		75%		
	PFM mode, $DCR_L < 50$ m Ω , $V_{OUT} = 1.8$ V, $V_{IN} = 3.6$ V:				
	$I_{OUT} = 1$ mA		68%		
	$I_{OUT} = 10$ mA		80%		
	$I_{OUT} = 400$ mA		85%		

5.16 VDD1 SMPS

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input voltage (VCC1 and VCC7) V_{IN}	$V_{OUT} \leq 2.7\text{ V}$ $V_{OUT} > 2.7\text{ V}$	2.7 V_{OUT}		5.5 5.5	V
DC output voltage (V_{OUT})	$V_{GAIN_SEL} = 00$, $I_{OUT} = 0$ to I_{OUTmax} : max programmable voltage, $SEL[6:0] = 1001011$	–3%	1.5	+3%	V
	min programmable voltage, $SEL[6:0] = 0000011$		1.2		
	$SEL[6:0] = 0000000$: power down		0.6		
	$V_{GAIN_SEL} = 10$, $SEL = 0101011 = 43$, $I_{OUT} = 0$ to I_{OUTmax}	–3%	2.2	+3%	V
	$V_{GAIN_SEL} = 11$, $SEL = 0101011 = 43$, $I_{OUT} = 0$ to I_{OUTmax}	–3%	3.3	+3%	V
DC output maximum voltage maximum value			3.3		V
DC output voltage programmable step ($V_{OUTSTEP}$)	$V_{GAIN_SEL} = 00$, 72 steps		12.5		mV
Rated output current I_{OUTmax}	VDD1 output voltage = {0.6 to 2.2 V}	1500			mA
	VDD1 output voltage = 3.2 V	1200			
	VDD1 output voltage = {1.2 V, 1.35 V, 1.5 V}	2000			
	$V_{INmin} = 3\text{ V}$				
P-channel MOSFET On-resistance $R_{DS(ON), PMOS}$	$V_{IN} = V_{INmin}$ $V_{IN} = 3.8\text{ V}$		300 250	400	m Ω
P-channel leakage current I_{LK_PMOS}	$V_{IN} = V_{INmax}$, $SW1 = 0\text{ V}$			2	μA
N-channel MOSFET On-resistance $R_{DS(ON), NMOS}$	$V_{IN} = V_{MIN}$ $V_{IN} = 3.8\text{ V}$		300 250	400	m Ω
N-channel leakage current I_{LK_NMOS}	$V_{IN} = V_{INmax}$, $SW1 = V_{INmax}$			2	μA
PMOS current limit (high-side)	$V_{IN} = V_{INmin}$ to V_{INmax}	1800			mA
NMOS current limit (low-side)	$V_{IN} = V_{INmin}$ to V_{INmax} , source current load	1800			mA
	$V_{IN} = V_{INmin}$ to V_{INmax} , sink current load	1800			
DC load regulation	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = 1500\text{ mA}$ VDD1 output voltage = {0.6 to 1.5 V}			20	mV
	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = 2000\text{ mA}$ VDD1 output voltage = {1.2V, 1.35 V, 1.5 V} $V_{INmin} = 3\text{ V}$			30	
	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = 1500\text{ mA}$ VDD1 output voltage = 2.2 V			30	
	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = 1200\text{ mA}$ VDD1 output voltage = 3.2 V			30	

VDD1 SMPS (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
DC line regulation	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = 1500$ mA VDD1 output voltage = {0.6 to 1.5 V} On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = 2000$ mA VDD1 output voltage = {1.2V, 1.35 V, 1.5 V} $V_{INmin} = 3$ V On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = 1500$ mA VDD1 output voltage = 2.2 V On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = 1200$ mA VDD1 output voltage = 3.2 V			20 30 30 30	mV
Transient load regulation	$V_{IN} = 3.8$ V, $V_{OUT} = 1.2$ V $I_{OUT} = 0$ to 500 mA, Max slew = 100 mA/μs $I_{OUT} = 700$ mA to 1.2A, Max slew = 100 mA/μs			50	mV
t on, off to on	$I_{OUT} = 200$ mA		350		μs
Output voltage transition rate	From $V_{OUT} = 0.6$ V to 1.5 V and $V_{OUT} = 1.5$ V to 0.6 V $I_{OUT} = 500$ mA TSTEP[2:0] = 001 TSTEP[2:0] = 011 (default) TSTEP[2:0] = 111		12.5 7.5 2.5		mV/μs
Overshoot	SMPS turned on		3%		
Power-save mode ripple voltage	PFM (pulse skip mode), $I_{OUT} = 1$ mA		$0.025 \times V_{OUT}$		V _{PP}
Switching frequency		2.7	3	3.3	MHz
Duty cycle				100%	
Minimum on time t _{ON(MIN)} P-channel MOSFET			35		ns
Discharge resistor for power-down sequence R _{DIS}			30	50	Ω
VFB1 internal resistance		0.5	1		MΩ
Ground current (I _G)	Off PWM mode, $I_{OUT} = 0$ mA, $V_{IN} = 3.8$ V, VDD1_PSKIP = 0 Pulse skipping mode, no switching Low-power (pulse skipping) mode, no switching ST[1:0] = 11		7500 78 63	1	μA
Conversion efficiency	PWM mode, DCR _L < 0.1 Ω, $V_{OUT} = 1.2$ V, $V_{IN} = 3.6$ V: $I_{OUT} = 10$ mA $I_{OUT} = 100$ mA $I_{OUT} = 400$ mA $I_{OUT} = 800$ mA $I_{OUT} = 1500$ mA PFM mode, DCR _L < 0.1Ω, $V_{OUT} = 1.2$ V, $V_{IN} = 3.6$ V: $I_{OUT} = 1$ mA $I_{OUT} = 10$ mA $I_{OUT} = 400$ mA		35% 78% 80% 74% 62% 59% 70% 80%		

5.17 VDD2 SMPS

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input voltage (VCC2 and VCC7) V_{IN}	$V_{OUT} \leq 2.7\text{ V}$ $V_{OUT} > 2.7\text{ V}$	2.7 V_{OUT}		5.5 5.5	V
DC output voltage (V_{OUT})	VGAIN_SEL = 00, $I_{OUT} = 0$ to I_{OUTmax} : max programmable voltage, SEL[6:0] = 1001011 min programmable voltage, SEL[6:0] = 0000011 SEL[6:0] = 000000: power down VGAIN_SEL = 10, SEL = 0101011 = 43 VGAIN_SEL = 11, SEL=0101011=43	 –3% –3% –3%	1.5 1.2 0.6 0 2.2 3.3	 +3% +3% +3%	V
DC output maximum voltage maximum value			3.3		V
DC output voltage programmable step ($V_{OUTSTEP}$)	VGAIN_SEL = 00, 72 steps		12.5		mV
Rated output current I_{OUTmax}	VDD2 output voltage = {0.6 to 1.5 V} VDD2 output voltage = 2.2 V VDD2 output voltage = 3.2 V	1500 1200 1200			mA
P-channel MOSFET On-resistance $R_{DS(ON)}_{PMOS}$	$V_{IN} = V_{INmin}$ $V_{IN} = 3.8\text{ V}$		300 250	400	$m\Omega$
P-channel leakage current I_{LK_PMOS}	$V_{IN} = V_{INmax}$, SW2 = 0 V			2	μA
N-channel MOSFET On-resistance $R_{DS(ON)}_{NMOS}$	$V_{IN} = V_{MIN}$ $V_{IN} = 3.8\text{ V}$		300 250	400	$m\Omega$
N-channel leakage current I_{LK_NMOS}	$V_{IN} = V_{INmax}$, SW2 = V_{INmax}			2	μA
PMOS current limit (high-side)	$V_{IN} = V_{INmin}$ to V_{INmax} , source current load	1800			mA
NMOS current limit (low-side)	$V_{IN} = V_{INmin}$ to V_{INmax} , source current load $V_{IN} = V_{INmin}$ to V_{INmax} , sink current load	1800 1800			mA
DC load regulation	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = 1500\text{ mA}$ VDD2 output voltage = {0.6 to 1.5V} On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = 1200\text{ mA}$ VDD2 output voltage = {2.2 to 3.3 V}			20 30	mV
DC line regulation	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = 1500\text{ mA}$ VDD2 output voltage = {0.6 to 1.5V} On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = 1200\text{ mA}$ VDD2 output voltage = {2.2 to 3.3 V}			20 30	mV
Transient load regulation	$V_{IN} = 3.8\text{ V}$, $V_{OUT} = 1.2\text{ V}$ $I_{OUT} = 0$ to 500 mA, Max slew = 100 mA/ μs $I_{OUT} = 700\text{ mA}$ to 1.2 A, Max slew = 100 mA/ μs			50	mV
t on, Off to on	$I_{OUT} = 200\text{ mA}$		350		μs
Output voltage transition rate	From $V_{OUT} = 0.6\text{ V}$ to 1.5 V and $V_{OUT} = 1.5\text{ V}$ to 0.6 V $I_{OUT} = 500\text{ mA}$ TSTEP[2:0] = 001 TSTEP[2:0] = 011 (default) TSTEP[2:0] = 111		12.5 7.5 2.5		mV/ μs
Overshoot	SMPS turned on		3%		
Power-save mode ripple voltage	PFM (pulse skip mode), $I_{OUT} = 1\text{ mA}$		$0.025 \times V_{OUT}$		V_{PP}
Switching frequency		2.7	3	3.3	MHz

VDD2 SMPS (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Duty cycle				100%	
Minimum On time P-Channel MOSFET			35		ns
Discharge resistor for power-down sequence R_{DIS}			30	50	Ω
VFB2 internal resistance		0.5	1		M Ω
Ground current (I_Q)	Off PWM mode, $I_{OUT} = 0$ mA, $V_{IN} = 3.8$ V, $VDD2_PSKIP = 0$ PFM (pulse skipping) mode, no switching Low-power (pulse skipping) mode, no switching $ST[1:0] = 11$		7500 78 63	1	μ A
Conversion efficiency	PWM mode, $DCR_L < 50$ m Ω , $V_{OUT} = 1.2$ V, $V_{IN} = 3.6$ V: $I_{OUT} = 10$ mA $I_{OUT} = 100$ mA $I_{OUT} = 400$ mA $I_{OUT} = 800$ mA $I_{OUT} = 1200$ mA $I_{OUT} = 1500$ mA PFM mode, $DCR_L < 50$ m Ω , $V_{OUT} = 1.2$ V, $V_{IN} = 3.6$ V: $I_{OUT} = 1$ mA $I_{OUT} = 10$ mA $I_{OUT} = 400$ mA		35% 78% 80% 74% 66% 62% 59% 70% 80%		
	PWM mode, $DCR_L < 50$ m Ω , $V_{OUT} = 3.3$ V, $V_{IN} = 5$ V: $I_{OUT} = 10$ mA $I_{OUT} = 100$ mA $I_{OUT} = 400$ mA $I_{OUT} = 800$ mA $I_{OUT} = 1200$ mA PFM mode, $DCR_L < 50$ m Ω , $V_{OUT} = 3.3$ V, $V_{IN} = 5$ V: $I_{OUT} = 1$ mA $I_{OUT} = 10$ mA $I_{OUT} = 400$ mA		39% 85% 91% 90% 86% 80% 82% 92%		

5.18 VDDCtrl SMPS

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input Voltage for external FETs V_{IN}			3		25	V
Input voltage V_{5IN}			4.5		5.5	V
DC output voltage (V_{OUT})		$I_{OUT} = 0$ to I_{OUTmax} : max programmable voltage: SEL[6:0]=1000011 to 1111111 ... SEL[6:0]=0110001 ... min programmable voltage: SEL[6:0]=0000001 to 0000011 SEL[6:0]=000000: power down		1.4 1.2 0.6 0		V
DC Output Voltage programmable step ($V_{OUTSTEP}$)				12.5		mV
t on, off to on		From EN high to $V_{out} = 95\%$		900		μs
Output voltage transition rate		From $V_{OUT} = 0.6$ V to 1.4 V and $V_{OUT} = 1.4$ V to 0.6 V $I_{OUT} = 500$ mA		100 ⁽¹⁾		mV/20 μs
Switching frequency		$I_{OUT} = 100$ mA $I_{OUT} = 1$ A $I_{OUT} = 5$ A		10 100 340		kHz
Ground current (I_Q)	Off No load			400	1 500	μA
SUPPLY CURRENT						
$I_{(V5IN)}$	V_{5IN} supply current	V_{5IN} current, $T_A = 25^\circ C$, No load $V_{(EN)} = 5$ V, $V_{(VOUT)} = 0.63$ V		320	500	μA
$I_{SD(V5IN)}$	V_{5IN} shutdown current	V_{5IN} current, $T_A = 25^\circ C$, No load, $V_{(EN)} = 0$ V			1	μA
INTERNAL REFERENCE VOLTAGE						
Reference			0.5974	0.603	0.6086	V
Mismatch of resistive divider		specified by design, not production tested.	$(-0.0063 \times V_{OUT} + 0.0035)$	V_{OUT}	$0.001 \times V_{OUT} - 0.0003$	%
$I_{(VOUT)}$		specified by design, not production tested. $I_{(VOUT)} = 10^{-4} \times V_{OUT} - 6 \times 10^{-5}$				μA
		V_{OUT}				
		0.6 V		1.25		
		...		...		
		1 V		40		
		...		...		
		1.3875 V		78.75		
OUTPUT DISCHARGE						
I_{Dischg}	I Output discharge current from SW pin	$V_{(EN)} = 0$ V, $V_{(SW)} = 0.5$ V	5	13		mA
OUTPUT DRIVERS						

(1) 100 mV/20 μs reached with 50 mV/10 μs steps

VDDCtrl SMPS (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
R _(DRVH)	DRVH resistance	Source, I _(DRVH) = −50 mA		1.5	3	Ω
		Sink, I _(DRVH) = 50 mA		0.7	1.8	
R(DRVL)	DRVL resistance	Source, I _(DRVL) = −50 mA		1	2.2	
		Sink, I _(DRVL) = 50 mA		0.5	1.2	
t _D	Dead time	DRVH-off to DRVL-on	7	17	30	ns
		DRVH-off to DRVL-on	10	22	35	
BOOT STRAP SWITCH						
V _(FBST)	Forward voltage	V _(V5IN-VBST) , I _F = 10 mA, T _A = 25°C		0.1	0.2	V
I _{lkg}	VBST leakage current	V _(VBST) = 34.5 V, V _(SW) = 28 V, T _A = 25°C		0.01	1.5	μA
DUTY AND FREQUENCY CONTROL						
t _{OFF(min)}	Minimum off-time	T _A = 25°C	150	260	400	ns
t _{ON(min)}	Minimum on-time	V _{IN} = 28 V, V _{OUT} = 0.6 V, T _A = 25°C specified by design, not production tested.		86		
f _{SW}	Switching frequency	T _A = 25°C	312	340	368	kHz
SOFTSTART						
t _{SS}	Internal SS time	From V _(EN) = high to V _{OUT} = 95%		0.9		ms
PROTECTION: CURRENT SENSE						
V _(TRIP)	TRIP source current	V _(TRIP) = 1 V, T _A = 25°C	9	10	11	μA
	TRIP current temperature coefficient	On the basis of 25°C		4700		ppm/°C
V _(TRIP)	Current limit threshold setting range	V _(TRIP-GND) Voltage	0.2		3	V
V _{OCL}	Current limit threshold	V _(TRIP) = 3 V	355	375	395	mV
		V _(TRIP) = 1.6 V	185	200	215	
		V _(TRIP) = 0.2 V	17	25	33	
V _{OCLN}	Negative current limit threshold	V _(TRIP) = 3 V	−395	−375	−355	mV
		V _(TRIP) = 1.6 V	−215	−200	−185	
		V _(TRIP) = 0.2 V	−33	−25	−17	
	Auto zero cross adjustable range	Positive	3	15		mV
		Negative		−15	−3	
UVLO						
V5IN UVLO threshold		Wake up	4.2	4.38	4.5	V
		Shutdown	3.7	3.93	4.1	
THERMAL SHUTDOWN						
T _{SDN}	Thermal shutdown threshold	Shutdown temperature Specified by design. Not production tested.		145		°C
		Hysteresis Specified by design. Not production tested.		10		

5.19 LDO1 And LDO2

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input voltage (VCC6) V _{IN}	V _{OUT} (LDO1) = 1.05 V @ 320 mA and V _{OUT} (LDO2) = 1.05 V @ 160 mA	1.4		3.6	V
	V _{OUT} (LDO1) = 1.2 V/1.5 V @ 100 mA and V _{OUT} (LDO2) = 1.2 V/1.1 V/1.0 V	1.7		3.6	
	V _{OUT} (LDO1) = 1.5 V and V _{OUT} (LDO1, LDO2) = 1.8 V @ 200 mA	2.1		3.6	
	V _{OUT} (LDO1) = 1.8 V and V _{OUT} (LDO2) = 1.8 V	2.7		3.6	
	V _{OUT} (LDO1) = 2.7 V	3.2		3.6	
	V _{OUT} (LDO1) = V _{OUT} (LDO2) = 3.3 V	3.5		3.6	
LDO1					
DC output voltage V _{OUT}	ON and Low-power mode, V _{IN} = V _{INmin} to V _{INmax} (V _{INmax} 3.6 V)	–3%	1 1.05 ... 3.25 3.3	+3%	
Rated output current I _{OUTmax}	On mode Low-power mode	320 1			mA
Load current limitation (short-circuit protection)	On mode, V _{OUT} = V _{OUTmin} – 100 mV	450	600	1000	mA
Dropout voltage V _{DO}	ON mode, V _{DO} = V _{IN} – V _{OUT} , V _{IN} = 1.4 V, I _{OUT} = I _{OUTmax}			350	mV
DC load regulation	On mode, I _{OUT} = I _{OUTmax} to 0			12	mV
DC line regulation	On mode, V _{IN} = V _{INmin} to V _{INmax} @ I _{OUT} = I _{OUTmax}			4	mV
Transient load regulation	ON mode, V _{IN} = 1.5 V, V _{OUT} = 1.05 V I _{OUT} = 0.1 × I _{OUTmax} to 0.9 × I _{OUTmax} in 5 μs and I _{OUT} = 0.9 × I _{OUTmax} to 0.1 × I _{OUTmax} in 5 μs		20	40	mV
Transient line regulation	On mode, V _{IN} = 2.7 + 0.5 V to 2.7 in 30 μs, and V _{IN} = 2.7 to 2.7 + 0.5 V in 30 μs, I _{OUT} = I _{OUTmax}		5	10	mV
Turn-on time	V _{OUT} = {1 to 1.8 V}, @ I _{OUT} = 0 measured from V _{OUT} = 0.1 V up to 97% of V _{OUT}	30		150	μs
	V _{OUT} = {1.9 to 3.3 V}, @ I _{OUT} = 0 measured from V _{OUT} = 0.1 V up to 97% of V _{OUT}	50		230	
Turn-on inrush current			300	600	mA
Ripple rejection	V _{IN} = V _{INDC} + 100 mV _{pp} tone, V _{INDC} = 1.8 V, I _{OUT} = I _{OUTmax} /2 f = 217 Hz f = 20 kHz		70 40		dB
LDO1 internal resistance	LDO off		600		
Ground current	On mode, I _{OUT} = 0		63	75	μA
	On mode, I _{OUT} = I _{OUTmax}			2000	
	Low-power mode		22	20	
	Off mode (max 85°C)			2.7	
LDO2					
DC output voltage V _{OUT}	On and low-power mode, V _{IN} = V _{INmin} to V _{INmax}		1		

LDO1 And LDO2 (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	($V_{INmax} = 3.6\text{ V}$)	–3%	1.05 ... 3.25 3.3	+3%	
Rated output current I_{OUTmax}	On mode Low-power mode	320 1			mA
Load current limitation (short-circuit protection)	On mode, $V_{OUT} = V_{OUTmin} - 100\text{ mV}$	450	600	1000	mA
Dropout voltage V_{DO}	ON mode, $V_{DO} = V_{IN} - V_{OUT}$, $V_{IN} = 1.4\text{ V}$, $I_{OUT} = I_{OUTmax}$			350	mV
DC load regulation	On mode, $I_{OUT} = I_{OUTmax}$ to 0			12	mV
DC line regulation	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = I_{OUTmax}$			4	mV
Transient load regulation	ON mode, $V_{IN} = 1.5\text{ V}$, $V_{OUT} = 1.05\text{ V}$ $I_{OUT} = 0.1 \times I_{OUTmax}$ to $0.9 \times I_{OUTmax}$ in $5\text{ }\mu\text{s}$ and $I_{OUT} = 0.9 \times I_{OUTmax}$ to $0.1 \times I_{OUTmax}$ in $5\text{ }\mu\text{s}$		20	40	mV
Transient line regulation	On mode, $V_{IN} = 2.7 + 0.5\text{ V}$ to 2.7 in $30\text{ }\mu\text{s}$, And $V_{IN} = 2.7$ to $2.7 + 0.5\text{ V}$ in $30\text{ }\mu\text{s}$, $I_{OUT} = I_{OUTmax}$		5	10	mV
Turn-on time	$V_{OUT} = \{1\text{ to }1.8\text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1\text{ V}$ up to 97% of V_{OUT} $V_{OUT} = \{1.9\text{ to }3.3\text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1\text{ V}$ up to 97% of V_{OUT}	30 50		150 230	μs
Turn-on inrush current			300	600	mA
Ripple rejection	$V_{IN} = V_{INDC} + 100\text{ mV}_{pp}$ tone, $V_{INDC} = 1.8\text{ V}$, $I_{OUT} = I_{OUTmax}/2$ $f = 217\text{ Hz}$ $f = 20\text{ kHz}$		70 40		dB
LDO2 internal resistance	LDO off		600		Ω
Ground current	On mode, $I_{OUT} = 0$ On mode, $I_{OUT} = I_{OUTmax}$ Low-power mode Off mode (max 85°C)		63 22	75 2000 20 2.7	μA

5.20 LDO3 And LDO4

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input voltage (VCC5) V_{IN}	V_{OUT} (LDO3) = 1.8 V and V_{OUT} (LDO4) = 1.8 V/ 1.1 V/ 1.0 V V_{OUT} (LDO3) = 2.6 V and V_{OUT} (LDO4) = 2.5 V V_{OUT} (LDO3) = 2.8 V	2.7 3.0 3.2		5.5 5.5 5.5	V
LDO3					
DC output voltage V_{OUT}	On and low-power mode, $V_{OUT} = 1.0 - 3.3$ V, $V_{IN} = V_{INmin}$ to V_{INmax}	-3%	1 1.1 ... 3.2 3.3	+3%	V
Rated output current I_{OUTmax}	On mode Low-power mode	200 1			mA
Load current limitation (short-circuit protection)	On mode, $V_{OUT} = V_{OUTmin} - 100$ mV	400	550	650	On mode, $V_{OUTtyp} = 2.8$ V, $I_{DO} = V_{IN} - V_{OUT}$, mA
Dropout Voltage V_{DO}	On mode, $V_{OUTtyp} = 3.3$ V, $V_{DO} = V_{IN} - V_{OUT}$, $V_{IN} = 3.6$ V, $I_{OUT} = I_{OUTmax}$		150	250	mV
DC load regulation	On mode, $I_{OUT} = I_{OUTmax}$ to 0			10	mV
DC line regulation	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = I_{OUTmax}$			4	mV
Transient load regulation	On mode, $V_{IN} = 2.7$ V, $V_{OUTtyp} = 1.8$ V $I_{OUT} = 0.1 \times I_{OUTmax}$ to $0.9 \times I_{OUTmax}$ in 5 μ s and $I_{OUT} = 0.9 \times I_{OUTmax}$ to $0.1 \times I_{OUTmax}$ in 5 μ s		15	22	mV
Transient line regulation	On mode, $V_{OUTtyp} = 1.8$ V, $I_{OUT} = I_{OUTmax}$, $V_{IN} = V_{INmin} + 0.5$ V to V_{INmin} in 30 μ s and $V_{IN} = V_{INmin}$ to $V_{INmin} + 0.5$ V in 30 μ s, $I_{OUT} = I_{OUTmax}$		0.5	1	mV
Turn-on time	$V_{OUT} = \{1 \text{ to } 1.8 \text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1$ V up to 97% of V_{OUT} $V_{OUT} = \{1.9 \text{ to } 3.3 \text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1$ V up to 97% of V_{OUT}	30 50		150 200	μ s
Turn-on inrush current			200	450	mA
Ripple Rejection	$V_{IN} = V_{INDC} + 100$ mV _{pp} tone, $V_{INDC+} = 3.8$ V, $I_{OUT} = I_{OUTmax}/2$ $f = 217$ Hz $f = 50$ kHz		70 40		dB
LDO3 internal resistance	LDO off		500		k Ω
Ground current	On mode, $I_{OUT} = 0$ On mode, $I_{OUT} = I_{OUTmax}$ Low-power mode Off mode		65 14	76 2000 22 1	μ A
LDO4					
DC output voltage V_{OUT}	On and low-power mode, $V_{IN} = V_{INmin}$ to V_{INmax}	-3%	1 1.05 ... 3.25 3.3	+3%	V

LDO3 And LDO4 (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Rated output current I_{OUTmax}	On mode	50			mA
	Low-power mode	1			
Load current limitation (short-circuit protection)	On mode, $V_{OUT} = V_{OUTmin} - 100\text{ mV}$	200	400	500	mA
Dropout voltage V_{DO}	On mode, $V_{OUTtyp} = 2.5\text{ V}$, $V_{DO} = V_{IN} - V_{OUT}$ $V_{IN} = 3.6\text{ V}$, $I_{OUT} = I_{OUTmax}$		100	160	mV
DC load regulation	On mode, $I_{OUT} = I_{OUTmax}$ to 0			5	mV
DC line regulation	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = I_{OUTmax}$			4	mV
Transient load regulation	On mode, $V_{IN} = 2.7\text{ V}$, $V_{OUTtyp} = 1.8\text{ V}$ $I_{OUT} = 0.1 \times I_{OUTmax}$ to $0.9 \times I_{OUTmax}$ in $5\text{ }\mu\text{s}$ and $I_{OUT} = 0.9 \times I_{OUTmax}$ to $0.1 \times I_{OUTmax}$ in $5\text{ }\mu\text{s}$		6	10	mV
Transient line regulation	On mode, $V_{IN} = V_{INmin} + 0.5\text{ V}$ to V_{INmin} in $30\text{ }\mu\text{s}$ and $V_{IN} = V_{INmin}$ to $V_{INmin} + 0.5\text{ V}$ in $30\text{ }\mu\text{s}$, $I_{OUT} = I_{OUTmax}/2$		0.2	1	mV
Turn-on time	$V_{OUT} = \{1\text{ to }1.8\text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1\text{ V}$ up to 97% of V_{OUT}	30		150	μs
	$V_{OUT} = \{1.9\text{ to }3.3\text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1\text{ V}$ up to 97% of V_{OUT}	50		200	
Ripple rejection	$V_{IN} = V_{INDC} + 100\text{ mV}_{pp}$ tone, $V_{INDC} = 3.8\text{ V}$, $I_{OUT} = I_{OUTmax}/2$ $f = 217\text{ Hz}$ $f = 50\text{ kHz}$		70 40		dB
LDO4 internal resistance	LDO Off		500		k Ω
Ground current	On mode, $I_{OUT} = 0$		55	65	μA
	On mode, $I_{OUT} = I_{OUTmax}$			900	
	Low-power mode		14	17	
	Off mode			1	

5.21 LDO5

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input voltage (VCC4) V_{IN}	V_{OUT} (LDO5) = 1.8 V V_{OUT} (LDO5) = 2.5 V V_{OUT} (LDO5) = 2.8 V @ $I_{load} = 200$ mA V_{OUT} (VAUX2) = 2.8 V @ 300 mA	2.7 3.2 3.2 3.2		5.5 5.5 5.5 5.5	V
LDO5					
DC output voltage V_{OUT}	On and low-power mode, $V_{OUT} = 1.0 - 3.3$ V, $V_{IN} = V_{INmin}$ to V_{INmax}	-3%	1 1.1 ... 3.2 3.3	+3%	V
Rated output current I_{OUTmax}	On mode Low-power mode	300 1			mA
Load current limitation (short-circuit protection)	On mode, $V_{OUT} = V_{OUTmin} - 100$ mV	450	550	650	mA
Dropout voltage V_{DO}	On mode, $V_{DO} = V_{IN} - V_{OUT}$, $V_{IN} = 2.7$ V, $I_{OUT} = I_{OUTmax}$ $V_{IN} = 2.7$ V, $I_{OUT} = 250$ mA $V_{IN} = 2.7$ V, $I_{OUT} = 200$ mA			500 400 300	mV
DC load regulation	On mode, $I_{OUT} = I_{OUTmax}$ to 0			15	mV
DC line regulation	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ I_{OUTmax}			4	mV
Transient load regulation	On mode, $V_{IN} = 3.2$ V, $V_{OUTtyp} = 2.8$ V $I_{OUT} = 0.1 \times I_{OUTmax}$ to $0.9 \times I_{OUTmax}$ in 5 μ s and $I_{OUT} = 0.9 \times I_{OUTmax}$ to $0.1 \times I_{OUTmax}$ in 5 μ s		16	30	mV
Transient line regulation	On mode, $V_{IN} = V_{INmin} + 0.5$ V to V_{INmin} in 30 μ s and $V_{IN} = V_{INmin}$ to $V_{INmin} + 0.5$ V in 30 μ s, $I_{OUT} = I_{OUTmax}$		4	12	mV
Turn-on time	$V_{OUT} = \{1 \text{ to } 1.8 \text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1$ V up to 97% of V_{OUT} $V_{OUT} = \{1.9 \text{ to } 3.3 \text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1$ V up to 97% of V_{OUT}	30 50		150 200	μ s
Turn-on inrush current			200	450	mA
Ripple Rejection	$V_{IN} = V_{INDC} + 100$ mV _{pp} tone, $V_{INDC+} = 3.8$ V, $I_{OUT} = I_{OUTmax}/2$ $f = 217$ Hz $f = 20$ kHz		70 40		dB
LDO5 internal resistance	LDO Off		60		Ω
Ground current	On mode, $I_{OUT} = 0$ On mode, $I_{OUT} = I_{OUTmax}$ Low-power mode Off mode		65 14	76 2000 22 1	μ A

5.22 LDO6, LDO7, And LDO8

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input voltage (VCC3) V_{IN}	$V_{OUT}(LDO6) = 1.2 \text{ V @ } 150 \text{ mA}$, $V_{OUT}(LDO7) = 1.1 \text{ V @ } 150 \text{ mA}$ and $(VLDO8) = 1 \text{ V @ } 180 \text{ mA}$ $V_{OUT}(LDO7) = 1.8 \text{ V/2 V}$ and $V_{OUT}(LDO6) = 1.8 \text{ V}$ $V_{OUT}(LDO7) = 2.8 \text{ V}$ $V_{OUT}(LDO7) = 3.3 \text{ V}$ $V_{OUT}(LDO7) = 2.8 \text{ V @ } 250 \text{ mA}$ $V_{OUT}(LDO7) = 3.0 \text{ V}$ $V_{OUT}(LDO7) = 3.3 \text{ V @ } 250 \text{ mA}$	1.7 2.7 3.2 3.6 3.2 3.6 3.6		5.5 5.5 5.5 5.5 5.5 5.5 5.5	V
LDO6					
DC Output voltage V_{OUT}	On and low-power mode, $V_{IN} = V_{INmin}$ to V_{INmax}	–3%	1 1.1 ... 3.2 3.3	+3%	V
Rated output current I_{OUTmax}	On mode Low-power mode	300 1			mA
Load current limitation (short-circuit protection)	On mode, $V_{OUT} = V_{OUTmin} - 100 \text{ mV}$	450	550	650	mA
Dropout Voltage V_{DO}	On mode, $V_{DO} = V_{IN} - V_{OUT}$, $V_{IN} = 2.7 \text{ V}$, $I_{OUT} = I_{OUTmax}$ $V_{IN} = 2.7 \text{ V}$, $I_{OUT} = 250 \text{ mA}$ $V_{IN} = 2.7 \text{ V}$, $I_{OUT} = 200 \text{ mA}$ $V_{IN} = 1.7 \text{ V}$, $I_{OUT} = 180 \text{ mA}$ $V_{IN} = 1.7 \text{ V}$, $I_{OUT} = 150 \text{ mA}$ $V_{IN} = 1.7 \text{ V}$, $I_{OUT} = 100 \text{ mA}$			500 400 300 700 500 300	mV
DC load regulation	On mode, $I_{OUT} = I_{OUTmin}$ to 0			15	mV
DC line regulation	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = I_{OUTmax}$			4	mV
Transient load regulation	On mode, $V_{IN} = 3.2 \text{ V}$, $V_{OUTtyp} = 2.8 \text{ V}$ $I_{OUT} = 0.1 \times I_{OUTmax}$ to $0.9 \times I_{OUTmax}$ in $5 \mu\text{s}$ and $I_{OUT} = 0.9 \times I_{OUTmax}$ to $0.1 \times I_{OUTmax}$ in $5 \mu\text{s}$		20	32	mV
Transient line regulation	On mode, $V_{IN} = 2.7 \text{ V} + 0.5 \text{ V}$ to 2.7 V in $30 \mu\text{s}$ and $V_{IN} = 2.7 \text{ V}$ to $2.7 \text{ V} + 0.5 \text{ V}$ in $30 \mu\text{s}$, $I_{OUT} = I_{OUTmax}$		5	15	mV
Turn-on time	$V_{OUT} = \{1 \text{ to } 1.8 \text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1 \text{ V}$ up to 97% of V_{OUT} $V_{OUT} = \{1.9 \text{ to } 3.3 \text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1 \text{ V}$ up to 97% of V_{OUT}	30 50		150 200	μs
Turn-on Inrush current			200	450	mA
Ripple Rejection	$V_{IN} = V_{INDC} + 100 \text{ mV}_{pp}$ tone, $V_{INDC+} = 3.8 \text{ V}$, $I_{OUT} = I_{OUTmax}/2$ $f = 217 \text{ Hz}$ $f = 20 \text{ kHz}$		70 40		dB
LDO6 internal resistance	LDO off		60		Ω
Ground current	On mode, $I_{OUT} = 0$ On mode, $I_{OUT} = I_{OUTmax}$ Low-power mode Off mode		65 14	76 2000 22 1	μA
LDO7					
DC output voltage V_{OUT}	On and low-power mode, $V_{IN} = V_{INmin}$ to V_{INmax}		1		

LDO6, LDO7, And LDO8 (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
		–3%	1.1 ... 3.2 3.3	+3%	V
Rated output current I_{OUTmax}	On mode Low-power mode	300 1			mA
Load current limitation (short-circuit protection)	On mode, $V_{OUT} = V_{OUTmin} - 100\text{ mV}$	450	550	650	mA
Dropout voltage V_{DO}	On mode, $V_{DO} = V_{IN} - V_{OUT}$, $V_{IN} = 2.7\text{ V}$, $I_{OUT} = I_{OUTmax}$ $V_{IN} = 2.7\text{ V}$, $I_{OUT} = 250\text{ mA}$ $V_{IN} = 2.7\text{ V}$, $I_{OUT} = 200\text{ mA}$ $V_{IN} = 1.7\text{ V}$, $I_{OUT} = 180\text{ mA}$ $V_{IN} = 1.7\text{ V}$, $I_{OUT} = 150\text{ mA}$ $V_{IN} = 1.7\text{ V}$, $I_{OUT} = 100\text{ mA}$			500 400 300 700 500 300	mV
DC load regulation	On mode, $I_{OUT} = I_{OUTmax}$ to 0			15	mV
DC line regulation	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = I_{OUTmax}$			4	mV
Transient load regulation	On mode, $V_{IN} = 3.6\text{ V}$, $V_{OUTtyp} = 3.3\text{ V}$ $I_{OUT} = 0.1 \times I_{OUTmax}$ to $0.9 \times I_{OUTmax}$ in $5\text{ }\mu\text{s}$ and $I_{OUT} = 0.9 \times I_{OUTmax}$ to $0.1 \times I_{OUTmax}$ in $5\text{ }\mu\text{s}$		16	25	mV
Transient line regulation	On mode, $I_{OUT} = I_{OUTmax}/2$, $V_{IN} = 2.7 + 0.5\text{ V}$ to 2.7 in $30\text{ }\mu\text{s}$ and $V_{IN} = 2.7\text{ V} + 0.5\text{ V}$ in $30\text{ }\mu\text{s}$, $I_{OUT} = I_{OUTmax}/2$		5	15	mV
Turn-on time	$V_{OUT} = \{1\text{ to }1.8\text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1\text{ V}$ up to 97% of V_{OUT}	30		150	μs
	$V_{OUT} = \{1.9\text{ to }3.3\text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1\text{ V}$ up to 97% of V_{OUT}	50		200	
Turn-on inrush current			200	450	mA
Ripple rejection	$V_{IN} = V_{INDC} + 100\text{ mV}_{pp}$ tone, $V_{INDC+} = 3.8\text{ V}$, $I_{OUT} = I_{OUTmax}/2$ $f = 217\text{ Hz}$ $f = 20\text{ kHz}$		70 40		dB
LDO7 internal resistance	LDO off		60		Ω
Ground current	On mode, $I_{OUT} = 0$ On mode, $I_{OUT} = I_{OUTmax}$ Low-power mode Off mode		65 14	76 2000 22 1	μA
LDO8					
DC output voltage V_{OUT}	On and low-power mode, $V_{IN} = V_{INmin}$ to V_{INmax}	–3%	1 1.1 ... 3.2 3.3	+3%	V
Rated output current I_{OUTmax}	On mode Low-power mode	300 1			mA
Load current limitation (short-circuit protection)	On mode, $V_{OUT} = V_{OUTmin} - 100\text{ mV}$	450	550	650	mA

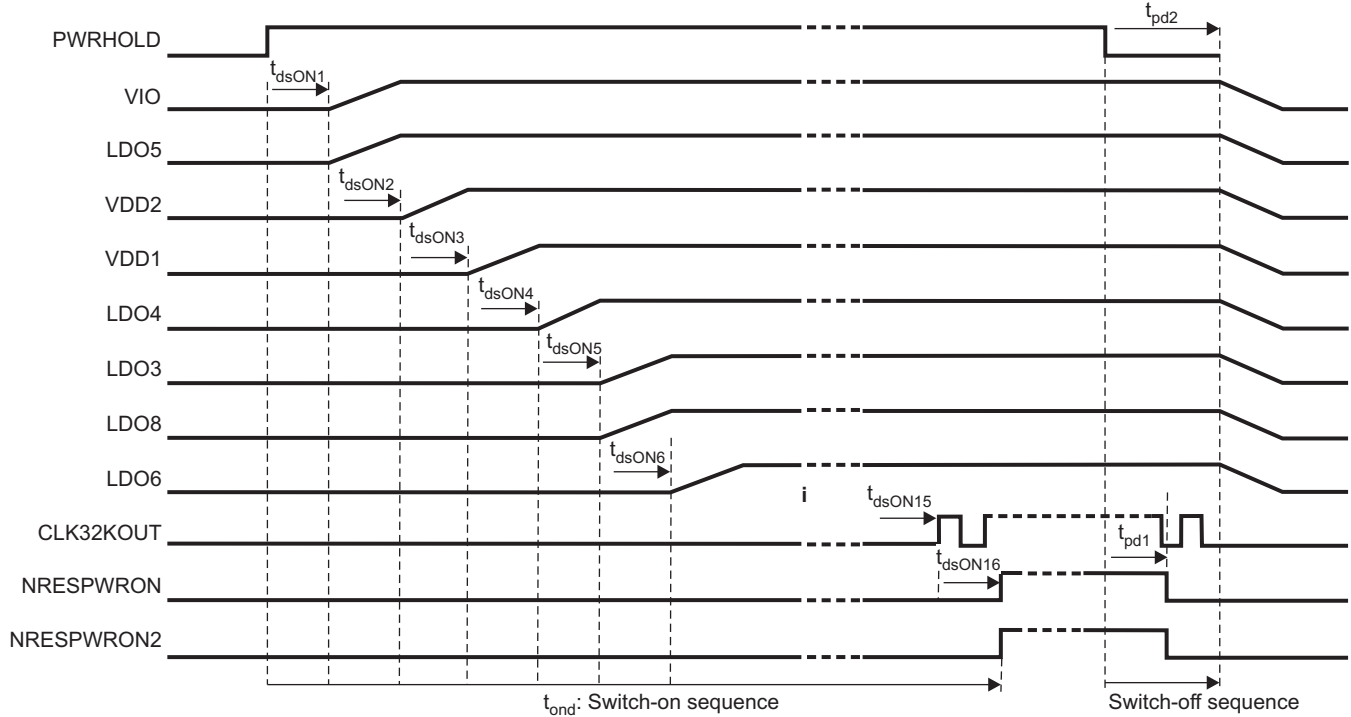
LDO6, LDO7, And LDO8 (continued)

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Dropout voltage V_{DO}	On mode, $V_{DO} = V_{IN} - V_{OUT}$, $V_{IN} = 2.7\text{ V}$, $I_{OUT} = I_{OUTmax}$ $V_{IN} = 2.7\text{ V}$, $I_{OUT} = 250\text{ mA}$ $V_{IN} = 2.7\text{ V}$, $I_{OUT} = 200\text{ mA}$ $V_{IN} = 1.7\text{ V}$, $I_{OUT} = 180\text{ mA}$ $V_{IN} = 1.7\text{ V}$, $I_{OUT} = 150\text{ mA}$ $V_{IN} = 1.7\text{ V}$, $I_{OUT} = 100\text{ mA}$			500 400 300 700 500 300	mV
DC load regulation	On mode, $I_{OUT} = I_{OUTmax}$ to 0			15	mV
DC line regulation	On mode, $V_{IN} = V_{INmin}$ to V_{INmax} @ $I_{OUT} = I_{OUTmax}$			4	mV
Transient load regulation	On mode, $V_{IN} = 1.7\text{ V}$, $V_{OUTtyp} = 1.2\text{ V}$ $I_{OUT} = 10\text{ mA}$ to 90 mA in $5\text{ }\mu\text{s}$ and $I_{OUT} = 90\text{ mA}$ to 10 mA in $5\text{ }\mu\text{s}$		7	30	mV
Transient line regulation	On mode, $I_{OUT} = 100\text{ mA}$, $V_{IN} = 2.7\text{ V} + 0.2\text{ V}$ to 2.7 V in $30\text{ }\mu\text{s}$ and $V_{IN} = 2.7\text{ V}$ to $2.7\text{ V} + 0.2\text{ V}$ in $30\text{ }\mu\text{s}$, $I_{OUT} = 100\text{ mA}$		5	15	mV
Turn-on time	$V_{OUT} = \{1\text{ to }1.8\text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1\text{ V}$ up to 97% of V_{OUT} $V_{OUT} = \{1.9\text{ to }3.3\text{ V}\}$, @ $I_{OUT} = 0$ measured from $V_{OUT} = 0.1\text{ V}$ up to 97% of V_{OUT}	30 50		150 200	μs
Turn-on inrush current			200	450	mA
Ripple rejection	$V_{IN} = V_{INDC} + 100\text{ mV}_{pp}$ tone, $V_{INDC+} = 3.8\text{ V}$, $I_{OUT} = I_{OUTmax}/2$ $f = 217\text{ Hz}$ $f = 20\text{ kHz}$		70 40		dB
LDO8 internal resistance	LDO off		60		Ω
Ground current	On mode, $I_{OUT} = 0$ On mode, $I_{OUT} = I_{OUTmax}$ Low-power mode Off mode		65 14	76 2000 22 1	μA

6 Switch-ON/OFF Sequences And Timing

An example boot sequence is described in this chapter. Each TPS65911x part number supports a dedicated EEPROM boot sequence to match specific processor requirements. Fixed boot mode is the same in all TPS65911x part numbers. Boot mode selection is described in [Section 8.3.2](#).



Note:: [Figure 6-1](#) is for illustrative purposes only and does not describe any actual TPS65911x part number.

Figure 6-1. Boot Sequence Example with 2-ms Time Slot and Simultaneous Switch-Off of Resources

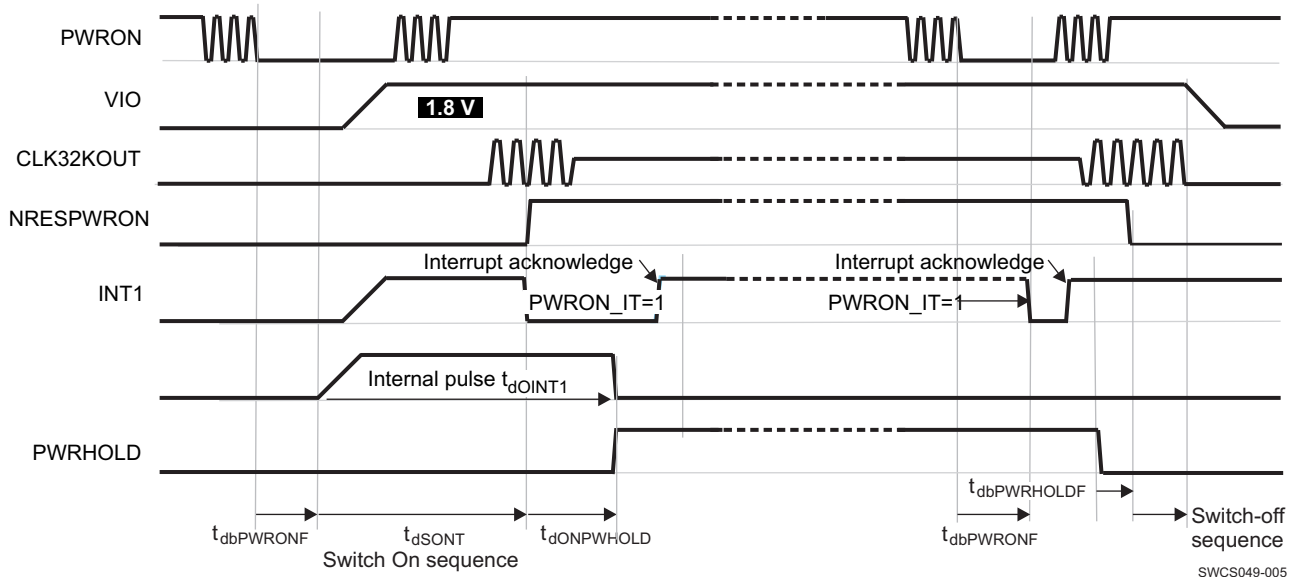
Table 6-1. Timing Characteristics for Boot Sequence Example

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{dsON1}	PWRHOLD rising edge to VIO, LDO5 enable delay		$66 \times t_{CK32k} = 2060$		μs
t_{dsON2}	VIO to VDD2 enable delay		$64 \times t_{CK32k} = 2000$		μs
t_{dsON3}	VDD2 to VDD1 enable delay		$64 \times t_{CK32k} = 2000$		μs
t_{dsON4}	VDD1 to LDO4 enable delay		$64 \times t_{CK32k} = 2000$		μs
t_{dsON5}	LDO4 to LDO3, LDO8 enable delay		$64 \times t_{CK32k} = 2000$		μs
t_{dsON6}	LDO3 to LDO6 enable delay		$64 \times t_{CK32k} = 2000$		μs
t_{dsON7}	LDO6 to CLK32KOUT rising-edge delay		$9 \times 64 \times t_{CK32k} = 18000$		μs
t_{dsON16}	CLK32KOUT to NRESPWON, NRESPWON2 rising-edge delay		$64 \times t_{CK32k} = 2000$		μs
t_{dsONT}	Total switch-on delay		32		ms
t_{pd1}	PWRHOLD falling-edge to NRESPWON, NRESPWON2 falling-edge delay		$2 \times t_{CK32k} = 62.5$		μs
t_{pd1b}	NRESPWON falling-edge to CLK32KOUT low delay		$3 \times t_{CK32k} = 92$		μs
t_{pd2}	PWRHOLD falling-edge to supplies and reference disable delay		$5 \times t_{CK32k} = 154$		μs

7 Power Control Timing

7.1 Device State Control Through PWRON Signal

Figure 7-1 shows the device state control through PWRON signal.



Note::

1. DEV_ON or AUTODEV_ON control bits can be used instead of PWRHOLD signal to maintain supplies on after switch-on sequence.
2. Internal POWER ON enable condition pulse TdOINT1 keeps device active until PWRHOLD acknowledge.
3. Switch-off from PWRHOLD removal

Figure 7-1. Device State Control Through PWRON Signal

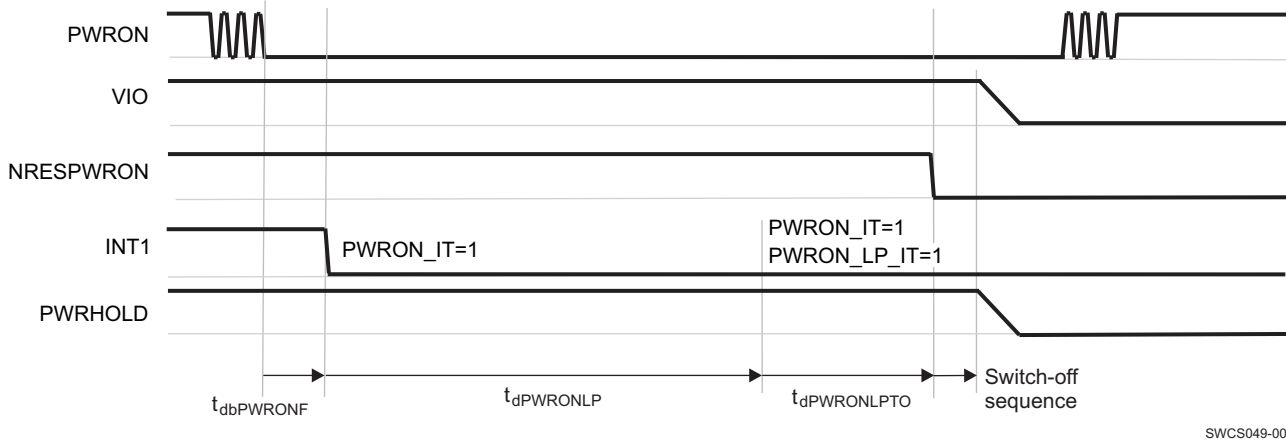


Figure 7-2. PWRON Long-Press Turn-Off

Table 7-1 lists the power control timing characteristics.

Table 7-1. Power Control Timing Characteristics

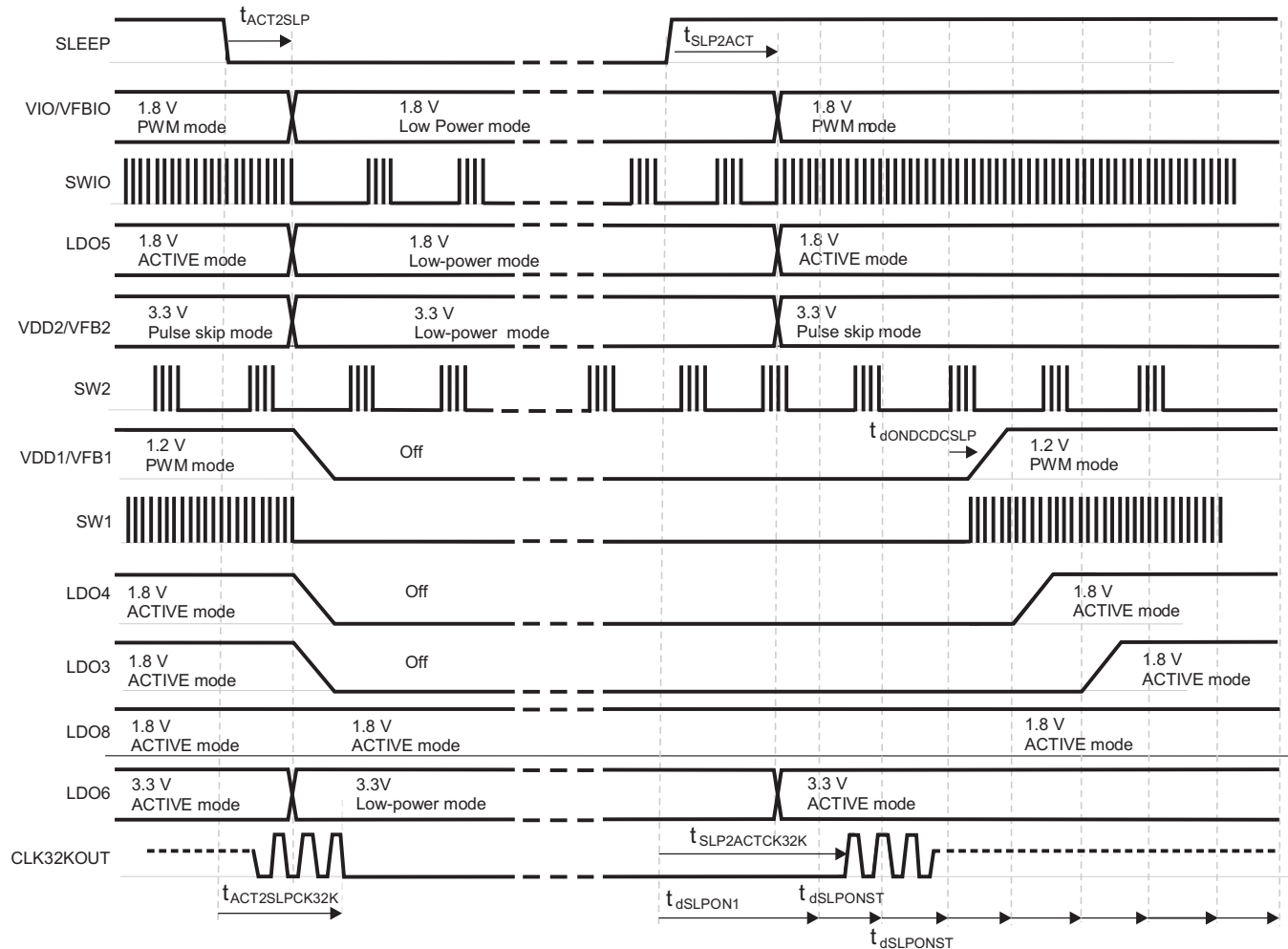
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{dbPWRONF}$: PWRON falling-edge debouncing delay			100		ms
$t_{dbPWRONR}$: PWRON rising-edge debouncing delay			$3 \times t_{CK32k} = 94$		μs

Table 7-1. Power Control Timing Characteristics (continued)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{dbPWRHOLD}$: PWRHOLD rising-edge debouncing delay			$2 \times t_{CK32k} = 63$		μs
t_{dOINT1} : INT1 (internal) Power-on pulse duration after PWRON low-level (debounced) event			1		s
$t_{dONPWHOLD}$: delay to set high PWRHOLD signal or DEV_ON control bit after NRESPWON released to keep on the supplies			$t_{dOINT1} - t_{dSONT} = 970^{(1)}$		ms
$t_{dPWRONLP}$: PWRON long-press delay	PWRON falling-edge to PWRON_LP_IT		4		s
$t_{dPWRONLPTO}$: PWROW long-press interrupt (PWRON_LP_IT) to supplies switch-off	PWRON_LP_IT to NRESPWON falling-edge		1		s

(1) $t_{dSONT} = 30$ ms, as in example boot sequence.

7.2 Device SLEEP State Control



SWCS049-007

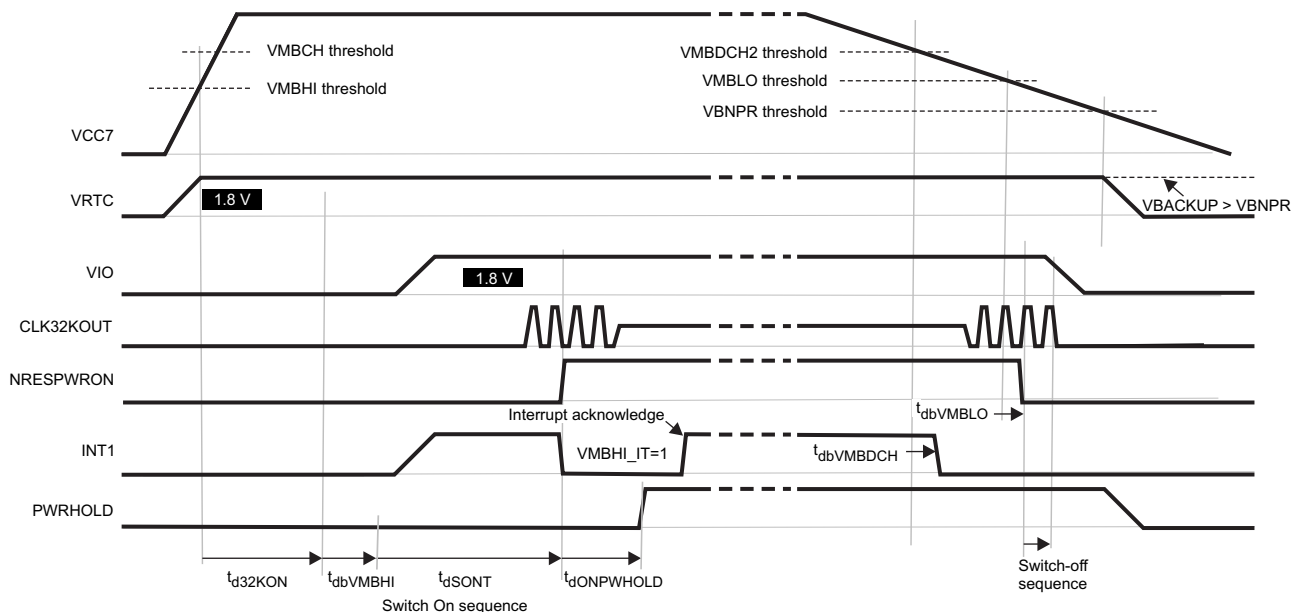
NOTE: Registers programming: VIO_PSKIP = 0, VDD1_PSKIP = 0, VDD1_SETOFF = 1, LDO3_SETOFF = 1, LDO4_SETOFF = 1, LDO8_KEEPOFF = 1.

Figure 7-3. Device SLEEP State Control

Table 7-2. Device SLEEP State Control Timing Characteristics

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{ACT2SLP}$	SLEEP falling-edge to supply in low-power mode (SLEEP resynchronization delay)	$2 \times t_{CK32k} = 62$		$3 \times t_{CK32k} = 94$	μs
$t_{ACT2SLPCK32K}$	SLEEP falling-edge to CLK32KOUT low	156	$t_{ACT2SLP} + 3 \times t_{CK32k}$	188	μs
$t_{SLP2ACT}$	SLEEP rising edge to supply in high-power mode	$8 \times t_{CK32k} = 250$		$9 \times t_{CK32k} = 281$	μs
$t_{SLP2ACTCK32K}$	SLEEP rising edge to CLK32KOUT running	344	$t_{SLP2ACT} + 3 \times t_{CK32k}$	375	μs
$t_{dSLPON1}$	SLEEP rising edge to time step 1 of the turn-on sequence from SLEEP state	281	$t_{SLP2ACT} + 1 \times t_{CK32k}$	312	μs
$t_{dSLPONST}$	turn-on sequence step duration, from SLEEP state TSLOT_LENGTH[1:0] = 00 TSLOT_LENGTH[1:0] = 01 TSLOT_LENGTH[1:0] = 10 TSLOT_LENGTH[1:0] = 11		0 200 500 2000		μs
$t_{dSLPONDCDC}$	VDD1, VDD2, or VIO turn-on delay from turn-on sequence time step		$2 \times t_{CK32k} = 62$		μs

7.3 Device Turn-On/Turn-Off with Rising/Falling Input Voltage



SWCS049-008

NOTE: To allow power-up from first supply insertion as shown here, VMBHI_IT_MSK is set to 0.

NOTE: Power-up to active state is enabled when VMBHI interrupt is not masked (VMBHI_IT_MSK in boot configuration).

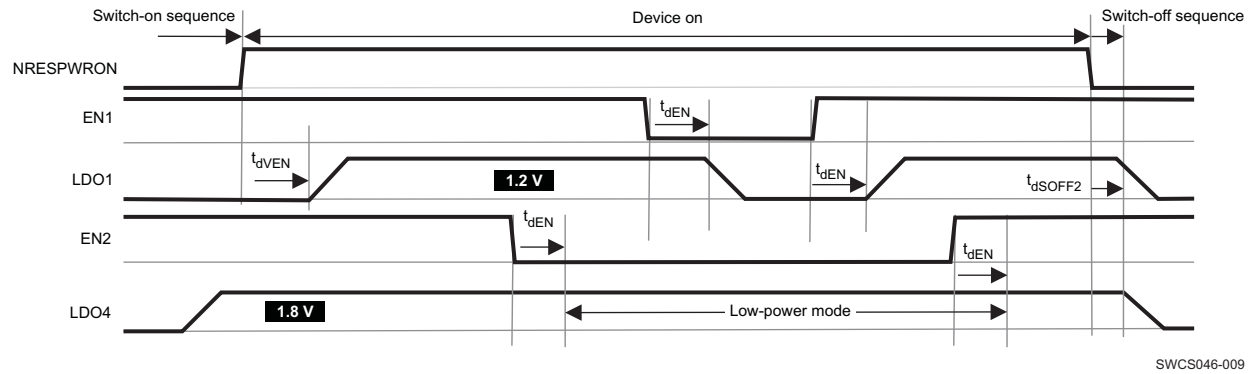
NOTE: DEV_ON or AUTODEV_ON control bits can be used instead of PWRHOLD signal to maintain supplies on after switch-on sequence

Figure 7-4. Device Turn-On/Off with Rising/Falling Input Voltage

Table 7-3. Device Turn-On Voltage with Rising Input Voltage, Timing Characteristics

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{d32KON} : 32-kHz oscillator turn-on time	RC oscillator Quartz oscillator bypass clock		0.1 200 0.1		ms
$t_{dbVMBHI}$: VMBHI rising-edge debouncing delay		$3 \times t_{CK32k} = 94$		$4 \times t_{CK32k} = 125$	μs
t_{dOINT1} : INT1 Power On pulse duration after VMBHI high level (debounced) event			1		s
$t_{dONPWHOLD}$: delay to set high PWRHOLD signal or DEV_ON control bit after NRESPWRON released in order to keep on the supplies			$t_{dOINT1} - t_{DSONT} = 970$		ms
$t_{dbVMBDCH}$: Main Battery voltage = VMBDCH threshold to INT1 falling-edge delay		$3 \times t_{CK32k} = 94$		$4 \times t_{CK32k} = 125$	s
$t_{dbVMBLO}$: Main Battery voltage = VMBLO threshold to NRESPWRON falling-edge delay		$3 \times t_{CK32k} = 94$		$4 \times t_{CK32k} = 125$	s

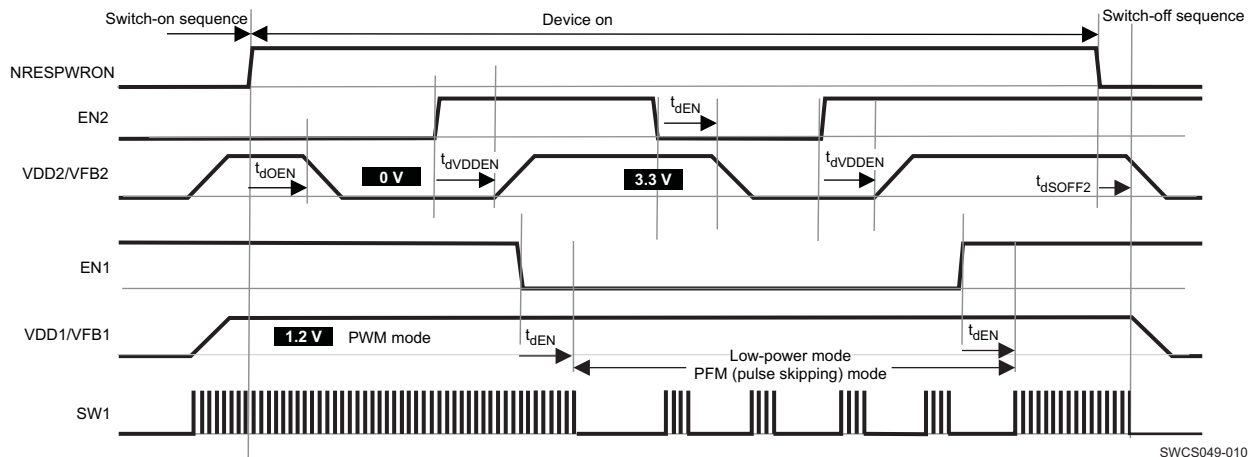
7.4 Power Supplies State Control Through EN1 and EN2 Signals



SWCS046-009

NOTE: Register setting: LDO1_EN1 = 1, LDO4_EN2 = 1, and LDO4_KEEPPON = 1.

Figure 7-5. LDO Type Supplies State Control Through EN1 and EN2



SWCS049-010

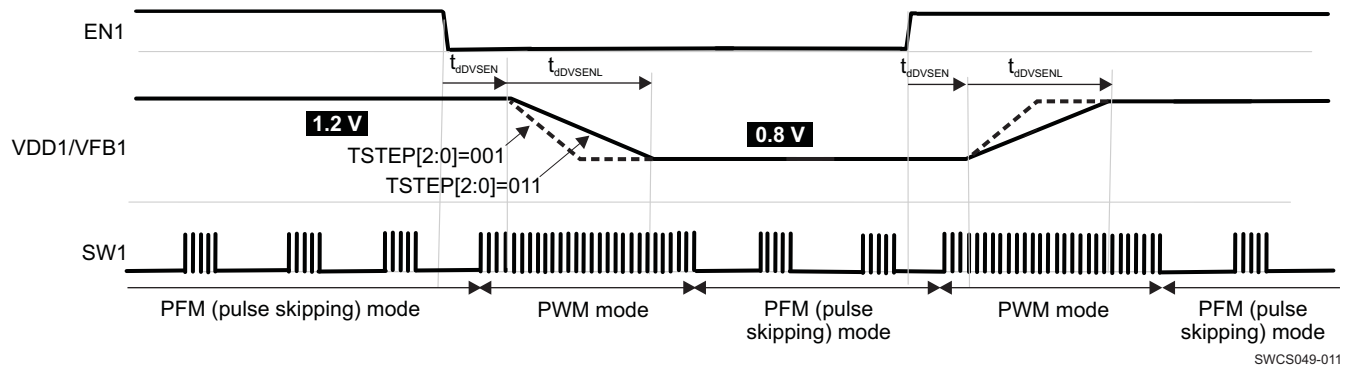
NOTE: Register setting: VDD2_EN2 = 1, VDD1_EN1 = 1, VDD1_KEEPPON = 1, VDD1_PSKIP = 0, and SEL[6:0] = hex00 in VDD2_SR_REG.

Figure 7-6. VDD1 and VDD2 Supplies State Control Through EN1 and EN2

Table 7-4. Supplies State Control Through EN1 and EN2 Timing Characteristics

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{dEN} : NRESPWRON to supply state change delay, EN1 or EN2 driven			0		ms
t_{dOEN} : EN1 or EN2 edge to supply state change delay			$1 \times t_{CK32k} = 31$		μ s
t_{dVDDEN} : EN1 or EN2 edge to VDD1 or VDD2 DCDC turn on delay			$3 \times t_{CK32k} = 63$		μ s

7.5 VDD1, VDD2 Voltage Control Through EN1 and EN2 Signals



NOTE: Register setting: VDD1_EN1=1, SEL[6:0]=hex13 in VDD1_SR_REG

Figure 7-7. VDD1 Supply Voltage Control Through EN1

Table 7-5. VDD1 Supply Voltage Control Through EN1 Timing Characteristics

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{dVSEN} : EN1 (or EN2) edge to VDD1 (or VDD2) voltage change delay			$2 \times t_{CK32k} = 62$		μs
t_{dVSENL} : VDD1 (or VDD2) voltage settling delay	TSTEP[2:0] = 001 TSTEP[2:0] = 011 (default) TSTEP[2:0] = 111		32 0.4/7.5 = 53 160		μs

8 Detailed Description

8.1 Power Reference

The bandgap voltage reference is filtered by using an external capacitor connected across the VREF output and the analog ground REFGND (see [Section 5.3](#)). The VREF voltage is distributed and buffered inside the device.

8.2 Power Resources

The power resources provided by the TPS65911 device include inductor based switched mode power supplies (SMPSs) and linear low-dropout voltage regulators (LDOs). These supply resources provide the required power to the external processor cores and external components, and to modules embedded in the TPS65911 device.

Two of the integrated SMPSs and the external FET SMPS have voltage scaling capability. These SMPSs will provide independent core voltage domains to the host processor. When changing the output voltage, VDD1 and VDD2 reach the new value through successive steps of 2.5 to 12.5 mV. The size of the voltage step is selected by the TSTEP bit. VDDCtrl has a target slew rate of 100 mV/20 μ s. New output values are reached in successive smaller steps of $N \times \text{LSB}$, $\text{LSB} = 12.5 \text{ mV}$, $N = 1$ to 4. A suitable combination of steps is calculated internally based on current and new target value for output voltage.

The VIO SMPS provides supply voltage for the host processor I/Os.

[Table 8-1](#) lists the power sources provided by the TPS65911 device.

Table 8-1. Power Sources

RESOURCE	TYPE	VOLTAGES	POWER
VIO	SMPS	1.5 V	1300 mA
		1.8 V	1200 mA
		2.2 / 3.3 V	1100 mA
VDD1	SMPS	0.6 to 2.2 V	1500 mA
		3.2 V	1200 mA
		1.2 / 1.35 / 1.5 V ($V_{\text{INmin}} = 3 \text{ V}$)	2000 mA
		0.6 ... 1.5 V in 12.5-mV steps Programmable multiplication factor: x2, x3. Maximum output 3.3 V	
VDD2	SMPS	0.6 to 1.5 V	1500 mA
		2.2 / 3.2 V	1200 mA
		0.6 ... 1.5 V in 12.5-mV steps Programmable multiplication factor: x2, x3. Maximum output 3.3 V	
VDDCtrl	SMPS	0.6 ... 1.4 V in 12.5-mV steps	External component dependent
LDO1	LDO	1.0–3.3 V, 0.05-V step	320 mA
LDO2	LDO	1.0–3.3 V, 0.05-V step	320 mA
LDO3	LDO	1.0–3.3 V, 0.1-V step	200 mA
LDO4	LDO	1.0–3.3 V, 0.05-V step	50 mA
LDO5	LDO	1.0–3.3 V, 0.1-V step	300 mA
LDO6	LDO	1.0–3.3 V, 0.1-V step	300 mA
LDO7	LDO	1.0–3.3 V, 0.1-V step	300 mA
LDO8	LDO	1.0–3.3 V, 0.1-V step	300 mA

8.3 Embedded Power Controller

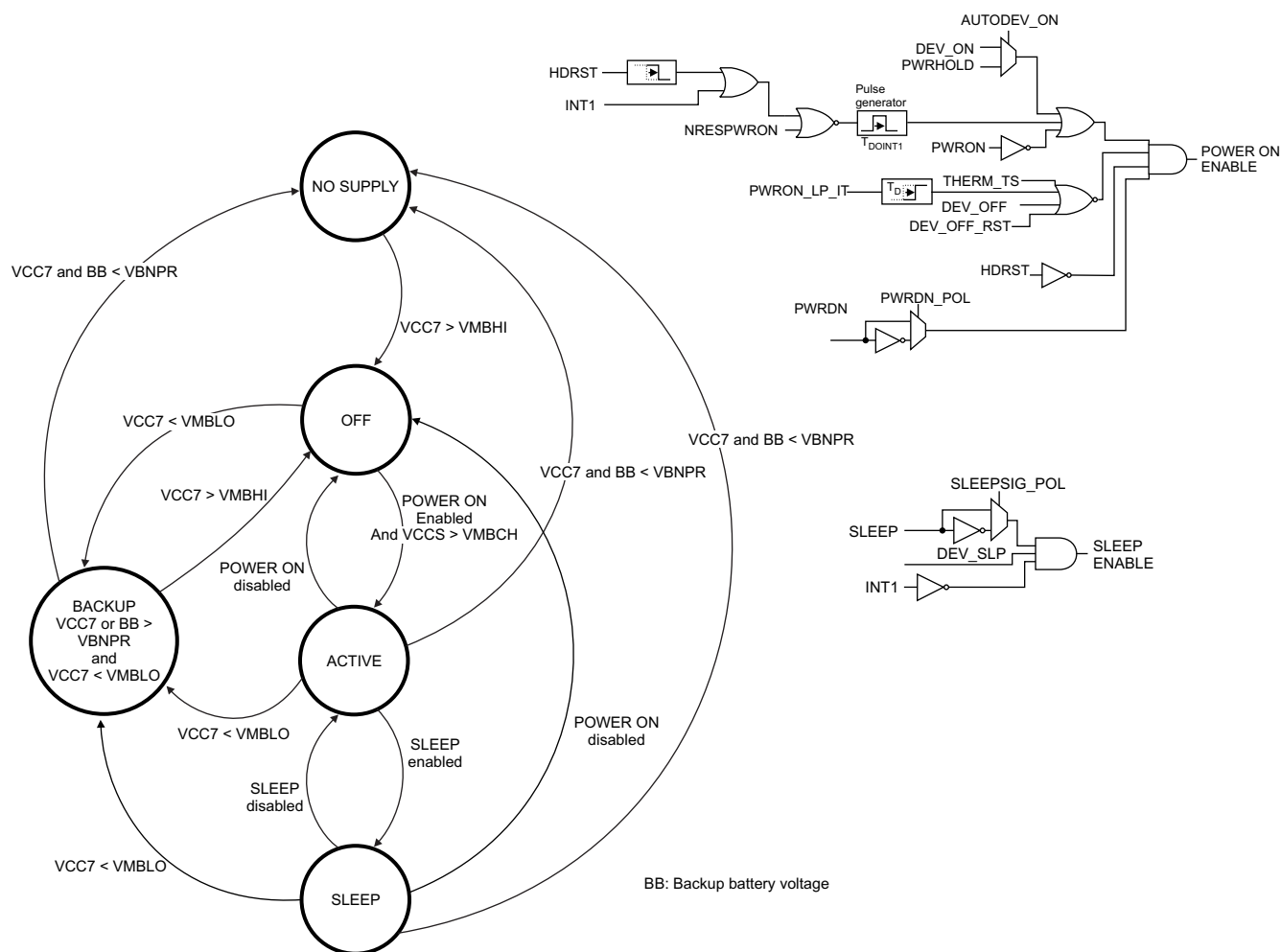
The embedded power controller (EPC) manages the state of the device and controls the power-up sequence.

8.3.1 STATE-MACHINE

The EPC supports the following states:

- **NO SUPPLY:** The main battery supply voltage is not high enough to power the VRTC regulator. A global reset is asserted in this case. Everything on the device is off.
- **BACKUP:** The main battery supply voltage is high enough to enable the VRTC domain but not enough to switch on all the resources. In this state, the VRTC regulator is in backup mode and only the 32K oscillator and RTC module are operating (if enabled). All other resources are off or under reset.
- **OFF:** The main battery supply voltage is high enough to start the power-up sequence but device power on is not enabled. All power supplies are in the OFF state except VRTC.
- **ACTIVE:** Device POWER ON enable conditions are met and regulated power supplies are on or can be enabled with full current capability.
- **SLEEP:** Device SLEEP enable conditions are met and some selected regulated power supplies are in low-power mode.

[Figure 8-1](#) shows the transitions for the state-machine.



SWCS049-024

NOTE: PWRHOLD enables power-on unless the pin is programmed as GPI.

Figure 8-1. Embedded Power Control State-Machine

Device POWER ON enable conditions:

- None of the device POWER ON disable conditions are met.
- PWRON signal low level
- Or PWRHOLD signal high level
- Or DEV_ON control bit set to 1 (default inactive)
- Or interrupt flag active (default INT1 low) generates a POWER ON enable condition during a fixed delay (t_{DOINT1} pulse duration defined in Section 7). Interrupt sources expected (if enabled), when the device is off:
 - RTC alarm interrupt
 - First-time input voltage rising above the VMBHI threshold (depending on the boot mode used) and input voltage $> VMBCH$ threshold. The interrupt corresponding to this last condition is VMBCH_IT in the INT_STS_REG register.
 - Or HDRST reset release generates a POWER ON enable condition during a fixed delay t_{DOINT1}

Interrupt flag active generates a POWER ON enable condition pulse of length t_{DOINT1} only when the device is in the OFF state (when the NRESPWRON signal is low). The POWER ON enable condition pulse occurs only if the interrupt status bit is initially low (no previous interrupt pending in the status register). The interrupt status register must first be cleared to allow device power off during the t_{DOINT1} pulse duration.

GPIO2 cannot be used to turn on the device, even if its associated interrupt is not masked. The GPIO0, GPIO1, GPIO3, GPIO4, or GPIO5 signals can be used to turn on the device, if its associated interrupt is not masked.

Note: The watchdog interrupt is not a power on event, but will wake up the device from sleep mode.

Device POWER ON disable conditions:

- PWRON signal low level during more than the long-press delay: PWON_LP_DELAY (can be disabled though register programming). The interrupt corresponding to this condition is PWRON_LP_IT in the INT_STS_REG register.
- Or die temperature has reached the thermal shutdown threshold (THERM_TS = 1).
- Or DEV_OFF or DEV_OFF_RST control bit is set to 1 (DEV_OFF value is cleared when the device is in OFF state).

Note: If the DEV_ON bit is set to 1, after switch-off, the device will switch back on. To keep the device off, DEV_ON must be cleared first.

Device SLEEP enable conditions:

- SLEEP signal low level (default, or high level depending on the programmed polarity)
- And DEV_SLP control bit is set to 1.
- And interrupt flag inactive (default INT1 high): no nonmasked interrupt is pending.

The SLEEP state can be controlled by programming DEV_SLP and keeping the SLEEP signal in the active polarity state, or it can be controlled through the SLEEP signal setting the DEV_SLP bit to 1 once, after device turn-on.

Device reset scenarios:

The device has three reset scenarios:

- Full reset: All digital logic of device is reset.
 - Caused by POR (power on reset) when VCC7 < VBNPR and BB < VBNPR
- General reset: No impact on the RTC, backup registers, or interrupt status.
 - Caused by PWON_LP_RST bit set high
 - Or DEV_OFF_RST bit set high
 - Or HDRST input set high
- Turnoff: Power reinitialization in off/backup mode.

A mapping of digital registers to these reset scenarios is described in [Table 11-1](#).

8.3.2 BOOT Configuration And Switch-ON/OFF Sequences

The power sequence is the automated switch-on of the devices resources when an OFF-to-ACTIVE transition occurs. The power-on sequence has 15 sequential time slots to which resources (DCDCs, LDOs, 32-kHz clock, GPIO0, GPIO2, GPIO6, GPIO7) can be assigned. The time slot length can be selected to be 0.5 ms or 2 ms. If a resource is not assigned to any time slot, it will be in off mode after the power-on sequence and the voltage level can be changed through the register SEL bits before enabling the resource.

Power off disables all power resources at the same time by default. By setting the PWR_OFF_SEQ control bit to 1, power off will follow the power-up sequence in reverse order (the first resource to be powered on will be last to power off).

The values of VDD1, VDD2, and VDDCtrl set in the boot sequence can be selected from 16 steps. For the whole range, 100-mV steps are available: 0.6/0.7...1.4/1.5 V. From 0.8 to 1.4 V, additional values with 50-mV step resolution can be set: 0.85/1.05...1.35 V.

For LDO1, LDO2, and LDO4 all levels from 1.0 to 3.3 V are selectable in the boot sequence with 50-mV steps. For other LDOs, the level is selectable with 100-mV steps, from 1.0 to 3.3 V.

The device supports three boot configurations, which define the power sequence and several device control bits. The boot configuration is selectable by the device BOOT1 pin.

BOOT1	Boot Configuration
Floating	Test boot mode
0	Fixed boot mode
1	EEPROM boot mode

The BOOT1 input pad is disabled after the boot mode is read at power up, to save power.

[Table 8-2](#) and [Table 8-3](#) describe the power sequence and general control bits defined in the boot sequence, respectively.

Fixed boot mode is the same in all part numbers while EEPROM boot mode is different in each part number. For EEPROM boot mode description refer to the User Guide for the selected part number.

Table 8-2. Boot Configuration: Power Sequence Control Bits

Register	Bit	Description	TPS65911x	
			Fixed Boot	EEPROM Boot
VDD1_OP_REG/VDD1_SR_REG		VDD1 voltage level selection for boot. Levels available: 0.6/0.7/0.8/0.85/0.9/0.95/.../1.35/1.4/1.5 V	1.2 V	x
VDD1_REG	VGAIN_SEL	VDD1 gain selection, x1 or x2	x1	x
EEPROM		VDD1 time slot selection	3	x
DCDCCTRL_REG	VDD1_PSKIP	VDD1 pulse skip mode enable	Enable skip	x
VDD2_OP_REG/VDD2_SR_REG		VDD2 voltage level selection for boot. Levels available: 0.6/0.7/0.8/0.85/0.9/0.95/.../1.35/1.4/1.5 V	1.5 V	x
VDD2_REG	VGAIN_SEL	VDD2 gain selection, x1 or x3	x1	x
EEPROM		VDD2 time slot selection	6	x
DCDCCTRL_REG	VDD2_PSKIP	VDD2 pulse skip mode enable	Enable skip	x
VIO_REG	SEL[3:2]	VIO voltage selection	1.8 V	x
EEPROM		VIO time slot selection	4	x
DCDCCTRL_REG	VIO_PSKIP	VIO pulse skip mode enable	Enable skip	x
VDDCtrl_OP_REG/VDDCtrl_SR_REG		VDDCtrl voltage level selection for boot. Levels available: 0.6/0.7/0.8/0.85/0.9/0.95/.../1.35/1.4 V	Off	x
EEPROM		VDDCtrl time slot selection	Off	x
LDO1_REG	SEL[7:2]	LDO1 voltage selection	1.05 V	x
EEPROM		LDO1 time slot	Off	x
LDO2_REG	SEL[7:2]	LDO2 voltage selection	1.2 V	x
EEPROM		LDO2 time slot	7	x
LDO3_REG	SEL[6:2]	LDO3 voltage selection	LDO3 voltage: 1 V	x
EEPROM		LDO3 time slot	Off	x
LDO4_REG	SEL[7:2]	LDO4 voltage selection	1.2 V	x
EEPROM		LDO4 time slot	2	x
LDO5_REG	SEL[6:2]	LDO5 voltage selection	LDO5 voltage: 1 V	x
EEPROM		LDO5 time slot	Off	x
LDO6_REG	SEL[6:2]	LDO6 voltage selection	LDO6 voltage: 1 V	x
EEPROM		LDO6 time slot	Off	x
LDO7_REG	SEL[6:2]	LDO7 voltage selection	1.2 V	x
EEPROM		LDO7 time slot	5	x
LDO8_REG	SEL[6:2]	LDO8 voltage selection	1.0 V	x

Table 8-2. Boot Configuration: Power Sequence Control Bits (continued)

Register	Bit	Description	TPS65911x	
			Fixed Boot	EEPROM Boot
EEPROM		LDO8 time slot	7	x
CLK32KOUT pin		CLK32KOUT time slot	5	x
NRESPWRON, NRESPWRON2 pin		NRESPWRON time slot	10	x
GPIO0 pin		GPIO0 time slot	1	x
GPIO2 pin		GPIO2 time slot	Off	x
GPIO6 pin		GPIO6 time slot	6	x
GPIO7 pin		GPIO7 time slot	5	x

Table 8-3. Boot Configuration: General Control Bits

Register	Bit	Description	TPS65911x	
			Fixed Boot	EEPROM Boot
VRTC_REG	VRTC_OFFMASK	0: VRTC LDO will be in low-power mode during OFF state. 1: VRTC LDO will be in full-power mode during OFF state.	0	x
DEVCTRL_REG	CK32K_CTRL	0: Clock source is crystal/external clock. 1: Clock source is internal RC oscillator.	Crystal	x
DEVCTRL_REG	DEV_ON	0: No impact 1: Will maintain device on, in ACTIVE or SLEEP state	0	x
DEVCTRL2_REG	TSLOTD	Boot sequence time slot duration: 0: 0.5 ms 1: 2 ms	2 ms	x
DEVCTRL2_REG	PWON_LP_OFF	0: Turn off device after PWRON long-press not allowed. 1: Turn off device after PWRON long-press.	1	x
DEVCTRL2_REG	PWON_LP_RST	0: No impact 1: Reset digital core when device is off	1	x
DEVCTRL2_REG	IT_POL	0: INT1 signal will be active-low. 1: INT1 signal will be active-high.	0	x
INT_MSK_REG	VMBHI_IT_MSK	0: Device will automatically switch-on at NO SUPPLY-to-OFF or BACKUP-to-OFF transition (device will switch-on when supply is inserted) 1: Start-up reason required before switch-on (VMBHI event interrupt masked)	1	x
INT_MSK3_REG	GPIO5_F_IT_MSK	0: GPIO5 falling-edge detection interrupt not masked 1: GPIO5 falling-edge detection interrupt masked	1	x
INT_MSK3_REG	GPIO5_R_IT_MSK	0: GPIO5 rising-edge detection interrupt not masked 1: GPIO5 rising-edge detection interrupt masked	0	x
INT_MSK3_REG	GPIO4_F_IT_MSK	0: GPIO4 falling-edge detection interrupt not masked 1: GPIO4 falling-edge detection interrupt masked	1	x

Table 8-3. Boot Configuration: General Control Bits (continued)

Register	Bit	Description	TPS65911x	
			Fixed Boot	EEPROM Boot
INT_MSK3_REG	GPIO4_R_IT_MSK	0: GPIO4 rising-edge detection interrupt not masked 1: GPIO4 rising-edge detection interrupt masked	0	x
GPIO0_REG	GPIO_ODEN	0: GPIO0 configured as push-pull output 1: GPIO0 configured as open-drain output	Push-pull	x
WATCHDOG_REG	WATCHDOG_EN	0: Watchdog disabled 1: Watchdog enabled, periodic operation with 100 s	1	x
EEPROM	VMBBUF_BYPASS	0: Enable input buffer for external resistive divider 1: In single-cell system, disable buffer for low power	Disable buffer	x
VMBCH_REG	VMBCH_SEL[5:1]	Select threshold for boot gating comparator COMP1, 2.5–3.5 V.	3.1 V	x
EEPROM	AUTODEV_ON	0: PWRHOLD pin is used as PWRHOLD feature. 1: PWRHOLD pin is GPI. After power on, DEV_ON set high internally, no processor action needed to maintain supplies.	1, PWRHOLD pin is GPI	x
EEPROM	PWRDN_POL	0: PWRDN signal will be active-low. 1: PWRDN signal will be active-high.	Active-low	x

8.3.3 Control Signals

8.3.3.1 SLEEP

When none of the device SLEEP-disable conditions are met, a falling edge (default, or rising edge, depending on the programmed polarity) of this signal causes an ACTIVE-to-SLEEP state transition of the device. A rising edge (default, or falling edge, depending on the programmed polarity) causes a transition back to the ACTIVE state. This input signal is level-sensitive and no debouncing is applied.

While the device is in the SLEEP state, predefined resources are automatically set in their low-power mode or off. Resources can be kept in their active mode (full-load capability) by programming the SLEEP_KEEP_LDO_ON and the SLEEP_KEEP_RES_ON registers. These registers contain 1 bit per power resource. If the bit is set to 1, then that resource stays in active mode when the device is in the SLEEP state.

32KCLKOUT is also included in the SLEEP_KEEP_RES_ON register and the 32-kHz clock output is maintained in the SLEEP state if the corresponding mask bit is set.

The status (low or high) of GPO0, GPO6, GPO7, and GPO8 are also controlled by the SLEEP signal, to allow enabling and disabling of external resources during sleep.

8.3.3.2 PWRHOLD

The PWRHOLD pin can be used as a PWRHOLD signal input or as a general purpose input (GPI). The mode is selected by the AUTODEV_ON bit, which is part of the boot configuration. When AUTODEV_MODE = 0, the PWRHOLD feature is selected.

Configured as PWRHOLD, when none of the device POWER ON disable conditions are met, a high level of this signal causes an OFF-to-ACTIVE state transition of the device and a low level causes a transition back to the OFF state.

This input signal is level-sensitive and no debouncing is applied. The rising and/or falling edge of PWRHOLD is highlighted through an associated interrupt if interrupt is unmasked.

When AUTODEV_ON = 1, the pin is used as a GPI. As a GPI, this input can generate a maskable interrupt from a rising or falling edge of the input. When AUTODEV_ON = 1, a rising edge of NRESPWRON also automatically sets the DEV_ON bit to 1 to maintain supplies after the switch-on sequence, thus removing the need for the processor to set the PWRHOLD signal or the DEV_ON bit.

8.3.3.3 BOOT1

This signal determines with which processor the device is working and, hence, which power-up sequence is needed. For more details, see [Section 6](#). There is no debouncing on this input signal.

8.3.3.4 NRESPWRON, NRESPWRON2

The NRESPWRON signal is used as the reset to the processor and is in the VDDIO domain. It is held low until the ACTIVE state is reached. See [Section 6](#) to get detailed timing.

The NRESPWRON2 signal is a second reset output. It follows the state of NRESPWRON but has an open-drain output with external pullup. The supply for the external pullup must not be activated before the TPS65911 device is in control of the output state (that is, not earlier than during first power-up sequence slot). In off mode, the NRESPWRON2 output has weak internal pulldown.

8.3.3.5 CLK32KOUT

This signal is the output of the 32K oscillator, which can be enabled or not during the power-on sequence, depending on the boot mode. It can be enabled and disabled by register bit, during the ACTIVE state of the device. The CLK32KOUT output can also be enabled or not during the SLEEP state of the device depending on the programming of the SLEEPMASK register.

8.3.3.6 PWRON

The PWRON input is connected to an external button. If the device is in the OFF or SLEEP state, a debounced falling edge (PWRON input low for minimum of 100 ms) causes an OFF-to-ACTIVE state or a SLEEP-to-ACTIVE state transition of the device. If the device is in active mode, then a low level on this signal generates an interrupt. If the PWRON signal is low for more than the PWON_TO_OFF_DELAY delay and the corresponding interrupt is not acknowledged by the processor within 1 second, the device goes into the OFF state. See [Figure 7-1](#) and [Figure 7-2](#) for PWRON behaviour.

8.3.3.7 INT1

The INT1 signal (default active low) warns the host processor of any event that has occurred on the TPS65911 device. The host processor can then poll the interrupt from the interrupt status register through I²C to identify the interrupt source. A low level (default setting) indicates an active interrupt, highlighted in the INT_STS_REG register. The polarity of INT1 can be set programming the IT_POL control bit. INT1 flag active is a POWER ON enable condition during a fixed delay, t_{DOINT1} (only), when the device is in the OFF state (when NRESPWRON is low).

Any of the interrupt sources can be masked programming the INT_MSK_REG register. When an interrupt is masked its corresponding interrupt status bit is still updated, but the INT1 flag is not activated. Interrupt source masking can be used to mask a device switch-on event. Because interrupt flag active is a POWER ON enable condition, during t_{DOINT1} delay, any interrupt not masked must be cleared to allow immediate turn off of the device.

For a description of interrupt sources, see [Table 8-5](#).

8.3.3.8 EN2 and EN1

EN2 and EN1 are the data and clock signals of the serial control interface dedicated to voltage scaling applications.

These signals can also be programmed to be used as enable signals of one or several supplies, when the device is on (NRESPWRON high). A resource assigned to EN2 or EN1 control automatically disables the serial control interface.

Programming EN1_LDO_ASS_REG, EN2_LDO_REG, and SLEEP_KEEP_LDO_ON_REG registers: EN1 and EN2 signals can be used to control the turn on/off or SLEEP state of any LDO-type supplies.

Programming EN1_SMPS_ASS_REG, EN2_SMPS_ASS_REG, and SLEEP_KEEP_RES_ON registers: EN1 and EN2 signals can be used to control the turn on/off or LOW-POWER state (PFM mode) of SMPS-type supplies.

The EN2 and EN1 signals can be used to set the output voltage of VDD1 and VDD2 SMPS from a roof to a floor value, preprogrammed in the VDD1_OP_REG, VDD2_OP_REG and VDD1_SR_REG, VDD2_SR_REG registers.

When a supply is controlled through the EN1 or EN2 signals, its state is no longer driven by the device SLEEP state.

8.3.3.9 GPIO0–8

GPIO0, GPIO2, and GPIO6–7 can be programmed to be part of the power-up sequence and used as enable signals for external resources.

GPIO0 is a configurable I/O in the VCC7 domain. By default, its output is push-pull, driving low. GPIO0 can also be configured as an open-drain output with external pullup.

GPIO1 through GPIO8 are configurable open-drain digital I/Os in the VRTC domain. GPIO directivity, debouncing delay, and internal pullup can be programmed. By default, all are inputs with weak internal pulldown; as open-drain output an external pullup is required.

GPIO0–1 and GPIO3–5 can be used to turn on the device if the corresponding interrupt is not masked. When configured as an input, GPIO2 cannot be used to turn on the device, even if its associated interrupt is not masked. The GPIO interrupt is level sensitive. When an interrupt is detected, before clearing the interrupt, it should first be disabled by masking it.

GPIO1 and GPIO3, which have current sink capability of 10 mA, can also be used to drive LEDs connected to a 5-V supply.

GPIO2 can be used for synchronizing DCDCs to an external clock. Programming DCDCKEXT = 1, VDD1, VDD2, and VIO DCDC switching can be synchronized using a 3-MHz clock set though the GPIO2 pin. VDD1 and VDD2 will be in-phase and VIO will be phase shifted by 180 degrees.

It is recommended not to connect noisy switching signals to GPIO4 and GPIO5.

8.3.3.10 HDRST Input

HDRST is a cold reset input for the PMIC. High level at input forces the TPS65911 into off mode, causing a general reset of device to the default settings. The default state is defined by the register reset state and boot configuration. HDRST high level keeps the device in off mode. When reset is released and HDRST input goes low, the device automatically transitions to active mode. The device is kept in active mode for the period t_{DONIT1} , after which another power-on enable reason is needed to maintain the device on.

The HDRST input is in the VRTC domain and has a weak internal pulldown, which is active by default.

8.3.3.11 PWRDN

The PWRDN input is a reset input with selectable polarity (PWRDN_POL). High(low) level at input forces the TPS65911 device into off mode, causing a power-off reset. Off mode is maintained until PWRDN is released and a start-up reason like PWRON button press or DEV_ON = 1 is detected. An interrupt is generated to indicate the cause for shutdown. The PWRDN input is in the VRTC domain, but can tolerate a 5-V input.

8.3.3.12 Comparators: COMP1 and COMP2

The TPS65911 device has three comparators for system status detection/control. One comparator detects the voltage at pin VCC7. When $VCC7 > VMBHI$, the comparator initiates a NO SUPPLY-to-OFF transition and the VMBHI_IT interrupt is generated. When $VCC7 < VMBLO$, the comparator initiates an ACTIVE/SLEEP/OFF-to-BACKUP transition. When both VCC7 and backup battery are below VBPNR, the NO SUPPLY state is entered.

Comparators COMP1 and COMP2 detect the voltage of VCCS. Programmable comparator COMP1 is intended for detecting if battery voltage is high enough for an OFF-to-ACTIVE transition of the TPS65911 device. For an OFF-to-ACTIVE transition VCCS must be $> VMBCH$ (main battery charged) and a level below the comparator threshold prevents the power-up sequence. The threshold can be set from 2.5 to 3.5 V with 50-mV steps through VMBCH_SEL. The comparator has debouncing so that VCCS must stay above VMBDCH ($VMBCH - 0.1$ V) for a debouncing period of 61 μ s. The comparator can be bypassed if the threshold selection is set to 0. The default threshold is set in the boot configuration.

In a system with a multiple-cell battery, the battery level is sensed through an external resistor divider. The TPS65911 device has an internal buffer at the VCCS input, which must be used with the external resistive divider.

In a single-cell system, VCCS and VCC7 are connected directly to the battery. The VCCS input buffer can be bypassed to minimize power consumption. The buffer bypass is controlled with the VMBBUF_BYPASS bit in the boot configuration.

COMP2 is disabled by default and can be enabled by software. The comparator trigger generates an interrupt which is programmable on the rising (VMBCH2_H_IT) or falling edge (VMBCH2_L_IT), hence the comparator can be used for detecting high or low battery scenarios. COMP2 generates an interrupt for the host. In sleep mode, this creates a wake-up interrupt for the host. In off mode, the comparator trigger generates a turn-on event. In backup or no supply modes, the comparator is not active.

The COMP2 threshold can be set from 2.5 to 3.5 V with 50-mV steps. Enabling the comparator is done through the voltage threshold selection bit VMBDCH2_SEL, which is set to 0 by default.

8.3.3.13 Watchdog

The watchdog has two modes of operation.

In periodic operation an interrupt is generated with a regular period defined by the WTCHDG_TIME setting. The IC initiates WTCHDOG shutdown if the interrupt is not cleared within the period. The watchdog interrupt WTCHDOG counter is reinitialized when NRESPWRON is low.

In interrupt mode the IC initiates WTCHDOG counter when interrupt is set pending and is cleared when interrupt is cleared. If no interrupt is cleared before watchdog expiration within WTCHDG_TIME, the device goes to off mode.

By default, periodic watchdog functionality is enabled with the maximum WTCHDG_TIME period.

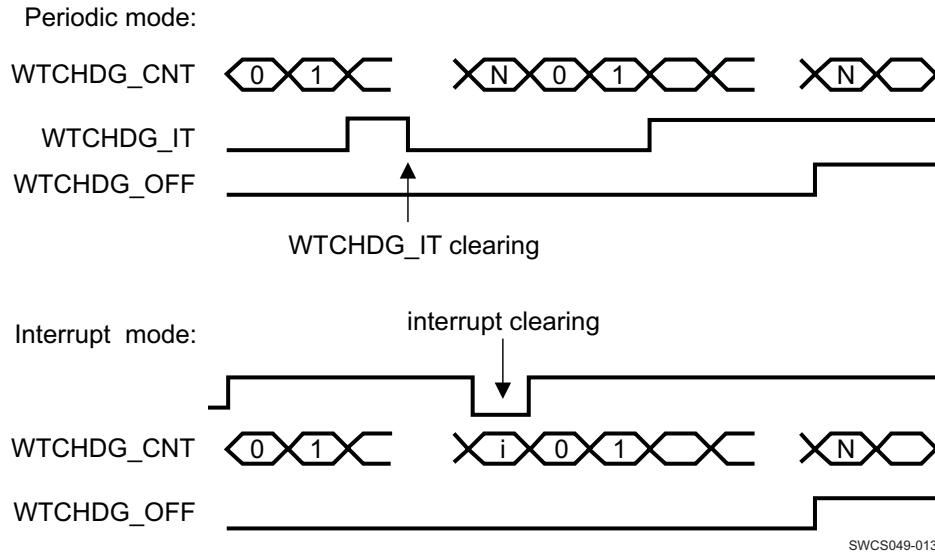


Figure 8-2. Watchdog Signals

8.3.3.14 Tracking LDO

LDO4 has an optional mode where its output level follows that of VDD1, from 0.6 to 1.5 V, when VDD1 is active. When VDD1 is set to off, the LDO4 output is defined by the SEL[7:2] bits in LDO4_REG, and can be set from 0.8 to 1.5 V.

Tracking mode is enabled by setting TRACK = 1 in DCDCCTRL_REG. In initial activation, VDD1 must be enabled and allowed to settle before enabling tracking mode. After initial activation, tracking mode can be kept enabled while VDD1 is turned off. The value of TRACK is set to default (0) after any turnoff event.

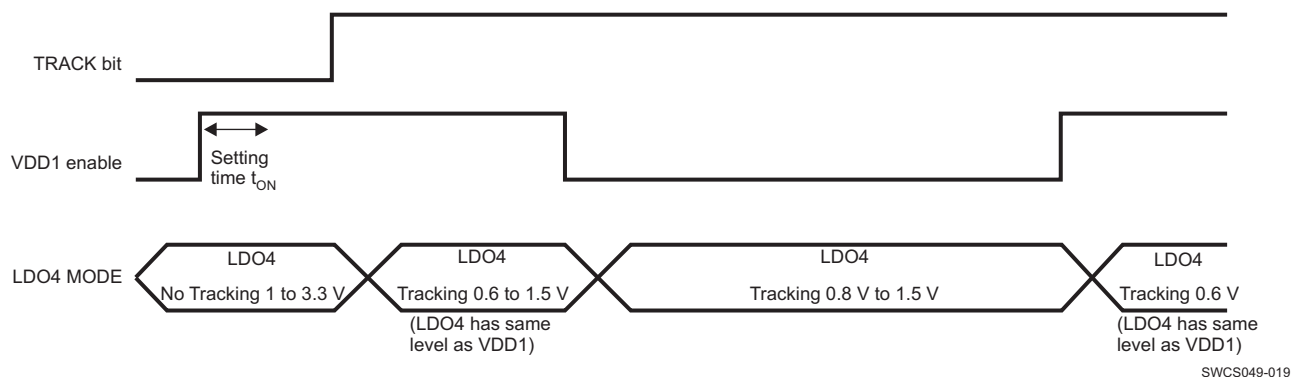


Figure 8-3. Tracking LDO

8.4 PWM And LED Generators

The TPS65911 device has two LED ON/OFF signal generators, LED1 and LED2. LED1 and LED2 have independently controllable periods from 125 ms to 8 s and ON time from 62.5 to 500 ms. Within the period, one or two ON pulses can be generated (control bit LED1(2)_SEQ). The user must take care to program period and ON time correctly, because no limitation on selected values is imposed. LED1 and LED2 signals can be routed to GPIO1 and GPIO3 open-drain outputs, respectively. These GPIOs have a current sink capability of 10 mA.

The PWM generator frequency and duty cycle are set by the PWM_FREQ and PWM_DUTY_CYCLE bits, respectively. The PWM generator signal can be connected to the GPIO3 or GPIO8 output. The PWM generator uses the 3-MHz clock, which is not available in off mode. To enable the PWM in sleep mode, the I2CHS_KEEPON bit must be set to 1.

8.5 Dynamic Voltage Frequency Scaling And Adaptive Voltage Scaling Operation

Dynamic voltage frequency scaling (DVFS) operation: A supply voltage value corresponding to a targeted frequency of the digital core supplied is programmed in VDD1_OP_REG or VDD2_OP_REG registers.

The slew rate of the voltage supply reaching a new VDD1_OP_REG or VDD2_OP_REG programmed value is limited to 12.5 mV/μs, fixed value.

Adaptive voltage scaling (AVS) operation: A supply voltage value corresponding to a supply voltage adjustment is programmed in VDD1_SR_REG or VDD2_SR_REG registers. The supply voltage is then intended to be tuned by the digital core supplied, based its performance self-evaluation. The slew rate of VDD1 or VDD2 voltage supply reaching a new programmed value is programmable through the VDD1_REG or VDD2_REG register, respectively.

A serial control interface (optional mode for EN1 and EN2 pins) can be dedicated to voltage scaling applications, to give dedicated access to the VDD1_OP_REG, VDD1_SR_REG and VDD2_OP_REG, VDD2_SR_REG registers.

A general-purpose serial control interface (CTL-I²C) also gives access to these registers, if the SR_CTL_I2C_SEL control bit is set to 1 in the DEVCTRL_REG register (default inactive).

Both control interfaces are compliant with HS-I²C specification (100 Kbps, 400 Kbps, or 3.4 Mbps).

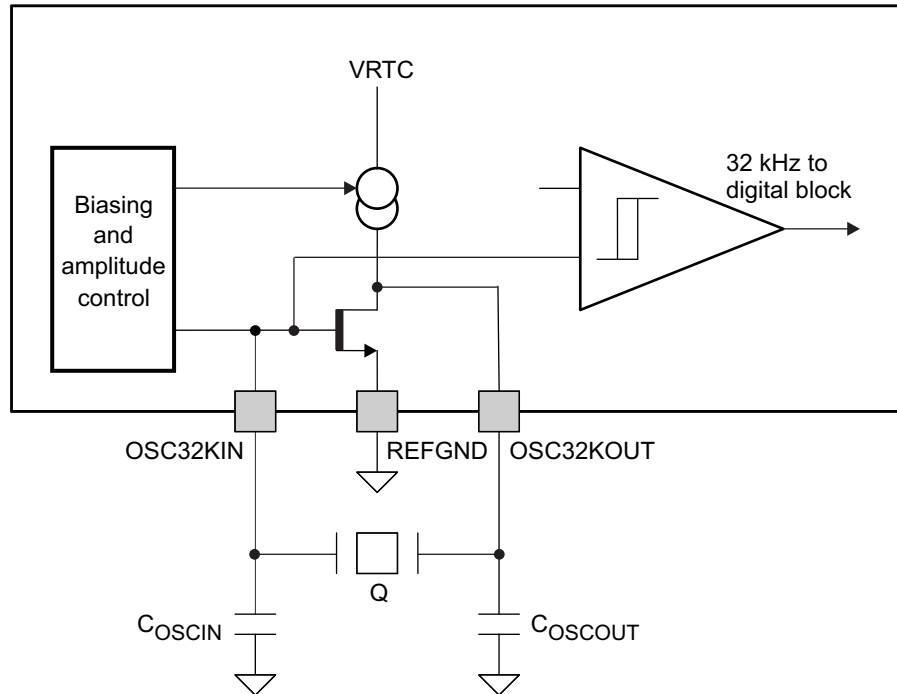
8.6 32-kHz RTC Clock

The TPS65911 device can provide a 32-kHz clock to the platform through the CLK32KOUT output, when a crystal is connected.

Alternatively, the device can accept a square-wave 32-kHz clock signal applied to OSC32IN input (OSC32KOUT kept floating) and gate the clock to CLK32OUT. This clock must be present for any state of the EPC except the NO SUPPLY state. The TPS65911 device also has an internal 32-kHz RC oscillator, to reduce the BOM, if an accurate clock is not needed by the system.

Default selection of a 32-kHz RC oscillator versus 32-kHz crystal oscillator or external square-wave 32-kHz clock depends on the boot configuration setting for the CK32K_CTRL bit.

Switching from the 32-kHz RC oscillator to the 32-kHz crystal oscillator or external square-wave 32-kHz clock can also be programmed through the DEVCTRL_REG register.



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Figure 8-4. Crystal Oscillator 32-kHz Clock

8.7 Real-Time Clock (RTC)

The RTC, which is driven by the 32-kHz clock, provides the alarm and timekeeping functions. The RTC is kept supplied when the device is in the OFF or the BACKUP state.

The main functions of the RTC block are:

- Time information (seconds/minutes/hours) directly in binary-coded decimal (BCD) format
- Calendar information (Day/Month/Year/Day of the week) directly in BCD code up to year 2099
- Programmable interrupts generation: The RTC can generate two interrupts: a timer interrupt RTC_PERIOD_IT periodically (1s/1m/1h/1d period) and an alarm interrupt RTC_ALARM_IT at a precise time of the day (alarm function). These interrupts are enabled using IT_ALARM and IT_TIMER control bits. Periodically interrupts can be masked during the SLEEP period to avoid host interruption and are automatically unmasked after SLEEP wakeup (using the IT_SLEEP_MASK_EN control bit).
- Oscillator frequency calibration and time correction

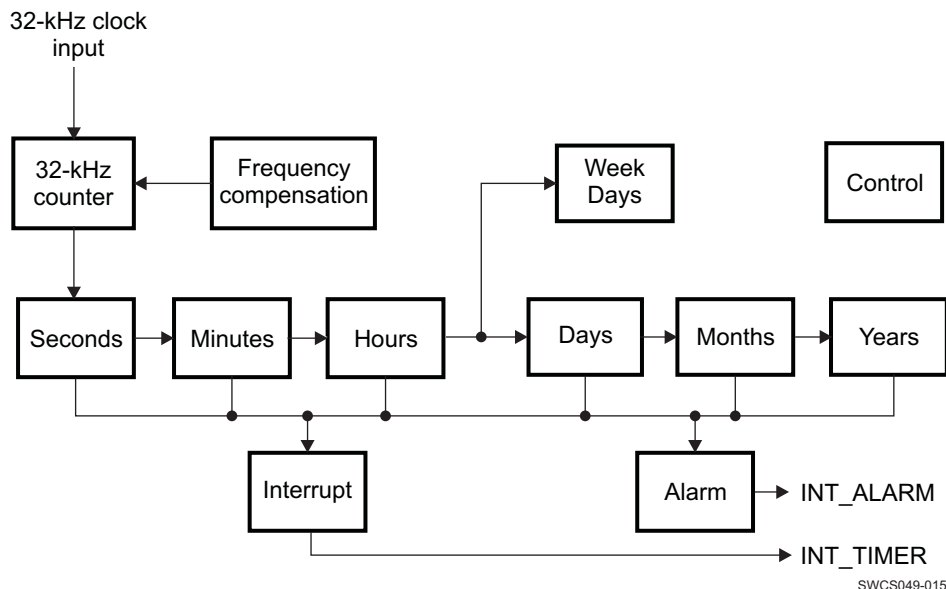


Figure 8-5. RTC Digital Section Block Diagram

8.7.1 Time Calendar Registers

All the time and calendar information is available in these dedicated registers, called TC registers. Values of the TC registers are written in BCD format.

- Years data ranges from 00 to 99
 - Leap year = Year divisible by four (2000, 2004, 2008, 2012...)
 - Common year = other years
- Months data ranges from 01 to 12
- Days value ranges from:
 - 1 to 31 when months are 1, 3, 5, 7, 8, 10, 12
 - 1 to 30 when months are 4, 6, 9, 11
 - 1 to 29 when month is 2 and year is a leap year
 - 1 to 28 when month is 2 and year is a common year
- Weeks value ranges from 0 to 6
- Hours value ranges from 00 to 23 in 24-hour mode and ranges from 1 to 12 in AM/PM mode
- Minutes value ranges from 0 to 59
- Seconds value ranges from 0 to 59

To modify the current time, software writes the new time into TC registers to fix the time/calendar information. The processor can write into the TC registers without stopping the RTC. In addition, software can stop the RTC by clearing the STOP_RTC bit of the control register and check the RUN bit of the status to be sure that the RTC is frozen, then update the TC values, and then restart the RTC by setting STOP_RTC bit.

Example: Time is 10H54M36S PM (PM_AM mode set), 2008 September 5, previous register values are:

Table 8-4. Real-Time Clock Registers Example

Register	Value
SECONDS_REG	0x36
MINUTES_REG	0x54
HOURS_REG	0x90

**Table 8-4. Real-Time Clock Registers
Example (continued)**

Register	Value
DAYS_REG	0x05
MONTHS_REG	0x09
YEARS_REG	0x08

The user can round to the closest minute, by setting the ROUND_30S register bit. TC values are set to the closest minute value at the next second. The ROUND_30S bit is automatically cleared when the rounding time is performed.

Example:

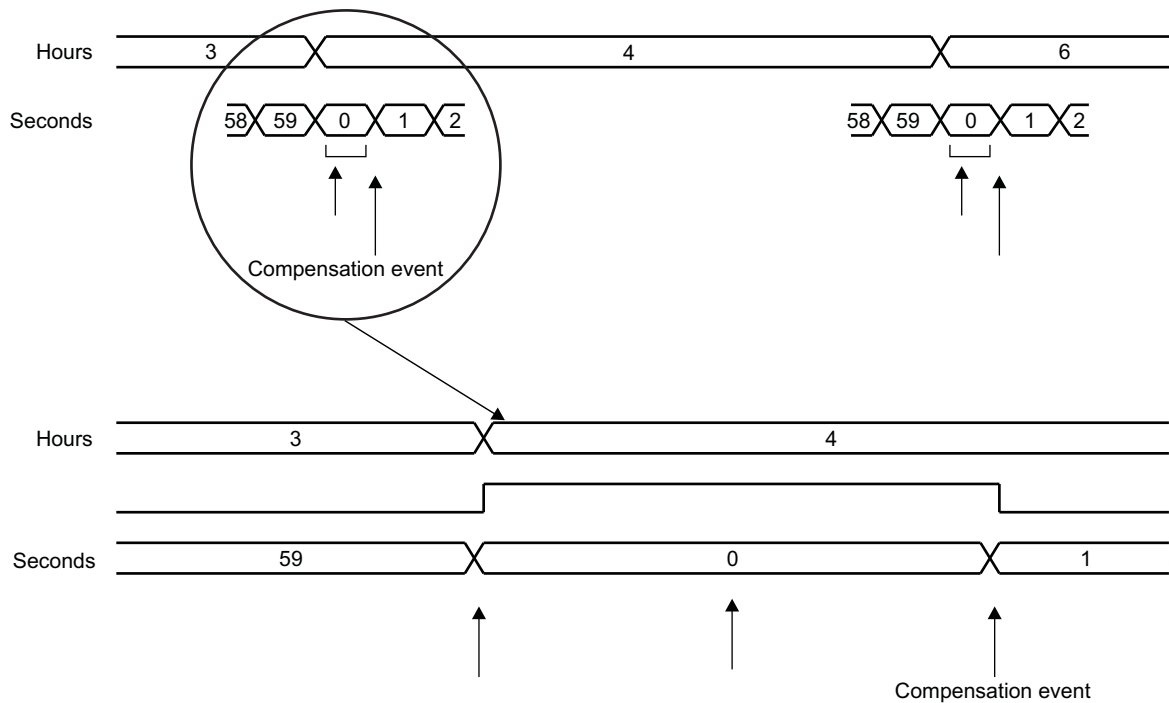
- If current time is 10H59M45S, a round operation changes time to 11H00M00S.
- if current time is 10H59M29S, a round operation changes time to 10H59M00S.

8.7.2 General Registers

Software can access the RTC_STATUS_REG and RTC_CTRL_REG registers at any time (except for the RTC_CTRL_REG[5] bit, which must be changed only when the RTC is stopped).

8.7.3 Compensation Registers

The RTC_COMP_MSB_REG and RTC_COMP_LSB_REG registers must respect the available access period. These registers must be updated before each compensation process. For example, software can load the compensation value into these registers after each hour event, during an available access period.



SWCS046-016

Figure 8-6. RTC Compensation Scheduling

This drift can be balanced to compensate for any inaccuracy of the 32-kHz oscillator. Software must calibrate the oscillator frequency, calculate the drift compensation versus 1-hour time period; and then load the compensation registers with the drift compensation value. Indeed, if the AUTO_COMP_EN bit in the RTC_CTRL_REG is enabled, the value of COMP_REG (in twos-complement) is added to the RTC 32-kHz counter at each hour and 1 second. When COMP_REG is added to the RTC 32-kHz counter, the duration of the current second becomes $(32768 - \text{COMP_REG})/32768\text{s}$; so, the RTC can be compensated with a 1/32768 s/hour time unit accuracy.

NOTE

The compensation is considered once written into the registers.

8.8 Backup Battery Management

The device includes a back-up battery switch connecting the VRTC regulator input to a main battery (VCC7) or to a back-up battery (VBACKUP), depending on the voltage value of the battery.

The VRTC supply can then be maintained during a BACKUP state as long as the input voltage is high enough ($> \text{VBNPR}$ threshold). Below the VBNPR voltage threshold, the digital core of the device is set under reset by internal signal POR (PowerOnReset).

The back-up domain functions which are always supplied from VRTC are:

- The internal 32-kHz oscillator
- Back-up registers

The back-up battery can be charged from the main battery through an embedded charger. The back-up battery charge voltage and enable is controlled through BBCH_REG register programming. This register content is maintained during the device BACKUP state.

Hence, when enabled, the back-up battery charge is maintained as long as the main battery voltage is higher than the VMBLO threshold and the back-up battery voltage.

8.9 Backup Registers

As part of the RTC, the device contains five 8-bit registers that can be used for storage by the application firmware when the external host is powered down. These registers retain their content as long as the VRTC is active.

8.10 I²C Interface

A general-purpose serial control interface (CTL-I²C) allows read and write access to the configuration registers of all resources of the system.

A second serial control interface (optional mode for EN1 and EN2 pins) can be dedicated to DVFS.

Both control interfaces are compliant with the HS-I²C specification.

These interfaces support the standard slave mode (100 Kbps), fast mode (400 Kbps), and high-speed mode (3.4 Mbps). The general-purpose I²C module using one slave hard-coded address (ID1 = 2Dh). The voltage scaling dedicated I²C module uses one slave hard-coded address (ID0 = 12h). The master mode is not supported.

Addressing:

The device supports seven-bit mode addressing.

It does not support the following features:

- 10-bit addressing
- General call

8.10.1 Access Protocols

or compatibility, the I2C interfaces in the TPS65911x device use the same read/write protocol as other TI power ICs, based on an internal register size of 8 bits. Supported transactions are described below.

8.10.1.1 Single Byte Access

A write access is initiated by a first byte including the address of the device (7 MSBs) and a write command (LSB), a second byte provides the address (8 bits) of the internal register, and the third byte represents the data to be written in the internal register, see [Figure 8-7](#).

A read access is initiated by:

- A first byte, including the address of the device (7 MSBs) and a write command (LSB)
- A second byte, providing the address (8 bits) of the internal register
- A third byte, including again the device address (7 MSBs) and the read command (LSB)

The device replies by sending

- A fourth byte, representing the content of the internal register (see [Figure 8-8](#))

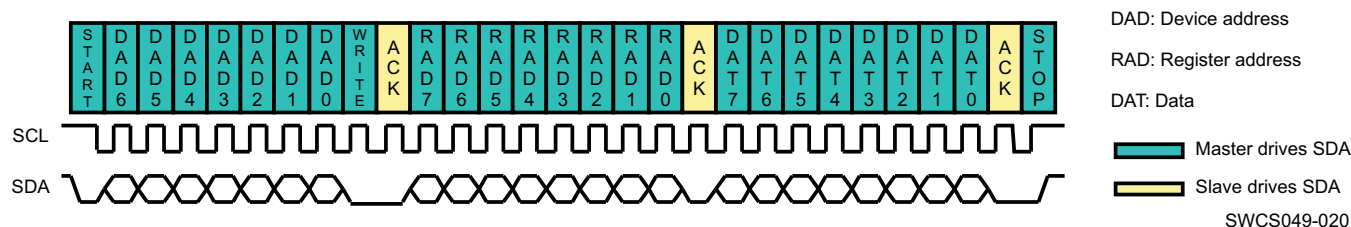


Figure 8-7. I²C Write Access Single Byte

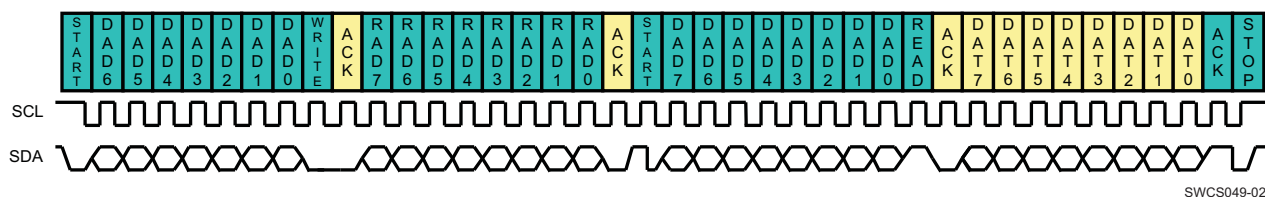


Figure 8-8. I²C Read Access Single Byte

8.10.1.2 Multiple Byte Access To Several Adjacent Registers

A write access is initiated by:

- A first byte, including the address of the device (7 MSBs) and a write command (LSB)
- A second byte, providing the base address (8 bits) of the internal registers

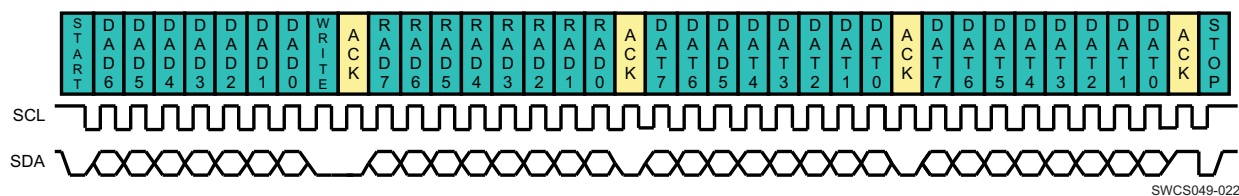
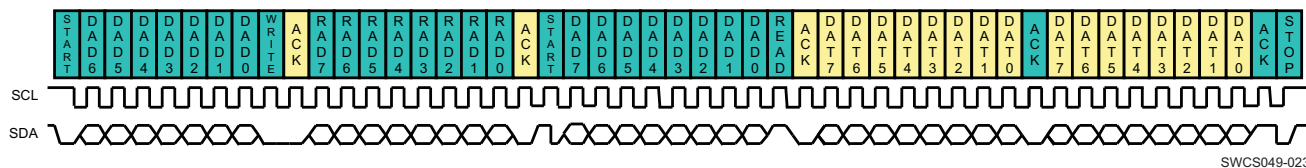
The following N bytes represent the data to be written in the internal register starting at the base address and incremented by one at each data byte (see [Figure 8-9](#)).

A read access is initiated by:

- A first byte, including the address of the device (7 MSBs) and a write command (LSB)
- A second byte, providing the base address (8 bits) of the internal register
- A third byte, including again the device address (7 MSBs) and the read command (LSB)

The device replies by sending:

- A fourth byte, representing the content of the internal registers, starting at the base address and next consecutive ones (see [Figure 8-10](#)).

Figure 8-9. I²C Write Access Multiple BytesFigure 8-10. I²C Read Access Multiple Bytes

8.11 Thermal Monitoring And Shutdown

A thermal protection module monitors the junction temperature of the device versus two thresholds:

- Hot-die temperature threshold
- Thermal shutdown temperature threshold

When the hot-die temperature threshold is reached, an interrupt is sent to software to close the noncritical running tasks.

When the thermal shutdown temperature threshold is reached, the TPS65911 device is set under reset and a transition to OFF state is initiated. Then the POWER ON enable conditions of the device are not considered until the die temperature has decreased below the hot-die threshold. Hysteresis is applied to the hot-die and shutdown thresholds, when detecting a falling edge of temperature, and both detections are debounced to avoid any parasitic detection.

The TPS65911 device allows programming of four hot-die temperature thresholds to increase the flexibility of the system.

By default, the thermal protection is enabled in ACTIVE state, but can be disabled through programming the THERM_REG register. The thermal protection can be enabled in SLEEP state programming the SLEEP_KEEP_RES_ON register. The thermal protection is automatically enabled during an OFF-to-ACTIVE state transition and is kept enabled in OFF state after a switch-off sequence caused by a thermal shutdown event. Transition to OFF state sequence caused by a thermal shutdown event is highlighted in the INT_STS_REG status register. Recovery from this OFF state is initiated (switch-on sequence) when the die temperature falls below the hot-die temperature threshold.

Hot-die and thermal shutdown temperature threshold detection states can be monitored or masked by reading or programming the THERM_REG register. The hot-die interrupt can be masked by programming the INT_MSK_REG register.

8.12 Interrupts

Table 8-5. Interrupt Sources

Interrupt	Description
RTC_ALARM_IT	RTC alarm event: Occurs at programmed determinate date and time (running in ACTIVE, OFF, and SLEEP state, default inactive)
RTC_PERIOD_IT	RTC periodic event: Occurs at programmed regular period of time (every second or minute) (running in ACTIVE, OFF, and SLEEP state, default inactive)

Table 8-5. Interrupt Sources (continued)

Interrupt	Description
HOT_DIE_IT	The embedded thermal monitoring module has detected a die temperature above the hot-die detection threshold (running in ACTIVE and SLEEP state). Level sensitive interrupt.
PWRHOLD_R_IT	PWRHOLD signal rising edge
PWRHOLD_F_IT	PWRHOLD signal falling-edge
PWRON_LP_IT	PWRON is low during more than the long-press delay: PWON_TO_OFF_DELAY (can be disable though register programming).
PWRON_IT	PWRON is low while the device is on (running in ACTIVE and SLEEP state). Level-sensitive interrupt.
VMBHI_IT	The battery voltage rise above the VMBHI threshold: NO SUPPLY-to-OFF or BACKUP-to-OFF device states transition (first battery plug or battery voltage bounce detection)
VMBDCH_IT	The battery voltage fall down below the VMBDCH threshold: the minimum operating voltage of power supplies.
GPIO0_R_IT	GPIO_CKSYNC rising-edge detection
GPIO0_F_IT	GPIO_CKSYNC falling-edge detection
VMBCH2_H_IT	Comparator 2 input above threshold detection
VMBCH2_L_IT	Comparator 2 input below threshold detection
GPIO1_R_IT	GPIO1 rising-edge detection
GPIO1_F_IT	GPIO1 falling-edge detection
GPIO2_R_IT	GPIO2 rising-edge detection
GPIO2_F_IT	GPIO2 falling-edge detection
GPIO3_R_IT	GPIO3 rising-edge detection
GPIO3_F_IT	GPIO3 falling-edge detection
GPIO4_R_IT	GPIO4 rising-edge detection
GPIO4_F_IT	GPIO4 falling-edge detection
GPIO5_R_IT	GPIO5 rising-edge detection
GPIO5_F_IT	GPIO5 falling-edge detection
WTCHDG_IT	Watchdog interrupt
PWRDN_IT	PWRDN reset interrupt

9 Package Description

The following table has the package descriptions of the TPS65911 PMU devices:

Package	TPS65911
Type	ZRC98 BGA Microstar Junior
Size (mm)	6x9
Substrate layers	1 layer
Pitch ball array (mm)	0.65 mm
Number of balls	98
Thickness (mm) (max. height including balls)	1

10 PCB Layout

The package ballout of the TPS65911 supports the use of inexpensive 4-layer, non-HID board technology. [Figure 10-1](#) shows an example layout.

Regardless of the chosen board technology, special care must be taken when designing the board layout for the TPS65911 to ensure performance. For detailed guidelines, see *TPS65911 Layout Guidelines*, TI Literature number SWCU080.

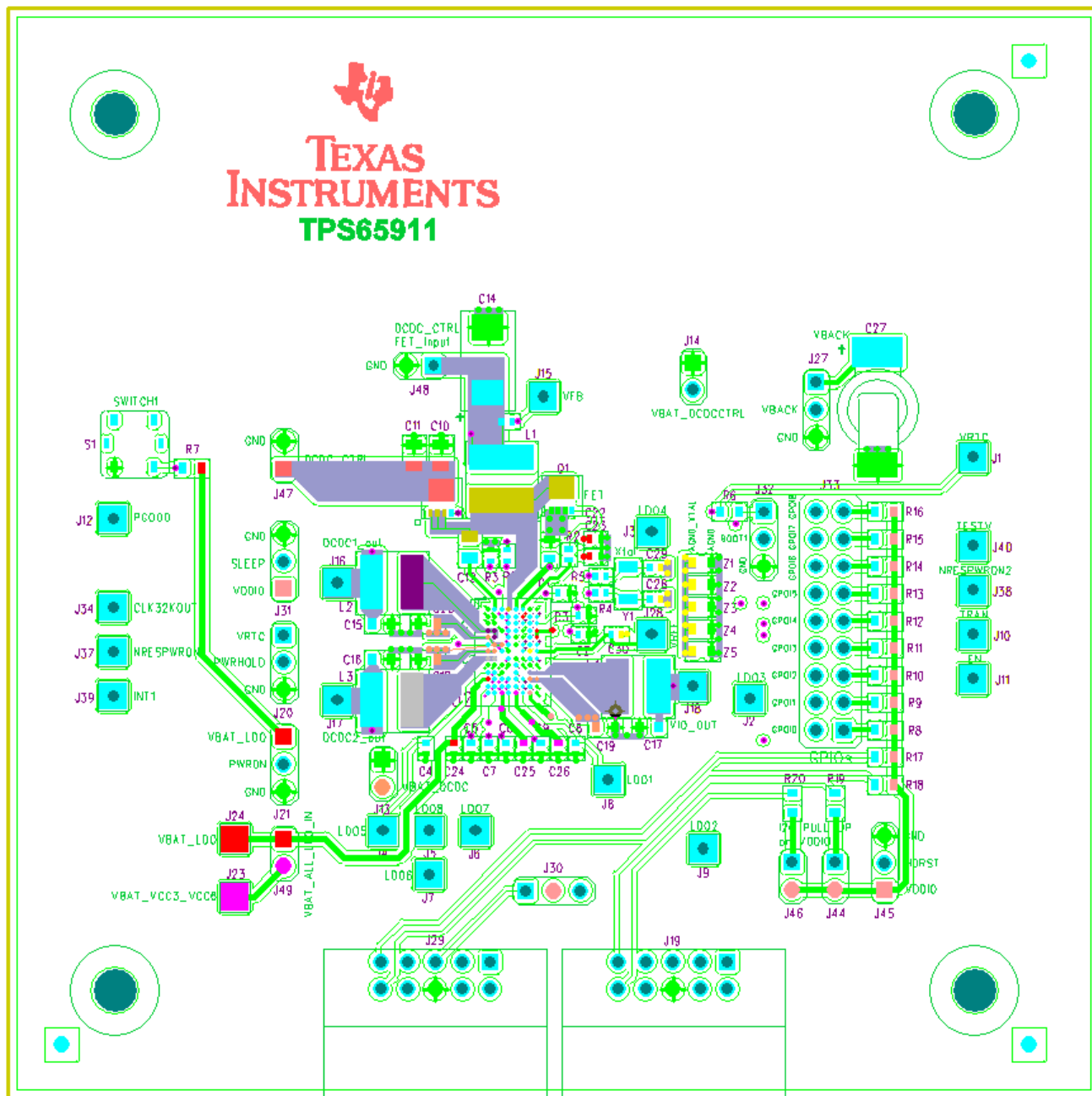


Figure 10-1. TPS65911 EVM Top Copper with Component Placement

11 Appendix A: Functional Registers

The possible device reset domains are:

- Full reset: All digital logic of device is reset.
 - Caused by POR (power on reset) when VCC7 < VBNPR and BB < VBNPR
- General reset: No impact on RTC, backup registers or interrupt status.
 - Caused by PWON_LP_RST bit set high or
 - DEV_OFF_RST bit set high or
 - HDRST input set high
- Turnoff OFF: Power reinitialization in off/backup mode.

In following register description, reset domain for each register is defined at the register table heading.

Note: DCDCCTRL_REG and DEVCTRL2_REG have bits in two reset domains.

Note 2: Comment “Default value: See boot configuration” indicates that bit default value is set in boot configuration and not by register Reset value .”

11.1 TPS65911_FUNC_REG Registers Mapping Summary

Table 11-1. TPS65911_FUNC_REG Register Summary⁽¹⁾

Register Name	Type	Register Width (Bits)	Register Reset	Address Offset
SECONDS_REG	RW	8	0x00	0x00
MINUTES_REG	RW	8	0x00	0x01
HOURS_REG	RW	8	0x00	0x02
DAYS_REG	RW	8	0x01	0x03
MONTHS_REG	RW	8	0x01	0x04
YEARS_REG	RW	8	0x00	0x05
WEEKS_REG	RW	8	0x00	0x06
ALARM_SECONDS_REG	RW	8	0x00	0x08
ALARM_MINUTES_REG	RW	8	0x00	0x09
ALARM_HOURS_REG	RW	8	0x00	0x0A
ALARM_DAYS_REG	RW	8	0x01	0x0B
ALARM_MONTHS_REG	RW	8	0x01	0x0C
ALARM_YEARS_REG	RW	8	0x00	0x0D
RTC_CTRL_REG	RW	8	0x00	0x10
RTC_STATUS_REG	RW	8	0x80	0x11
RTC_INTERRUPTS_REG	RW	8	0x00	0x12
RTC_COMP_LSB_REG	RW	8	0x00	0x13
RTC_COMP_MSB_REG	RW	8	0x00	0x14
RTC_RES_PROG_REG	RW	8	0x27	0x15
RTC_RESET_STATUS_REG	RW	8	0x00	0x16
BCK1_REG	RW	8	0x00	0x17
BCK2_REG	RW	8	0x00	0x18
BCK3_REG	RW	8	0x00	0x19
BCK4_REG	RW	8	0x00	0x1A
BCK5_REG	RW	8	0x00	0x1B
PUADEN_REG	RW	8	0x1F	0x1C
REF_REG	RO	8	0x01	0x1D
VRTC_REG	RW	8	0x01	0x1E
VIO_REG	RW	8	0x05	0x20
VDD1_REG	RW	8	0x0D	0x21
VDD1_OP_REG	RW	8	0x33	0x22
VDD1_SR_REG	RW	8	0x33	0x23
VDD2_REG	RW	8	0x0D	0x24
VDD2_OP_REG	RW	8	0x4B	0x25
VDD2_SR_REG	RW	8	0x4B	0x26
VDDCTRL_REG	RW	8	0x00	0x27
VDDCTRL_OP_REG	RW	8	0x03	0x28
VDDCTRL_SR_REG	RW	8	0x03	0x29
LDO1_REG	RW	8	0x15	0x30
LDO2_REG	RW	8	0x15	0x31
LDO5_REG	RW	8	0x00	0x32
LDO8_REG	RW	8	0x09	0x33
LDO7_REG	RW	8	0x0D	0x34
LDO6_REG	RW	8	0x21	0x35

(1) Register reset values are for fixed boot mode.

Table 11-1. TPS65911_FUNC_REG Register Summary⁽¹⁾ (continued)

LDO4_REG	RW	8	0x00	0x36
LD03_REG	RW	8	0x00	0x37
THERM_REG	RW	8	0x0D	0x38
BBCH_REG	RW	8	0x00	0x39
DCDCCTRL_REG	RW	8	0x39	0x3E
DEVCTRL_REG	RW	8	0x0000 0014	0x3F
DEVCTRL2_REG	RW	8	0x0000 0036	0x40
SLEEP_KEEP_LDO_ON_REG	RW	8	0x00	0x41
SLEEP_KEEP_RES_ON_REG	RW	8	0x00	0x42
SLEEP_SET_LDO_OFF_REG	RW	8	0x00	0x43
SLEEP_SET_RES_OFF_REG	RW	8	0x00	0x44
EN1_LDO_ASS_REG	RW	8	0x00	0x45
EN1_SMPS_ASS_REG	RW	8	0x00	0x46
EN2_LDO_ASS_REG	RW	8	0x00	0x47
EN2_SMPS_ASS_REG	RW	8	0x00	0x48
INT_STS_REG	RW	8	0x06	0x50
INT_MSK_REG	RW	8	0xFF	0x51
INT_STS2_REG	RW	8	0xA8	0x52
INT_MSK2_REG	RW	8	0xFF	0x53
INT_STS3_REG	RW	8	0x5A	0x54
INT_MSK3_REG	RW	8	0xFF	0x55
GPIO0_REG	RW	8	0x07	0x60
GPIO1_REG	RW	8	0x08	0x61
GPIO2_REG	RW	8	0x08	0x62
GPIO3_REG	RW	8	0x08	0x63
GPIO4_REG	RW	8	0x08	0x64
GPIO5_REG	RW	8	0x08	0x65
GPIO6_REG	RW	8	0x05	0x66
GPIO7_REG	RW	8	0x05	0x67
GPIO8_REG	RW	8	0x08	0x68
WATCHDOG_REG	RW	8	0x07	0x69
VMCH_REG	RW	8	0x1E	0x6A
VMCH2_REG	RW	8	0x00	0x6B
LED_CTRL1_REG	RW	8	0x00	0x6C
LED_CTRL2_REG1	RW	8	0x00	0x6D
PWM_CTRL1_REG	RW	8	0x00	0x6E
PWM_CTRL2_REG	RW	8	0x00	0x6F
SPARE_REG	RW	8	0x00	0x70
VERNUM_REG	RO	8	0x00	0x80

11.2 TPS65911_FUNC_REG Register Descriptions

Table 11-2. SECONDS_REG

Address Offset		0x00		Instance		(RESET DOMAIN: FULL RESET)	
Physical Address							
Description		RTC register for seconds					
Type		RW					
7	6	5	4	3	2	1	0
Reserved	SEC1			SEC0			
Bits	Field Name	Description				Type	Reset
7	Reserved	Reserved bit				RO R returns 0s	0
6:4	SEC1	Second digit of seconds (range is 0 up to 5)				RW	0x0
3:0	SEC0	First digit of seconds (range is 0 up to 9)				RW	0x0

Table 11-3. MINUTES_REG

Address Offset		0x01		Instance		(RESET DOMAIN: FULL RESET)									
Physical Address															
Description		RTC register for minutes													
Type		RW													
7		6		5		4		3		2		1		0	
Reserved				MIN1						MIN0					
Bits		Field Name		Description						Type		Reset			
7		Reserved		Reserved bit						RO R returns 0s		0			
6:4		MIN1		Second digit of minutes (range is 0 up to 5)						RW		0x0			
3:0		MIN0		First digit of minutes (range is 0 up to 9)						RW		0x0			

Table 11-4. HOURS_REG

Address Offset		0x02		Instance		(RESET DOMAIN: FULL RESET)	
Physical Address							
Description		RTC register for hours					
Type		RW					
7	6	5	4	3	2	1	0
PM_NAM	Reserved	HOUR1		HOUR0			

Bits	Field Name	Description	Type	Reset
7	PM_NAM	Only used in PM_AM mode (otherwise it is set to 0) 0 is AM 1 is PM	RW	0
6	Reserved	Reserved bit	RO R returns 0s	0
5:4	HOUR1	Second digit of hours(range is 0 up to 2)	RW	0x0
3:0	HOUR0	First digit of hours (range is 0 up to 9)	RW	0x0

Table 11-5. DAYS_REG

Address Offset	0x03							
Physical Address					Instance	(RESET DOMAIN: FULL RESET)		
Description	RTC register for days							
Type	RW							
7	6	5	4	3	2	1	0	
Reserved		DAY1			DAY0			

Bits	Field Name	Description	Type	Reset
7:6	Reserved	Reserved bit	RO R returns 0s	0x0
5:4	DAY1	Second digit of days (range is 0 up to 3)	RW	0x0
3:0	DAY0	First digit of days (range is 0 up to 9)	RW	0x1

Table 11-6. MONTHS_REG

Address Offset	0x04							
Physical Address				Instance	(RESET DOMAIN: FULL RESET)			
Description	RTC register for months							
Type	RW							
	7	6	5	4	3	2	1	0
	Reserved			MONTH1	MONTH0			

Bits	Field Name	Description	Type	Reset
7:5	Reserved	Reserved bit	RO R returns 0s	0x0
4	MONTH1	Second digit of months (range is 0 up to 1)	RW	0
3:0	MONTH0	First digit of months (range is 0 up to 9)	RW	0x1

Table 11-7. YEARS_REG

Address Offset	0x05							
Physical Address					Instance	(RESET DOMAIN: FULL RESET)		
Description	RTC register for day of the week							
Type	RW							
	7	6	5	4	3	2	1	0
	YEAR1				YEAR0			

Bits	Field Name	Description	Type	Reset
7:4	YEAR1	Second digit of years (range is 0 up to 9)	RW	0x0
3:0	YEAR0	First digit of years (range is 0 up to 9)	RW	0x0

Table 11-8. WEEKS_REG

Address Offset	0x06								
Physical Address		Instance	(RESET DOMAIN: FULL RESET)						
Description	RTC register for day of the week								
Type	RW								

7	6	5	4	3	2	1	0
Reserved					WEEK		

Bits	Field Name	Description	Type	Reset
7:3	Reserved	Reserved bit	RO R returns 0s	0x00
2:0	WEEK	First digit of day of the week (range is 0 up to 6)	RW	0

Table 11-9. ALARM_SECONDS_REG

Address Offset		0x08					
Physical Address				Instance		(RESET DOMAIN: FULL RESET)	
Description		RTC register for alarm programming for seconds					
Type		RW					
7	6	5	4	3	2	1	0
Reserved		ALARM_SEC1			ALARM_SEC0		

Bits	Field Name	Description	Type	Reset
7	Reserved	Reserved bit	RO R returns 0s	0
6:4	ALARM_SEC1	Second digit of alarm programming for seconds (range is 0 up to 5)	RW	0x0
3:0	ALARM_SEC0	First digit of alarm programming for seconds (range is 0 up to 9)	RW	0x0

Table 11-10. ALARM_MINUTES_REG

Address Offset		0x09		Instance		(RESET DOMAIN: FULL RESET)									
Physical Address															
Description		RTC register for alarm programming for minutes													
Type		RW													
7		6		5		4		3		2		1		0	
Reserved				ALARM_MIN1				ALARM_MIN0							

Bits	Field Name	Description	Type	Reset
7	Reserved	Reserved bit	RO R returns 0s	0
6:4	ALARM_MIN1	Second digit of alarm programming for minutes (range is 0 up to 5)	RW	0x0
3:0	ALARM_MIN0	First digit of alarm programming for minutes (range is 0 up to 9)	RW	0x0

Table 11-11. ALARM_HOURS_REG

Address Offset		0x0A		Instance		(RESET DOMAIN: FULL RESET)	
Physical Address							
Description		RTC register for alarm programming for hours					
Type		RW					
7	6	5	4	3	2	1	0
ALARM_PM_N AM	Reserved	ALARM_HOUR1		ALARM_HOUR0			

Bits	Field Name	Description	Type	Reset
7	ALARM_PM_NAM	Only used in PM_AM mode for alarm programming (otherwise it is set to 0) 0 is AM 1 is PM	RW	0
6	Reserved	Reserved bit	RO R returns 0s	0
5:4	ALARM_HOUR1	Second digit of alarm programming for hours (range is 0 up to 2)	RW	0x0
3:0	ALARM_HOUR0	First digit of alarm programming for hours (range is 0 up to 9)	RW	0x0

Table 11-12. ALARM_DAYS_REG

Address Offset	0x0B						
Physical Address	Instance (RESET DOMAIN: FULL RESET)						
Description	RTC register for alarm programming for days						
Type	RW						
7	6	5	4	3	2	1	0
Reserved		ALARM_DAY1		ALARM_DAY0			

Bits	Field Name	Description	Type	Reset
7:6	Reserved	Reserved bit	RO R Special	0x0
5:4	ALARM_DAY1	Second digit of alarm programming for days (range is 0 up to 3)	RW	0x0
3:0	ALARM_DAY0	First digit of alarm programming for days (range is 0 up to 9)	RW	0x1

Table 11-13. ALARM_MONTHS_REG

Address Offset	0x0C						
Physical Address	Instance (RESET DOMAIN: FULL RESET)						
Description	RTC register for alarm programming for months						
Type	RW						
7	6	5	4	3	2	1	0
Reserved			ALARM_MONT H1	ALARM_MONTH0			

Bits	Field Name	Description	Type	Reset
7:5	Reserved	Reserved bit	RO R returns 0s	0x0
4	ALARM_MONTH1	Second digit of alarm programming for months (range is 0 up to 1)	RW	0
3:0	ALARM_MONTH0	First digit of alarm programming for months (range is 0 up to 9)	RW	0x1

Table 11-14. ALARM_YEARS_REG

Address Offset	0x0D						
Physical Address	Instance (RESET DOMAIN: FULL RESET)						
Description	RTC register for alarm programming for years						
Type	RW						

7	6	5	4	3	2	1	0
ALARM_YEAR1				ALARM_YEAR0			

Bits	Field Name	Description	Type	Reset
7:4	ALARM_YEAR1	Second digit of alarm programming for years (range is 0 up to 9)	RW	0x0
3:0	ALARM_YEAR0	First digit of alarm programming for years (range is 0 up to 9)	RW	0x0

Table 11-15. RTC_CTRL_REG

Address Offset		0x10						
Physical Address		Instance (RESET DOMAIN: FULL RESET)						
Description		RTC control register: NOTES: A dummy read of this register is necessary before each I ² C read in order to update the ROUND_30S bit value.						
Type		RW						
7		6	5	4	3	2	1	0
RTC_V_OPT	GET_TIME	SET_32_COUNTER	TEST_MODE	MODE_12_24	AUTO_COMP	ROUND_30S	STOP_RTC	

Bits	Field Name	Description	Type	Reset
7	RTC_V_OPT	RTC date/time register selection: 0: Read access directly to dynamic registers (SECONDS_REG, MINUTES_REG, HOURS_REG, DAYS_REG, MONTHS_REG, YEAR_REG, WEEKS_REG) 1: Read access to static shadowed registers: (see GET_TIME bit).	RW	0
6	GET_TIME	When writing a 1 into this register, the content of the dynamic registers (SECONDS_REG, MINUTES_REG, HOURS_REG, DAYS_REG, MONTHS_REG, YEAR_REG and WEEKS_REG) is transferred into static shadowed registers. Each update of the shadowed registers needs to be done by re-asserting GET_TIME bit to 1 (i.e.: reset it to 0 and then re-write it to 1)	RW	0
5	SET_32_COUNTER	0: No action 1: set the 32-kHz counter with COMP_REG value. It must only be used when the RTC is frozen.	RW	0
4	TEST_MODE	0: functional mode 1: test mode (Auto compensation is enable when the 32-kHz counter reaches at its end)	RW	0
3	MODE_12_24	0: 24 hours mode 1: 12 hours mode (PM-AM mode) It is possible to switch between the two modes at any time without disturbed the RTC, read or write are always performed with the current mode.	RW	0
2	AUTO_COMP	0: No auto compensation 1: Auto compensation enabled	RW	0
1	ROUND_30S	0: No update 1: When a one is written, the time is rounded to the closest minute. This bit is a toggle bit, the micro-controller can only write one and RTC clears it. If the micro-controller sets the ROUND_30S bit and then read it, the micro-controller will read one until the rounded to the closet.	RW	0
0	STOP_RTC	0: RTC is frozen 1: RTC is running	RW	0

Table 11-16. RTC_STATUS_REG

Address Offset	0x11		
Physical Address			Instance (RESET DOMAIN: FULL RESET)

Table 11-16. RTC_STATUS_REG (continued)

Description		RTC status register: NOTES: A dummy read of this register is necessary before each I ² C read in order to update the status register value.					
Type		RW					
7	6	5	4	3	2	1	0
POWER_UP	ALARM	EVENT_1D	EVENT_1H	EVENT_1M	EVENT_1S	RUN	Reserved

Bits	Field Name	Description	Type	Reset
7	POWER_UP	Indicates that a reset occurred (bit cleared to 0 by writing 1). POWER_UP is set by a reset, is cleared by writing one in this bit.	RW	1
6	ALARM	Indicates that an alarm interrupt has been generated (bit clear by writing 1). The alarm interrupt keeps its low level, until the micro-controller write 1 in the ALARM bit of the RTC_STATUS_REG register. The timer interrupt is a low-level pulse (15 µs duration).	RW	0
5	EVENT_1D	One day has occurred	RO	0
4	EVENT_1H	One hour has occurred	RO	0
3	EVENT_1M	One minute has occurred	RO	0
2	EVENT_1S	One second has occurred	RO	0
1	RUN	0: RTC is frozen 1: RTC is running This bit shows the real state of the RTC, indeed because of STOP_RTC signal was resynchronized on 32-kHz clock, the action of this bit is delayed.	RO	0
0	Reserved	Reserved bit	RO R returns 0s	0

Table 11-17. RTC_INTERRUPTS_REG

Address Offset		0x12					
Physical Address		Instance		(RESET DOMAIN: FULL RESET)			
Description		RTC interrupt control register					
Type		RW					
7	6	5	4	3	2	1	0
Reserved			IT_SLEEP_MASK_EN	IT_ALARM	IT_TIMER	EVERY	

Bits	Field Name	Description	Type	Reset
7:5	Reserved	Reserved bit	RO R returns 0s	0x0
4	IT_SLEEP_MASK_EN	1: Mask periodic interrupt while the TPS65911 device is in SLEEP mode. Interrupt event is back up in a register and occurred as soon as the TPS65911 device is no more in SLEEP mode. 0: Normal mode, no interrupt masked	RW	0
3	IT_ALARM	Enable one interrupt when the alarm value is reached (TC ALARM registers) by the TC registers	RW	0
2	IT_TIMER	Enable periodic interrupt 0: interrupt disabled 1: interrupt enabled	RW	0
1:0	EVERY	Interrupt period 00: every second 01: every minute 10: every hour 11: every day	RW	0x0

Table 11-18. RTC_COMP_LSB_REG

Address Offset	0x13							
Physical Address		Instance		(RESET DOMAIN: FULL RESET)				
Description	RTC compensation register (LSB) Notes: This register must be written in 2-complement. This means that to add one 32-kHz oscillator period every hour, micro-controller needs to write FFFF into RTC_COMP_MSB_REG & RTC_COMP_LSB_REG. To remove one 32-kHz oscillator period every hour, micro-controller needs to write 0001 into RTC_COMP_MSB_REG & RTC_COMP_LSB_REG. The 7FFF value is forbidden.							
Type	RW							
	7	6	5	4	3	2	1	0
	RTC_COMP_LSB							

Bits	Field Name	Description	Type	Reset
7:0	RTC_COMP_LSB	This register contains the number of 32-kHz periods to be added into the 32-kHz counter every hour [LSB]	RW	0x00

Table 11-19. RTC_COMP_MSB_REG

Address Offset	0x14							
Physical Address					Instance	(RESET DOMAIN: FULL RESET)		
Description	RTC compensation register (MSB) Notes: See RTC_COMP_LSB_REG Notes.							
Type	RW							
	7	6	5	4	3	2	1	0
	RTC_COMP_MSB							

Bits	Field Name	Description	Type	Reset
7:0	RTC_COMP_MSB	This register contains the number of 32-kHz periods to be added into the 32-kHz counter every hour [MSB]	RW	0x00

Table 11-20. RTC_RES_PROG_REG

Address Offset	0x15														
Physical Address		Instance					(RESET DOMAIN: FULL RESET)								
Description	RTC register containing oscillator resistance value														
Type	RW														
7		6		5		4		3		2		1		0	
Reserved		SW_RES_PROG													

Bits	Field Name	Description	Type	Reset
7:6	Reserved	Reserved bit	RO R returns 0s	0x0
5:0	SW_RES_PROG	Value of the oscillator resistance	RW	0x27

Table 11-21. RTC_RESET_STATUS_REG

Address Offset	0x16																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																				</
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Table 11-21. RTC_RESET_STATUS_REG (continued)

Type	RW						
7	6	5	4	3	2	1	0
Reserved							RESET_STAT US
Bits	Field Name	Description				Type	Reset
7:1	Reserved	Reserved bit				RO R returns 0s	0x0
0	RESET_STATUS	This bit can only be set to one and is cleared when a manual reset or a POR (VBAT < 2.1) occur. If this bit is reset it means that the RTC has lost its configuration.				RW	0

Table 11-22. BCK1_REG

Address Offset	0x17						
Physical Address	Instance (RESET DOMAIN: FULL RESET)						
Description	Backup register which can be used for storage by the application firmware when the external host is powered down. These registers will retain their content as long as the VRTC is active.						
Type	RW						
7	6	5	4	3	2	1	0
BCKUP							

Bits	Field Name	Description	Type	Reset
7:0	BCKUP	Backup bit	RW	0x00

Table 11-23. BCK2_REG

Address Offset	0x18						
Physical Address	Instance (RESET DOMAIN: FULL RESET)						
Description	Backup register which can be used for storage by the application firmware when the external host is powered down. These registers will retain their content as long as the VRTC is active.						
Type	RW						
7	6	5	4	3	2	1	0
BCKUP							

Bits	Field Name	Description	Type	Reset
7:0	BCKUP	Backup bit	RW	0x00

Table 11-24. BCK3_REG

Address Offset	0x19						
Physical Address	Instance (RESET DOMAIN: FULL RESET)						
Description	Backup register which can be used for storage by the application firmware when the external host is powered down. These registers will retain their content as long as the VRTC is active.						
Type	RW						
7	6	5	4	3	2	1	0
BCKUP							

Bits	Field Name	Description	Type	Reset
7:0	BCKUP	Backup bit	RW	0x00

Table 11-25. BCK4_REG

Address Offset	0x1A			
Physical Address	Instance (RESET DOMAIN: FULL RESET)			
Description	Backup register which can be used for storage by the application firmware when the external host is powered down. These registers will retain their content as long as the VRTC is active.			
Type	RW			
7	6	5	4	3
2	1	0	BCKUP	

Bits	Field Name	Description	Type	Reset
7:0	BCKUP	Backup bit	RW	0x00

Table 11-26. BCK5_REG

Address Offset	0x1B			
Physical Address	Instance (RESET DOMAIN: FULL RESET)			
Description	Backup register which can be used for storage by the application firmware when the external host is powered down. These registers will retain their content as long as the VRTC is active.			
Type	RW			
7	6	5	4	3
2	1	0	BCKUP	

Bits	Field Name	Description	Type	Reset
7:0	BCKUP	Backup bit	RW	0x00

Table 11-27. PUADEN_REG

Address Offset	0x1C			
Physical Address	Instance (RESET DOMAIN: GENERAL RESET)			
Description	Pullup/pulldown control register.			
Type	RW			
7	6	5	4	3
2	1	0	Reserved	
I2CCTLP	I2CSR	PWRONP	SLEPP	PWRHOLDP
HDRSTP	NRESPWRON 2P			

Bits	Field Name	Description	Type	Reset
7	Reserved		RO	0
6	I2CCTLP	SDACTL and SCLCTL pullup control: 1: Pullup is enabled 0: Pullup is disabled	RW	0
5	I2CSR	SDASR and SCLSR pullup control: 1: Pullup is enabled 0: Pullup is disabled	RW	0
4	PWRONP	PWRON pad pullup control: 1: Pullup is enabled 0: Pullup is disabled	RW	1

Bits	Field Name	Description	Type	Reset
3	SLEEPP	SLEEP pad pulldown control: 1: Pulldown is enabled 0: Pulldown is disabled	RW	1
2	PWRHOLDP	PWRHOLD pad pulldown control: 1: Pulldown is enabled 0: Pulldown is disabled	RW	1
1	HDRSTP	HDRST pad pulldown control: 1: Pulldown is enabled 0: Pulldown is disabled	RW	1
0	NRESPWRON2P	NRESPWRON2 pad control: 1: Pulldown is enabled 0: Pulldown is disabled	RW	1

Table 11-28. REF_REG

Address Offset	0x1D			
Physical Address			Instance	(RESET DOMAIN: TURNOFF OFF RESET)
Description	Reference control register			
Type	RO			
7	6	5	4	3
Reserved				2
				1
				0
				ST

Bits	Field Name	Description	Type	Reset
7:2	Reserved	Reserved bit	RO R returns 0s	0x00
1:0	ST	Reference state: ST[1:0] = 00: Off ST[1:0] = 01: On high power (ACTIVE) ST[1:0] = 10: Reserved ST[1:0] = 11: On low power (SLEEP) (Write access available in test mode only)	RO	0x1

Table 11-29. VRTC_REG

Address Offset	0x1E			
Physical Address			Instance	(RESET DOMAIN: GENERAL RESET)
Description	VRTC internal regulator control register			
Type	RW			
7	6	5	4	3
Reserved				2
				1
				0
				ST

Bits	Field Name	Description	Type	Reset
7:4	Reserved	Reserved bit	RO R returns 0s	0x0
3	VRTC_OFFMASK	VRTC internal regulator off mask signal: when 1, the regulator keeps its full-load capability during device OFF state. when 0, the regulator will enter in low-power mode during device OFF state. Note that VRTC is put in low-power mode when the device is on backup even if this bit is set to 1 (Default value: See boot configuration)	RW	0

Bits	Field Name	Description	Type	Reset
2	Reserved	Reserved bit	RO R returns 0s	0
1:0	ST	Reference state: ST[1:0] = 00: Reserved ST[1:0] = 01: On high power (ACTIVE) ST[1:0] = 10: Reserved ST[1:0] = 11: On low power (SLEEP) (Write access available in test mode only)	RO	0x1

Table 11-30. VIO_REG

Address Offset		0x20					
Physical Address		Instance					
		(RESET DOMAIN: TURNOFF OFF RESET)					
Description		VIO control register					
Type		RW					
7	6	5	4	3	2	1	0
ILMAX		Reserved		SEL		ST	

Bits	Field Name	Description	Type	Reset
7:6	ILMAX	Select maximum load current: when 00: 0.6 A when 01: 1.0 A when 10: 1.3 A when 11: 1.3 A	RW	0x0
5:4	Reserved	Reserved bit	RO R returns 0s	0x0
3:2	SEL	Output voltage selection (EEPROM bits): SEL[1:0] = 00: 1.5 V SEL[1:0] = 01: 1.8 V SEL[1:0] = 10: 2.5 V SEL[1:0] = 11: 3.3 V (Default value: see boot configuration)	RW	0x0
1:0	ST	Supply state (EEPROM bits): ST[1:0] = 00: Off ST[1:0] = 01: On high power (ACTIVE) ST[1:0] = 10: Off ST[1:0] = 11: On low power (SLEEP)	RW	0x0

Table 11-31. VDD1_REG

Address Offset		0x21													
Physical Address		Instance (RESET DOMAIN: TURNOFF OFF RESET)													
Description		VDD1 control register													
Type		RW													
7		6		5		4		3		2		1		0	
VGAIN_SEL				ILMAX				TSTEP						ST	

Bits	Field Name	Description	Type	Reset
7:6	VGAIN_SEL	Select output voltage multiplication factor: G (EEPROM bits): when 00: x1 when 01: x1 when 10: x2 when 11: x3 (Default value:see boot configuration)	RW	0x0

Bits	Field Name	Description	Type	Reset
5	ILMAX	Select maximum load current: when 0: 1.0 A when 1: > 1.5 A	RW	0
4:2	TSTEP	Time step: when changing the output voltage, the new value is reached through successive 12.5 mV voltage steps (if not bypassed). The equivalent programmable slew rate of the output voltage is then: TSTEP[2:0] = 000: step duration is 0, step function is bypassed TSTEP[2:0] = 001: 12.5 mV/μs (sampling 3 Mhz) TSTEP[2:0] = 010: 9.4 mV/μs (sampling 3 Mhz × 3/4) TSTEP[2:0] = 011: 7.5 mV/μs (sampling 3 Mhz × 3/5) (default) TSTEP[2:0] = 100: 6.25 mV/μs(sampling 3 Mhz/2) TSTEP[2:0] = 101: 4.7 mV/μs(sampling 3 Mhz/3) TSTEP[2:0] = 110: 3.12 mV/μs(sampling 3 Mhz/4) TSTEP[2:0] = 111: 2.5 mV/μs(sampling 3 Mhz/5)	RW	0x3
1:0	ST	Supply state (EEPROM bits): ST[1:0] = 00: Off ST[1:0] = 01: On, high-power mode ST[1:0] = 10: Off ST[1:0] = 11: On, low-power mode	RW	0x0

Table 11-32. VDD1_OP_REG

Address Offset	0x22						
Physical Address				Instance	(RESET DOMAIN: TURNOFF OFF RESET)		
Description	VDD1 voltage selection register. This register can be accessed by both control and coltage scaling I ² C interfaces depending on SR_CTL_I2C_SEL register bit value.						
Type	RW						
7	6	5	4	3	2	1	0
CMD	SEL						

Bits	Field Name	Description	Type	Reset
7	CMD	when 0: VDD1_OP_REG voltage is applied when 1: VDD1_SR_REG voltage is applied	RW	0
6:0	SEL	Output voltage (4 EEPROM bits) selection with GAIN_SEL = 00 (G = 1, 12.5 mV per LSB): SEL[6:0] = 1001011 to 1111111: 1.5 V ... SEL[6:0] = 0111111: 1.35 V ... SEL[6:0] = 0110011: 1.2 V ... SEL[6:0] = 0000001 to 0000011: 0.6 V SEL[6:0] = 0000000: Off (0.0 V) Note: from SEL[6:0] = 3 to 75 (dec) Vout = (SEL[6:0] × 12.5 mV + 0.5625 V) × G (Default value: See boot configuration) Note: Vout maximum value is 3.3 V	RW	0x00

Table 11-33. VDD1_SR_REG

Address Offset	0x23	Instance	(RESET DOMAIN: TURNOFF OFF RESET)
Physical Address			
Description	VDD1 voltage selection register. This register can be accessed by both control and voltage scaling dedicated I ² C interfaces depending on SR_CTL_I2C_SEL register bit value.		
Type	RW		

7	6	5	4	3	2	1	0
Reserved	SEL						

Bits	Field Name	Description	Type	Reset
7	Reserved	Reserved bit	RO R returns 0s	0
6:0	SEL	Output voltage selection with GAIN_SEL = 00 (G = 1, 12.5 mV per LSB): SEL[6:0] = 1001011 to 1111111: 1.5 V ... SEL[6:0] = 0111111: 1.35 V ... SEL[6:0] = 0110011: 1.2 V ... SEL[6:0] = 0000001 to 0000011: 0.6 V SEL[6:0] = 0000000: Off (0.0 V) Note: from SEL[6:0] = 3 to 75 (dec) Vout = (SEL[6:0] × 12.5 mV + 0.5625 V) × G (Default value: See boot configuration) Note: Vout maximum value is 3.3 V	RW	0x00

Table 11-34. VDD2_REG

Address Offset	0x24	Instance	(RESET DOMAIN: TURNOFF OFF RESET)
Physical Address			
Description	VDD2 control register		
Type	RW		

7	6	5	4	3	2	1	0
VGAIN_SEL	ILMAX	TSTEP			ST		

Bits	Field Name	Description	Type	Reset
7:6	VGAIN_SEL	Select output voltage multiplication factor (x1, x3 included in EEPROM bits): G when 00: x1 when 01: x1 when 10: x2 when 11: x3	RW	0x0
5	ILMAX	Select maximum load current: when 0: 1.0 A when 1: > 1.5 A	RW	0
4:2	TSTEP	Time step: when changing the output voltage, the new value is reached through successive 12.5 mV voltage steps (if not bypassed). The equivalent programmable slew rate of the output voltage is then: TSTEP[2:0] = 000: step duration is 0, step function is bypassed TSTEP[2:0] = 001: 12.5 mV/μs (sampling 3 Mhz) TSTEP[2:0] = 010: 9.4 mV/μs (sampling 3 Mhz × 3/4) TSTEP[2:0] = 011: 7.5 mV/μs (sampling 3 Mhz × 3/5) (default) TSTEP[2:0] = 100: 6.25 mV/μs(sampling 3 Mhz/2) TSTEP[2:0] = 101: 4.7 mV/μs(sampling 3 Mhz/3) TSTEP[2:0] = 110: 3.12 mV/μs(sampling 3 Mhz/4) TSTEP[2:0] = 111: 2.5 mV/μs(sampling 3 Mhz/5)	RW	0x1
1:0	ST	Supply state (EEPROM bits): ST[1:0] = 00: Off ST[1:0] = 01: On, high-power mode ST[1:0] = 10: Off ST[1:0] = 11: On, low-power mode	RW	0x0

Table 11-35. VDD2_OP_REG

Address Offset	0x25														
Physical Address				Instance	(RESET DOMAIN: TURNOFF OFF RESET)										
Description	VDD2 voltage selection register. This register can be accessed by both control and voltage scaling dedicated I ² C interfaces depending on SR_CTL_I2C_SEL register bit value.														
Type	RW														
7		6		5		4		3		2		1		0	
CMD		SEL													

Bits	Field Name	Description	Type	Reset
7	CMD	Command: when 0: VDD2_OP_REG voltage is applied when 1: VDD2_SR_REG voltage is applied	RW	0
6:0	SEL	Output voltage (4 EEPROM bits) selection with GAIN_SEL = 00 (G = 1, 12.5 mV per LSB): SEL[6:0] = 1001011 to 11111111: 1.5 V ... SEL[6:0] = 01111111: 1.35 V ... SEL[6:0] = 0110011: 1.2 V ... SEL[6:0] = 0000001 to 0000011: 0.6 V SEL[6:0] = 0000000: Off (0.0 V) Note: from SEL[6:0] = 3 to 75 (dec) $V_{out} = (SEL[6:0] \times 12.5 \text{ mV} + 0.5625 \text{ V}) \times G$ Note: Vout maximum value is 3.3 V	RW	0x00

Table 11-36. VDD2_SR_REG

Address Offset	0x26														
Physical Address				Instance	(RESET DOMAIN: TURNOFF OFF RESET)										
Description	VDD2 voltage selection registre. This register can be accessed by both control and voltage scaling dedicated I ² C interfaces depending on SR_CTL_I2C_SEL register bit value.														
Type	RW														
7		6		5		4		3		2		1		0	
Reserved		SEL													

Bits	Field Name	Description	Type	Reset
7	Reserved	Reserved bit	RO R returns 0s	0
6:0	SEL	Output voltage (EEPROM bits) selection with GAIN_SEL = 00 (G = 1, 12.5 mV per LSB): SEL[6:0] = 1001011 to 11111111: 1.5 V ... SEL[6:0] = 01111111: 1.35V ... SEL[6:0] = 0110011: 1.2V ... SEL[6:0] = 0000001 to 0000011: 0.6V SEL[6:0] = 0000000: Off (0.0V) Note: from SEL[6:0] = 3 to 75 (dec) Vout= (SEL[6:0] × 12.5 mV + 0.5625 V) × G Note: Vout maximum value is 3.3 V	RW	0x00

Table 11-37. VDDCTRL_REG

Address Offset	0x27			
Physical Address	Instance			(RESET DOMAIN: TURNOFF OFF RESET)
Description	VDDCtrl, external FET controller			
Type	RW			
7	6	5	4	3
2	1	0	Reserved	
			ST	

Bits	Field Name	Description	Type	Reset
7:2	Reserved	Reserved bit	RO R returns 0s	0x00
1:0	ST	Supply state (EEPROM dependent): ST[1:0] = 00: Off ST[1:0] = 01: On ST[1:0] = 10: Off ST[1:0] = 11: On	RW	0x0

Table 11-38. VDDCTRL_OP_REG

Address Offset	0x28			
Physical Address	Instance			(RESET DOMAIN: TURN OFF RESET)
Description	VDDCtrl voltage selection register. This register can be accessed by both control and voltage scaling dedicated I ² C interfaces depending on SR_CTL_I2C_SEL register bit value.			
Type	RW			
7	6	5	4	3
2	1	0	CMD	
			SEL	

Bits	Field Name	Description	Type	Reset
7	CMD	Command: when 0: VDDctrl_OP_REG voltage is applied when 1: VDDctrl_SR_REG voltage is applied	RW	0
6:0	SEL	Output voltage (4 EEPROM bits) selection: SEL[6:0] = 1000011 to 1111111: 1.4 V ... SEL[6:0] = 0110011: 1.2 V ... SEL[6:0] = 0010011: 0.8 V ... SEL[6:0] = 0000001: 0.6 V SEL[6:0] = 0000000: Off (0.0 V) Note: from SEL[6:0] = 3 to 64 (dec) Vout = (SEL[6:0] × 12.5 mV + 0.5625 V) (Default value: See boot configuration)	RW	0x00

Table 11-39. VDDCTRL_SR_REG

Address Offset	0x29			
Physical Address	Instance			(RESET DOMAIN: TURN OFF RESET)
Description	VDDCtrl voltage selection register. This register can be accessed by both control and voltage scaling dedicated I ² C interfaces depending on SR_CTL_I2C_SEL register bit value.			
Type	RW			

7	6	5	4	3	2	1	0
Reserved	SEL						

Bits	Field Name	Description	Type	Reset
7	Reserved		RO	0
6:0	SEL	Output voltage (4 EEPROM bits) selection: SEL[6:0] = 100011 to 111111: 1.4 V ... SEL[6:0] = 011001: 1.2 V ... SEL[6:0] = 001001: 0.8 V ... SEL[6:0] = 000001: 0.6 V SEL[6:0] = 000000: Off (0.0 V) Note: from SEL[6:0] = 3 to 64 (dec) Vout = (SEL[6:0] × 12.5 mV + 0.5625 V) (Default value: See boot configuration)	RW	0x03

Table 11-40. LDO1_REG

Address Offset	0x30						
Physical Address				Instance	(RESET DOMAIN: TURNOFF OFF RESET)		
Description	LDO1 regulator control register						
Type	RW						
7	6	5	4	3	2	1	0
SEL						ST	

Bits	Field Name	Description	Type	Reset
7:2	SEL	Supply voltage (EEPROM bits): SEL[7:2] = 00000: 0.00011: 1 V SEL[7:2] = 000100: 1 V SEL[7:2] = 000101: 1.05 V ... SEL[7:2] = 110001: 3.25 V SEL[7:2] = 110010: 3.3 V (Default value: See boot configuration)	RW	0x0
1:0	ST	Supply state (EEPROM bits): ST[1:0] = 00: Off ST[1:0] = 01: On high power (ACTIVE) ST[1:0] = 10: Off ST[1:0] = 11: On low power (SLEEP)	RW	0x0

Table 11-41. LDO2_REG

Address Offset	0x31														
Physical Address					Instance	(RESET DOMAIN: TURNOFF OFF RESET)									
Description	LDO2 regulator control register														
Type	RW														
7		6		5		4		3		2		1		0	
SEL												ST			

Bits	Field Name	Description	Type	Reset
7:2	SEL	Supply voltage (EEPROM bits): SEL[7:2] = 00000: 000011: 1 V SEL[7:2] = 000100: 1 V SEL[7:2] = 000101: 1.05 V ... SEL[7:2] = 110001: 3.25 V SEL[7:2] = 110010: 3.3 V (Default value: See boot configuration)	RW	0x0
1:0	ST	Supply state (EEPROM bits): ST[1:0] = 00: Off ST[1:0] = 01: On high power (ACTIVE) ST[1:0] = 10: Off ST[1:0] = 11: On low power (SLEEP)	RW	0x0

Table 11-42. LDO5_REG

Address Offset		0x32													
Physical Address		Instance (RESET DOMAIN: TUROFF RESET)													
Description		LDO5 regulator control register													
Type		RW													
7		6		5		4		3		2		1		0	
Reserved		SEL										ST			

Bits	Field Name	Description	Type	Reset
7	Reserved		RO R returns 0s	0
6:2	SEL	Supply voltage (EEPROM bits): SEL[6:2] = 00000: 1 V SEL[6:2] = 00001: 1 V SEL[6:2] = 00010: 1 V SEL[6:2] = 00011: 1.1 V ... SEL[6:2] = 11000: 3.2 V SEL[6:2] = 11001: 3.3 V (Default value: See boot configuration)	RW	0x00
1:0	ST	Supply state (EEPROM bits): ST[1:0] = 00: Off ST[1:0] = 01: On high power (ACTIVE) ST[1:0] = 10: Off ST[1:0] = 11: On low power (SLEEP)	RW	0x0

Table 11-43. LDO8_REG

Address Offset	0x33							Instance (RESET DOMAIN: TURNOFF OFF RESET)
Physical Address								
Description	LDO8 regulator control register							
Type	RW							
76543210								
Reserved		SEL					ST	

Bits	Field Name	Description	Type	Reset
7	Reserved		RO R returns 0s	0
6:2	SEL	Supply voltage (EEPROM bits): SEL[6:2] = 00000: 1 V SEL[6:2] = 00001: 1 V SEL[6:2] = 00010: 1 V SEL[6:2] = 00011: 1.1 V ... SEL[6:2] = 11000: 3.2 V SEL[6:2] = 11001: 3.3 V (Default value: See boot configuration)	RW	0x00
1:0	ST	Supply state (EEPROM bits): ST[1:0] = 00: Off ST[1:0] = 01: On high power (ACTIVE) ST[1:0] = 10: Off ST[1:0] = 11: On low power (SLEEP)	RW	0x0

Table 11-44. LDO7_REG

Address Offset	0x34							Instance	(RESET DOMAIN: TURNOFF OFF RESET)
Physical Address									
Description	LDO7 regulator control register								
Type	RW								
7	6	5	4	3	2	1	0		
Reserved	SEL					ST			

Bits	Field Name	Description	Type	Reset
7	Reserved		RO R returns 0s	0
6:2	SEL	Supply voltage (EEPROM bits): SEL[6:2] = 00000: 1 V SEL[6:2] = 00001: 1 V SEL[6:2] = 00010: 1 V SEL[6:2] = 00011: 1.1 V ... SEL[6:2] = 11000: 3.2 V SEL[6:2] = 11001: 3.3 V (Default value: See boot configuration)	RW	0x00
1:0	ST	Supply state (EEPROM bits): ST[1:0] = 00: Off ST[1:0] = 01: On high power (ACTIVE) ST[1:0] = 10: Off ST[1:0] = 11: On low power (SLEEP)	RW	0x0

Table 11-45. LDO6_REG

Address Offset	0x35	Instance	(RESET DOMAIN: TURNOFF OFF RESET)
Physical Address			
Description	LDO6 regulator control register		
Type	RW		

7	6	5	4	3	2	1	0
Reserved	SEL					ST	

Bits	Field Name	Description	Type	Reset
7	Reserved		RO R returns 0s	0
6:2	SEL	Supply voltage (EEPROM bits): SEL[6:2] = 00000: 1 V SEL[6:2] = 00001: 1 V SEL[6:2] = 00010: 1 V SEL[6:2] = 00011: 1.1 V ... SEL[6:2] = 11000: 3.2 V SEL[6:2] = 11001: 3.3 V (Default value: See boot configuration)	RW	0x00
1:0	ST	Supply state (EEPROM bits): ST[1:0] = 00: Off ST[1:0] = 01: On high power (ACTIVE) ST[1:0] = 10: Off ST[1:0] = 11: On low power (SLEEP)	RW	0x0

Table 11-46. LDO4_REG

Address Offset	0x36		
Physical Address		Instance	(RESET DOMAIN: TURNOFF OFF RESET)
Description	LDO4 regulator control register		
Type	RW		

7	6	5	4	3	2	1	0
SEL					ST		

Bits	Field Name	Description	Type	Reset
7:2	SEL	Supply voltage (EEPROM bits): SEL[7:2] = 00000: 00000: 0.8 V SEL[7:2] = 00000: 000001: 0.85 V SEL[7:2] = 00000: 000010: 0.9 V SEL[7:2] = 000100: 1 V SEL[7:2] = 000101: 1.05 V ... SEL[7:2] = 110001: 3.25 V SEL[7:2] = 110010: 3.3 V Applicable voltage selection TRACK LDO 0: 1 V to 3.3 V TRACK LDO 1: 0.8 V to 1.5 V (Default value: See boot configuration)	RW	0x00
1:0	ST	Supply state (EEPROM bits): ST[1:0] = 00: Off ST[1:0] = 01: On high power (ACTIVE) ST[1:0] = 10: Off ST[1:0] = 11: On low power (SLEEP)	RW	0x0

Table 11-47. LDO3_REG

Address Offset	0x37		
Physical Address		Instance	(RESET DOMAIN: TURNOFF OFF RESET)
Description	LDO3 regulator control register		
Type	RW		

7	6	5	4	3	2	1	0
Reserved	SEL					ST	

Bits	Field Name	Description	Type	Reset
7	Reserved		RO R returns 0s	0
6:2	SEL	Supply voltage (EEPROM bits): SEL[6:2] = 00000: 1 V SEL[6:2] = 00001: 1 V SEL[6:2] = 00010: 1 V SEL[6:2] = 00011: 1.1 V ... SEL[6:2] = 11000: 3.2 V SEL[6:2] = 11001: 3.3 V (Default value: See boot configuration)	RW	0x00
1:0	ST	Supply state (EEPROM bits): ST[1:0] = 00: Off ST[1:0] = 01: On high power (ACTIVE) ST[1:0] = 10: Off ST[1:0] = 11: On low power (SLEEP)	RW	0x0

Table 11-48. Therm_REG

Address Offset	0x38				
Physical Address			Instance	(RESET DOMAIN:	
Description	Thermal control register			bits[5:2]: GENERAL RESET	
Type	RW			bit[0] TURNOFF OFF RESET)	

7	6	5	4	3	2	1	0
Reserved		THERM_HD	THERM_TS	THERM_HDSEL		Reserved	THERM_STATE

Bits	Field Name	Description	Type	Reset
7:6	Reserved	Reserved bit	RO R returns 0s	0x0
5	THERM_HD	Hot die detector output: when 0: the hot die threshold is not reached when 1: the hot die threshold is reached	RO	0
4	THERM_TS	Thermal shutdown detector output: when 0: the thermal shutdown threshold is not reached when 1: the thermal shutdown threshold is reached	RO	0
3:2	THERM_HDSEL	Temperature selection for hot-die detector: when 00: Low temperature threshold ... when 11: High temperature threshold	RW	0x3
1	Reserved		RO R returns 0s	0
0	THERM_STATE	Thermal shutdown module enable signal: when 0: thermal shutdown module is disable when 1: thermal shutdown module is enable	RW	1

Table 11-49. BBCH_REG

Address Offset	0x39		
Physical Address	Instance		(RESET DOMAIN: GENERAL RESET)
Description	Back-up battery charger control register		

Table 11-49. BBCH_REG (continued)

Type	RW							
7	6	5	4	3	2	1	0	
Reserved					BBSEL		BBCHEN	
Bits	Field Name	Description					Type	Reset
7:3	Reserved	Reserved bit					RO R returns 0s	0x00
2:1	BBSEL	Back up battery charge voltage selection: BBSEL[1:0] = 00: 3.0 V BBSEL[1:0] = 01: 2.52 V BBSEL[1:0] = 10: 3.15 V BBSEL[1:0] = 11: VBAT					RW	0x0
0	BBCHEN	Back up battery charge enable					RW	0

Table 11-50. DCDCCTRL_REG

Address Offset		0x3E						
Physical Address		Instance					RESET DOMAIN: bits [7:3]: TURNOFF OFF RESET bits [2:0]: GENERAL RESET	
Description		DCDC control register						
Type		RW						
7		6	5	4	3	2	1	0
Reserved		TRACK	VDD2_PSKIP	VDD1_PSKIP	VIO_PSKIP	DCDCCKEXT	DCDCCKSYNC	

Bits	Field Name	Description	Type	Reset
7	Reserved	Reserved bit	RO R returns 0s	0
6	TRACK	1: Tracking mode: LDO4 output follows VDD1 setting when VDD1 active. See appendix for more information. 0: Normal LDO operation without tracking	RW	0
5	VDD2_PSKIP	VDD2 pulse skip mode enable (EEPROM bit) Default value: See boot configuration	RW	1
4	VDD1_PSKIP	VDD1 pulse skip mode enable (EEPROM bit) Default value: See boot configuration	RW	1
3	VIO_PSKIP	VIO pulse skip mode enable (EEPROM bit) Default value: See boot configuration	RW	1
2	DCDCCKEXT	This signal control the muxing of the GPIO2 pad: When 0: this pad is a GPIO When 1: this pad is used as input for an external clock used for the synchronisation of the DCDCs	RW	0
1:0	DCDCCKSYNC	DCDC clock configuration: DCDCCKSYNC[1:0] = 00: no synchronization of DCDC clocks DCDCCKSYNC[1:0] = 01: DCDC synchronous clock with phase shift DCDCCKSYNC[1:0] = 10: no synchronization of DCDC clocks DCDCCKSYNC[1:0] = 11: DCDC synchronous clock	RW	0x1

Table 11-51. DEVCTRL_REG

Address Offset	0x3F						
Physical Address					Instance	(RESET DOMAIN: GENERAL RESET)	
Description	Device control register					Bit 0,1, and 3 : TURN OFF RESET	

Table 11-51. DEVCTRL_REG (continued)

Type	RW						
7	6	5	4	3	2	1	0
PWR_OFF_SEQ	RTC_PWDN	CK32K_CTRL	SR_CTL_I2C_SEL	DEV_OFF_RST	DEV_ON	DEV_SLP	DEV_OFF

Bits	Field Name	Description	Type	Reset
7	PWR_OFF_SEQ	When 1, power-off will be sequential, reverse of power-on sequence (first resource to power on will be the last to power off). When 0, all resources disabled at the same time	RW	0
6	RTC_PWDN	When 1, disable the RTC digital domain (clock gating and reset of RTC registers and logic). This register bit is not reset in BACKUP state.	RW	0
5	CK32K_CTRL	Internal 32-kHz clock source control bit (EEPROM bit): when 0, the internal 32-kHz clock source is the crystal oscillator or an external 32-kHz clock in case the crystal oscillator is used in bypass mode when 1, the internal 32-kHz clock source is the RC oscillator.	RW	0
4	SR_CTL_I2C_SEL	Voltage scaling registers access control bit: when 0: access to registers by voltage scaling I ² C when 1: access to registers by control I ² C. The voltage scaling registers are: VDD1_OP_REG, VDD1_SR_REG, VDD2_OP_REG, VDD2_SR_REG, VDDCtrl_OP_REG, and VDDCtrl_SR_REG.	RW	1
3	DEV_OFF_RST	Write 1 will start an ACTIVE-to-OFF or SLEEP-to-OFF device state transition (switch-off event) and activate reset of the digital core. This bit is cleared in OFF state.	RW	0
2	DEV_ON	Write 1 will maintain the device on (ACTIVE or SLEEP device state) (if DEV_OFF = 0 and DEV_OFF_RST = 0). EEPROM bit (Default value: See boot configuration)	RW	0
1	DEV_SLP	Write 1 allows SLEEP device state (if DEV_OFF = 0 and DEV_OFF_RST = 0). Write '0' will start an SLEEP-to-ACTIVE device state transition (wake-up event) (if DEV_OFF = 0 and DEV_OFF_RST = 0). This bit is cleared in OFF state.	RW	0
0	DEV_OFF	Write 1 will start an ACTIVE-to-OFF or SLEEP-to-OFF device state transition (switch-off event). This bit is cleared in OFF state.	RW	0

Table 11-52. DEVCTRL2_REG

Address Offset	0x40		
Physical Address			Instance
Description	Device control register		(RESET DOMAIN: GENERAL RESET) TSL0T_LENGTH: TURN OFF RESET
Type	RW		

7	6	5	4	3	2	1	0
Reserved	DCDC_SLEEP_LVL	TSL0T_LENGTH	SLEEPSIG_PO_L	PWON_LP_OF_F	PWON_LP_RS_T	IT_POL	

Bits	Field Name	Description	Type	Reset
7	Reserved		RO R returns 0s	0
6	DCDC_SLEEP_LVL	When 1, DCDC output level in SLEEP mode is VDDx_SR_REG, to be other than 0 V. When 0, no effect	RW	0

Bits	Field Name	Description	Type	Reset
5:4	TSLOT_LENGTH	Time slot duration programming (EEPROM bit): When 00: 0 μ s When 01: 200 μ s When 10: 500 μ s When 11: 2 ms (Default value: See boot configuration)	RW	0x3
3	SLEEPSIG_POL	When 1, SLEEP signal active-high When 0, SLEEP signal active-low	RW	0
2	PWON_LP_OFF	When 1, allows device turn-off after a PWON Long Press (signal low) (EEPROM bits). (Default value: See boot configuration)	RW	1
1	PWON_LP_RST	When 1, allows digital core reset when the device is OFF (EEPROM bit). (Default value: See boot configuration)	RW	0
0	IT_POL	INT1 interrupt pad polarity control signal (EEPROM bit): When 0, active low When 1, active high (Default value: See boot configuration)	RW	0

Table 11-53. SLEEP_KEEP_LDO_ON_REG

Address Offset	0x41														
Physical Address					Instance	(RESET DOMAIN: GENERAL RESET)									
Description	When corresponding control bit = 0 in EN1_LDO_ASS register (default setting): Configuration Register keeping the full load capability of LDO regulator (ACTIVE mode) during the SLEEP state of the device. When control bit = 1, LDO regulator full load capability (ACTIVE mode) is maintained during device SLEEP state. When control bit = 0, the LDO regulator is set or stay in low-power mode during device SLEEP state (but then supply state can be overwritten programming ST[1:0]). Control bit value has no effect if the LDO regulator is off. When corresponding control bit = 1 in EN1_LDO_ASS register: Configuration Register setting the LDO regulator state driven by SCLSR_EN1 signal low level (when SCLSR_EN1 is high the regulator is on, full power): - the regulator is set off if its corresponding Control bit = 0 in SLEEP_KEEP_LDO_ON register (default) - the regulator is set in low-power mode if its corresponding control bit = 1 in SLEEP_KEEP_LDO_ON register														
Type	RW														
7		6		5		4		3		2		1		0	
LDO3_KEEPO_N		LDO4_KEEPO_N		LDO7_KEEPO_N		LDO8_KEEPO_N		LDO5_KEEPO_N		LDO2_KEEPO_N		LDO1_KEEPO_N		LDO6_KEEPO_N	

Bits	Field Name	Description	Type	Reset
7	LDO3_KEEPO_N	Setting supply state during device SLEEP state or when SCLSR_EN1 is low	RW	0
6	LDO4_KEEPO_N	Setting supply state during device SLEEP state or when SCLSR_EN1 is low	RW	0
5	LDO7_KEEPO_N	Setting supply state during device SLEEP state or when SCLSR_EN1 is low	RW	0
4	LDO8_KEEPO_N	Setting supply state during device SLEEP state or when SCLSR_EN1 is low	RW	0
3	LDO5_KEEPO_N	Setting supply state during device SLEEP state or when SCLSR_EN1 is low	RW	0
2	LDO2_KEEPO_N	Setting supply state during device SLEEP state or when SCLSR_EN1 is low	RW	0
1	LDO1_KEEPO_N	Setting supply state during device SLEEP state or when SCLSR_EN1 is low	RW	0
0	LDO6_KEEPO_N	Setting supply state during device SLEEP state or when SCLSR_EN1 is low	RW	0

Table 11-54. SLEEP_KEEP_RES_ON_REG

Address Offset	0x42						
Physical Address	Instance						
Description	Configuration Register keeping, during the SLEEP state of the device (but then supply state can be overwritten programming ST[1:0]): - the full load capability of LDO regulator (ACTIVE mode), - The PWM mode of DCDC converter - 32-kHz clock output - Register access through I ² C interface (keeping the internal high speed clock on) - Die Thermal monitoring on Control bit value has no effect if the resource is off.						
Type	RW						
7	6	5	4	3	2	1	0
THERM_KEEP ON	CLKOUT32K_K EEPON	VRTC_KEEPO N	I2CHS_KEEPO N	Reserved	VDD2_KEEPO N	VDD1_KEEPO N	VIO_KEEPO

Bits	Field Name	Description	Type	Reset
7	THERM_KEEPO	When 1, thermal monitoring is maintained during device SLEEP state. When 0, thermal monitoring is turned off during device SLEEP state.	RW	0
6	CLKOUT32K_KEEPO	When 1, CLK32KOUT output is maintained during device SLEEP state. When 0, CLK32KOUT output is set low during device SLEEP state.	RW	0
5	VRTC_KEEPO	When 1, LDO regulator full load capability (ACTIVE mode) is maintained during device SLEEP state. When 0, the LDO regulator is set or stays in low-power mode during device SLEEP state.	RW	0
4	I2CHS_KEEPO	When 1, high speed internal clock is maintained during device SLEEP state. When 0, high speed internal clock is turned off during device SLEEP state.	RW	0
3	Reserved		RO	0
2	VDD2_KEEPO	When 1, VDD2 SMPS PWM mode is maintained during device SLEEP state. No effect if VDD2 working mode is PFM. When 0, VDD2 SMPS PFM mode is set during device SLEEP state.	RW	0
1	VDD1_KEEPO	When 1, VDD1 SMPS PWM mode is maintained during device SLEEP state. No effect if VDD1 working mode is PFM. When 0, VDD1 SMPS PFM mode is set during device SLEEP state.	RW	0
0	VIO_KEEPO	When 1, VIO SMPS PWM mode is maintained during device SLEEP state. No effect if VIO working mode is PFM. When 0, VIO SMPS PFM mode is set during device SLEEP state.	RW	0

Table 11-55. SLEEP_SET_LDO_OFF_REG

Address Offset		0x43													
Physical Address		Instance (RESET DOMAIN: GENERAL RESET)													
Description		Configuration Register turning-off LDO regulator during the SLEEP state of the device. Corresponding *_KEEP_ON control bit in SLEEP_KEEP_RES_ON register should be 0 to make this *_SET_OFF control bit effective													
Type		RW													
7		6		5		4		3		2		1		0	
LDO3_SETOFF		LDO4_SETOFF		LDO7_SETOFF		LDO8_SETOFF		LDO5_SETOFF		LDO2_SETOFF		LDO1_SETOFF		LDO6_SETOFF	

Bits	Field Name	Description	Type	Reset
7	LDO3_SETOFF	When 1, LDO regulator is turned off during device SLEEP state. When 0, No effect	RW	0
6	LDO4_SETOFF	When 1, LDO regulator is turned off during device SLEEP state. When 0, No effect	RW	0

Bits	Field Name	Description	Type	Reset
5	LDO7_SETOFF	When 1, LDO regulator is turned off during device SLEEP state. When 0, No effect	RW	0
4	LDO8_SETOFF	When 1, LDO regulator is turned off during device SLEEP state. When 0, No effect	RW	0
3	LDO5_SETOFF	When 1, LDO regulator is turned off during device SLEEP state. When 0, No effect	RW	0
2	LDO2_SETOFF	When 1, LDO regulator is turned off during device SLEEP state. When 0, No effect	RW	0
1	LDO1_SETOFF	When 1, LDO regulator is turned off during device SLEEP state. When 0, No effect	RW	0
0	LDO6_SETOFF	When 1, LDO regulator is turned off during device SLEEP state. When 0, No effect	RW	0

Table 11-56. SLEEP_SET_RES_OFF_REG

Address Offset		0x44													
Physical Address		Instance (RESET DOMAIN: GENERAL RESET)													
Description		Configuration Register turning-off SMPS regulator during the SLEEP state of the device. Corresponding *_KEEP_ON control bit in SLEEP_KEEP_RES_ON2 register should be 0 to make this *_SET_OFF control bit effective. Supplies voltage expected after their wake-up (SLEEP-to-ACTIVE state transition) can also be programmed.													
Type		RW													
7		6		5		4		3		2		1		0	
DEFAULT_VOLT		Reserved		SPARE_SETOFF		VDDCTRL_SETOFF		VDD2_SETOFF		VDD1_SETOFF		VIO_SETOFF			

Bits	Field Name	Description	Type	Reset
7	DEFAULT_VOLT	When 1, default voltages (register value after switch-on) will be applied to all resources during SLEEP-to-ACTIVE transition. When 0, voltages programmed before the ACTIVE-to-SLEEP state transition will be used to turned-on supplies during SLEEP-to-ACTIVE state transition.	RW	0
6:5	Reserved		RO R returns 0s	0x0
4	SPARE_SETOFF	Spare bit	RW	0
3	VDDCTRL_SETOFF	When 1, SMPS is turned off during device SLEEP state. When 0, No effect.	RW	0
2	VDD2_SETOFF	When 1, SMPS is turned off during device SLEEP state. When 0, No effect.	RW	0
1	VDD1_SETOFF	When 1, SMPS is turned off during device SLEEP state. When 0, No effect.	RW	0
0	VIO_SETOFF	When 1, SMPS is turned off during device SLEEP state. When 0, No effect.	RW	0

Table 11-57. EN1_LDO_ASS_REG

Address Offset		0x45	
Physical Address		Instance	(RESET DOMAIN: TURNOFF RESET)

Table 11-57. EN1_LDO_ASS_REG (continued)

Description

Configuration Register setting the LDO regulators, driven by the multiplexed SCLSR_EN1 signal.

When control bit = 1, LDO regulator state is driven by the SCLSR_EN1 control signal and is also defined though SLEEP_KEEP_LDO_ON register setting:

When SCLSR_EN1 is high the regulator is on,

When SCLSR_EN1 is low:

- the regulator is off if its corresponding Control bit = 0 in SLEEP_KEEP_LDO_ON register
- the regulator is working in low-power mode if its corresponding control bit = 1 in SLEEP_KEEP_LDO_ON register

When control bit = 0 no effect: LDO regulator state is driven though registers programming and the device state

Any control bit of this register set to 1 will disable the I²C SR Interface functionality

Type

RW

7	6	5	4	3	2	1	0
LDO3_EN1	LDO4_EN1	LDO7_EN1	LDO8_EN1	LDO5_EN1	LDO2_EN1	LDO1_EN1	LDO6_EN1

Bits	Field Name	Description	Type	Reset
7	LDO3_EN1	Setting supply state control though SCLSR_EN1 signal	RW	0
6	LDO4_EN1	Setting supply state control though SCLSR_EN1 signal	RW	0
5	LDO7_EN1	Setting supply state control though SCLSR_EN1 signal	RW	0
4	LDO8_EN1	Setting supply state control though SCLSR_EN1 signal	RW	0
3	LDO5_EN1	Setting supply state control though SCLSR_EN1 signal	RW	0
2	LDO2_EN1	Setting supply state control though SCLSR_EN1 signal	RW	0
1	LDO1_EN1	Setting supply state control though SCLSR_EN1 signal	RW	0
0	LDO6_EN1	Setting supply state control though SCLSR_EN1 signal	RW	0

Table 11-58. EN1_SMPS_ASS_REG

Address Offset	0x46																					
Physical Address	Instance			(RESET DOMAIN: TURNOFF RESET)																		
Description	Configuration Register setting the SMPS Supplies driven by the multiplexed SCLSR_EN1 signal. When control bit = 1, SMPS Supply state and voltage is driven by the SCLSR_EN1 control signal and is also defined though SLEEP_KEEP_RES_ON register setting. When control bit = 0 no effect: SMPS Supply state is driven though registers programming and the device state. Any control bit of this register set to 1 will disable the I ² C SR Interface functionality																					
Type	RW																					
<table><tr><td>7</td><td>6</td><td>5</td><td>4</td><td>3</td><td>2</td><td>1</td><td>0</td></tr><tr><td colspan="3">Reserved</td><td>SPARE_EN1</td><td>VDDCTRL_EN1 1</td><td>VDD2_EN1</td><td>VDD1_EN1</td><td>VIO_EN1</td></tr></table>							7	6	5	4	3	2	1	0	Reserved			SPARE_EN1	VDDCTRL_EN1 1	VDD2_EN1	VDD1_EN1	VIO_EN1
7	6	5	4	3	2	1	0															
Reserved			SPARE_EN1	VDDCTRL_EN1 1	VDD2_EN1	VDD1_EN1	VIO_EN1															
Bits	Field Name	Description	Type			Reset																
7:5	Reserved		RO R returns 0s			0x0																
4	SPARE_EN1	Spare bit	RW			0																
3	VDDCTRL_EN1	When control bit = 1: When EN1 is high the supply voltage is programmed though VDDCtrl_OP_REG register, and it can also be programmed off. When EN1 is low the supply voltage is programmed though VDDCtrl_SR_REG register, and it can also be programmed off. When control bit = 0: No effect: Supply state is driven though registers programming and the device state	RW			0																

Bits	Field Name	Description	Type	Reset
2	VDD2_EN1	When control bit = 1: When SCLSR_EN1 is high the supply voltage is programmed though VDD2_OP_REG register, and it can also be programmed off. When SCLSR_EN1 is low the supply voltage is programmed though VDD2_SR_REG register, and it can also be programmed off. When SCLSR_EN1 is low and SLEEP_KEEP_RES_ON = 1 the SMPS is working in low-power mode, if not tuned off through VDD2_SR_REG register. When control bit = 0 No effect: Supply state is driven though registers programming and the device state	RW	0
1	VDD1_EN1	When 1: When SCLSR_EN1 is high the supply voltage is programmed though VDD1_OP_REG register, and it can also be programmed off. When SCLSR_EN1 is low the supply voltage is programmed though VDD1_SR_REG register, and it can also be programmed off. When SCLSR_EN1 is low and SLEEP_KEEP_RES_ON = 1 the SMPS is working in low-power mode, if not tuned off though VDD1_SR_REG register. When control bit = 0 no effect: supply state is driven though registers programming and the device state	RW	0
0	VIO_EN1	When control bit = 1, supply state is driven by the SCLSR_EN1 control signal and is also defined though SLEEP_KEEP_RES_ON register setting: When SCLSR_EN1 is high the supply is on, When SCLSR_EN1 is low: - the supply is off (default) or the SMPS is working in low-power mode if its corresponding control bit = 1 in SLEEP_KEEP_RES_ON register When control bit = 0 No effect: SMPS state is driven though registers programming and the device state	RW	0

Table 11-59. EN2_LDO_ASS_REG

Address Offset	0x47														
Physical Address	Instance (RESET DOMAIN: TURNOFF RESET)														
Description	Configuration Register setting the LDO regulators, driven by the multiplexed SDASR_EN2 signal. When control bit = 1, LDO regulator state is driven by the SDASR_EN2 control signal and is also defined though SLEEP_KEEP_LDO_ON register setting: When SDASR_EN2 is high the regulator is on, When SCLSR_EN2 is low: - the regulator is off if its corresponding Control bit = 0 in SLEEP_KEEP_LDO_ON register - the regulator is working in low-power mode if its corresponding control bit = 1 in SLEEP_KEEP_LDO_ON register When control bit = 0 no effect: LDO regulator state is driven though registers programming and the device state Any control bit of this register set to 1 will disable the I ² C SR Interface functionality														
Type	RW														
7		6		5		4		3		2		1		0	
LDO3_EN2		LDO4_EN2		LDO7_EN2		LDO8_EN2		LDO5_EN2		LDO2_EN2		LDO1_EN2		LDO6_EN2	

Bits	Field Name	Description	Type	Reset
7	LDO3_EN2	Setting supply state control though SDASR_EN2 signal	RW	0
6	LDO4_EN2	Setting supply state control though SDASR_EN2 signal	RW	0
5	LDO7_EN2	Setting supply state control though SDASR_EN2 signal	RW	0
4	LDO8_EN2	Setting supply state control though SDASR_EN2 signal	RW	0
3	LDO5_EN2	Setting supply state control though SDASR_EN2 signal	RW	0
2	LDO2_EN2	Setting supply state control though SDASR_EN2 signal	RW	0
1	LDO1_EN2	Setting supply state control though SDASR_EN2 signal	RW	0
0	LDO6_EN2	Setting supply state control though SDASR_EN2 signal	RW	0

Table 11-60. EN2_SMPS_ASS_REG

Address Offset	0x48														
Physical Address	Instance			(RESET DOMAIN: TURNOFF RESET)											
Description	Configuration Register setting the SMPS Supplies driven by the multiplexed SDASR_EN2 signal. When control bit = 1, SMPS Supply state and voltage is driven by the SDASR_EN2 control signal and is also defined though SLEEP_KEEP_RES_ON register setting. When control bit = 0 no effect: SMPS Supply state is driven though registers programming and the device state Any control bit of this register set to 1 will disable the I ² C SR Interface functionality														
Type	RW														
7		6		5		4		3		2		1		0	
Reserved				SPARE_EN2		VDDCTRL_EN2		VDD2_EN2		VDD1_EN2		VIO_EN2			

Bits	Field Name	Description	Type	Reset
7:5	Reserved		RO R returns 0s	0x0
4	SPARE_EN2	Spare bit	RW	0
3	VDDCTRL_EN2	When control bit = 1: When EN2 is high the supply voltage is programmed though VDDCtrl_OP_REG register, and it can also be programmed off.. When EN2 is low the supply voltage is programmed though VDDCtrl_SR_REG register, and it can also be programmed off. When EN2 is low and and VDDCtrl_KEEPPON = 1 the SMPS is working in low-power mode, if not tuned off though VDDCtrl_SR_REG register. When control bit = 0 no effect: Supply state is driven though registers programming and the device state	RW	0
2	VDD2_EN2	When control bit = 1: When SDASR_EN2 is high the supply voltage is programmed though VDD2_OP_REG register, and it can also be programmed off. When SDASR_EN2 is low the supply voltage is programmed though VDD2_SR_REG register, and it can also be programmed off. When SDASR_EN2 is low and and SLEEP_KEEP_RES_ON = 1 the SMPS is working in low-power mode, if not tuned off though VDD2_SR_REG register. When control bit = 0 no effect: Supply state is driven though registers programming and the device state	RW	0
1	VDD1_EN2	When control bit = 1: When SDASR_EN2 is high the supply voltage is programmed though VDD1_OP_REG register, and it can also be programmed off. When SDASR_EN2 is low the supply voltage is programmed though VDD1_SR_REG register, and it can also be programmed off. When SDASR_EN2 is low and and SLEEP_KEEP_RES_ON = 1 the SMPS is working in low-power mode, if not tuned off though VDD1_SR_REG register. When control bit = 0 no effect: supply state is driven though registers programming and the device state	RW	0
0	VIO_EN2	When control bit = 1, supply state is driven by the SCLSR_EN2 control signal and is also defined though SLEEP_KEEP_RES_ON register setting: When SDASR_EN2 is high the supply is on, When SDASR_EN2 is low : - the supply is off (default) or the SMPS is working in low-power mode if its corresponding control bit = 1 in SLEEP_KEEP_RES_ON register When control bit = 0 no effect: SMPS state is driven though registers programming and the device state	RW	0

Table 11-61. INT_STS_REG

Address Offset	0x50					
Physical Address	Instance			(RESET DOMAIN: FULL RESET)		

Table 11-61. INT_STS_REG (continued)

Description		Interrupt status register: The interrupt status bit is set to 1 when the associated interrupt event is detected. Interrupt status bit is cleared by writing 1.													
Type		RW													
7		6		5		4		3		2		1		0	
RTC_PERIOD_IT		RTC_ALARM_IT		HOTDIE_IT		PWRHOLD_R_IT		PWRON_LP_IT		PWRON_IT		VMBHI_IT		PWRHOLD_F_IT	

Bits	Field Name	Description	Type	Reset
7	RTC_PERIOD_IT	RTC period event interrupt status.	RW W1 to Clr	0
6	RTC_ALARM_IT	RTC alarm event interrupt status.	RW W1 to Clr	0
5	HOTDIE_IT	Hot-die event interrupt status.	RW W1 to Clr	0
4	PWRHOLD_R_IT	Rising PWRHOLD event interrupt status.	RW W1 to Clr	0
3	PWRON_LP_IT	PWRON Long Press event interrupt status.	RW W1 to Clr	0
2	PWRON_IT	PWRON event interrupt status.	RW W1 to Clr	0
1	VMBHI_IT	VBAT > VMHI event interrupt status	RW W1 to Clr	0
0	PWRHOLD_F_IT	Falling PWRHOLD event interrupt status.	RW W1 to Clr	0

Table 11-62. INT_MSK_REG

Address Offset		0x51													
Physical Address		Instance (RESET DOMAIN: GENERAL RESET)													
Description		Interrupt mask register: When *_IT_MSK is set to 1, the associated interrupt is masked: INT1 signal is not activated, but *_IT interrupt status bit is updated. When *_IT_MSK is set to 0, the associated interrupt is enabled: INT1 signal is activated, *_IT is updated.													
Type		RW													
7		6		5		4		3		2		1		0	
RTC_PERIOD_IT_MSK		RTC_ALARM_IT_MSK		HOTDIE_IT_MSK		PWRHOLD_R_IT_MSK		PWRON_LP_IT_MSK		PWRON_IT_MSK		VMBHI_IT_MSK		PWRHOLD_F_IT_MSK	

Bits	Field Name	Description	Type	Reset
7	RTC_PERIOD_IT_MSK	RTC period event interrupt mask.	RW	1
6	RTC_ALARM_IT_MSK	RTC alarm event interrupt mask.	RW	1
5	HOTDIE_IT_MSK	Hot die event interrupt mask.	RW	1
4	PWRHOLD_R_IT_MSK	PWRHOLD rising-edge event interrupt mask.	RW	1
3	PWRON_LP_IT_MSK	PWRON Long Press event interrupt mask.	RW	1
2	PWRON_IT_MSK	PWRON event interrupt mask.	RW	1

Bits	Field Name	Description	Type	Reset
1	VMBHI_IT_MSK	VBAT > VMBHI interrupt event mask bit When 0, interrupt not masked. Device automatically switches on at NO SUPPLY-to-OFF BACKUP-to-OFF transition When 1, interrupt is masked. Device does not switch on until a start reason is received. (EEPROM bit. Default value: See boot configuration)	RW	1
0	PWRHOLD_F_IT_MSK	PWRHOLD falling-edge event interrupt mask.	RW	1

Table 11-63. INT_STS2_REG

Address Offset		0x52													
Physical Address		Instance		(RESET DOMAIN: FULL RESET)											
Description		Interrupt status register: The interrupt status bit is set to 1 when the associated interrupt event is detected. Interrupt status bit is cleared by writing 1.													
Type		RW													
7		6		5		4		3		2		1		0	
GPIO3_F_IT		GPIO3_R_IT		GPIO2_F_IT		GPIO2_R_IT		GPIO1_F_IT		GPIO1_R_IT		GPIO0_F_IT		GPIO0_R_IT	

Bits	Field Name	Description	Type	Reset
7	GPIO3_F_IT	GPIO3 falling-edge detection interrupt status	RW W1 to Clr	0
6	GPIO3_R_IT	GPIO3 rising-edge detection interrupt status	RW W1 to Clr	0
5	GPIO2_F_IT	GPIO2 falling-edge detection interrupt status	RW W1 to Clr	0
4	GPIO2_R_IT	GPIO2 rising-edge detection interrupt status	RW W1 to Clr	0
3	GPIO1_F_IT	GPIO1 falling-edge detection interrupt status	RW W1 to Clr	0
2	GPIO1_R_IT	GPIO1 rising-edge detection interrupt status	RW W1 to Clr	0
1	GPIO0_F_IT	GPIO0 falling-edge detection interrupt status	RW W1 to Clr	0
0	GPIO0_R_IT	GPIO0 rising-edge detection interrupt status	RW W1 to Clr	0

Table 11-64. INT_MSK2_REG

Address Offset		0x53													
Physical Address		Instance		(RESET DOMAIN: GENERAL RESET)											
Description		Interrupt mask register: When *_IT_MSK is set to 1, the associated interrupt is masked: INT1 signal is not activated, but *_IT interrupt status bit is updated. When *_IT_MSK is set to 0, the associated interrupt is enabled: INT1 signal is activated, *_IT is updated.													
Type		RW													
7		6		5		4		3		2		1		0	
GPIO3_F_IT_M SK		GPIO3_R_IT_ MSK		GPIO2_F_IT_M SK		GPIO2_R_IT_ MSK		GPIO1_F_IT_M SK		GPIO1_R_IT_ MSK		GPIO0_F_IT_M SK		GPIO0_R_IT_ MSK	

Bits	Field Name	Description	Type	Reset
7	GPIO3_F_IT_MSK	GPIO3 falling-edge detection interrupt mask.	RW	1
6	GPIO3_R_IT_MSK	GPIO3 rising-edge detection interrupt mask.	RW	1
5	GPIO2_F_IT_MSK	GPIO2 falling-edge detection interrupt mask.	RW	1
4	GPIO2_R_IT_MSK	GPIO2 rising-edge detection interrupt mask.	RW	1
3	GPIO1_F_IT_MSK	GPIO1 falling-edge detection interrupt mask.	RW	1
2	GPIO1_R_IT_MSK	GPIO1 rising-edge detection interrupt mask.	RW	1
1	GPIO0_F_IT_MSK	GPIO0 falling-edge detection interrupt mask.	RW	1
0	GPIO0_R_IT_MSK	GPIO0 rising-edge detection interrupt mask.	RW	1

Table 11-65. INT_STS3_REG

Address Offset		0x54													
Physical Address		Instance		(RESET DOMAIN: FULL RESET)											
Description		Interrupt status register: The interrupt status bit is set to 1 when the associated interrupt event is detected. Interrupt status bit is cleared by writing 1.													
Type		RW													
7		6		5		4		3		2		1		0	
PWRDN_IT		VMBCH2_L_IT		VMBCH2_H_IT		WTCHDG_IT		GPIO5_F_IT		GPIO5_R_IT		GPIO4_F_IT		GPIO4_R_IT	

Bits	Field Name	Description	Type	Reset
7	PWRDN_IT	PWRDN reset input high detected	RW W1 to Clr	0
6	VMBCH2_L_IT	Comparator2 input below threshold detection interrupt status	RW W1 to Clr	0
5	VMBCH2_H_IT	Comparator2 input above threshold detection interrupt status	RW W1 to Clr	0
4	WTCHDG_IT	Watchdog interrupt status	RW W1 to Clr	0
3	GPIO5_F_IT	GPIO5 falling-edge detection interrupt status	RW W1 to Clr	0
2	GPIO5_R_IT	GPIO5 rising-edge detection interrupt status	RW W1 to Clr	0
1	GPIO4_F_IT	GPIO4 falling-edge detection interrupt status	RW W1 to Clr	0
0	GPIO4_R_IT	GPIO4 rising-edge detection interrupt status	RW W1 to Clr	0

Table 11-66. INT_MSK3_REG

Address Offset	0x55						
Physical Address				Instance	(RESET DOMAIN: GENERAL RESET)		
Description	Interrupt mask register: When *_IT_MSK is set to 1, the associated interrupt is masked: INT1 signal is not activated, but *_IT interrupt status bit is updated. When *_IT_MSK is set to 0, the associated interrupt is enabled: INT1 signal is activated, *_IT is updated.						
Type	RW						
7	6	5	4	3	2	1	0
PWRDN_IT_M SK	VMBCH2_L_IT MSK	VMBCH2_H_IT MSK	WTCHDG_IT_ MSK	GPIO5_F_IT_M SK	GPIO5_R_IT_ MSK	GPIO4_F_IT_M SK	GPIO4_R_IT_ MSK

Bits	Field Name	Description	Type	Reset
7	PWRDN_IT_MSK	PWRDN interrupt mask	RW	1
6	VMBCH2_L_IT_MSK	Comparator2 input below threshold detection interrupt mask	RW	1
5	VMBCH2_H_IT_MSK	Comparator2 input above threshold detection interrupt mask	RW	1
4	WTCHDG_IT_MSK	Watchdog interrupt mask.	RW	1
3	GPIO5_F_IT_MSK	GPIO5 falling-edge detection interrupt mask.	RW	1
2	GPIO5_R_IT_MSK	GPIO5 rising-edge detection interrupt mask.	RW	1
1	GPIO4_F_IT_MSK	GPIO4 falling-edge detection interrupt mask.	RW	1
0	GPIO4_R_IT_MSK	GPIO4 rising-edge detection interrupt mask.	RW	1

Table 11-67. GPIO0_REG

Address Offset		0x60					
Physical Address		Instance				(RESET DOMAIN: GENERAL RESET)	
Description		GPIO0 configuration register					
Type		RW					
7	6	5	4	3	2	1	0
GPIO_SLEEP	Reserved	GPIO_ODEN	GPIO_DEB	GPIO_PDEN	GPIO_CFG	GPIO_STS	GPIO_SET

Bits	Field Name	Description	Type	Reset
7	GPIO_SLEEP ⁽¹⁾	1: as GPO, force low 0: No impact, keep as in active mode	RW	0
6	Reserved	Reserved bit	RO R returns 0s	0
5	GPIO_ODEN	Selection of output mode, EEPROM bit 0: Push-pull output 1: Open-drain output (Default value: See boot configuration) GPIO assigned to power-up sequence, this bit will be set to 1 by a TURNOFF reset	RW	0
4	GPIO_DEB	GPIO input debouncing time configuration: When 0, the debouncing is 91.5 μs using a 30.5 μs clock rate When 1, the debouncing is 150 ms using a 50 ms clock rate	RW	0
3	GPIO_PDEN	GPIO pad pulldown control: 1: Pulldown is enabled 0: Pulldown is disabled	RW	0
2	GPIO_CFG	Configuration of the GPIO pad direction: When 0, the pad is configured as an input When 1, the pad is configured as an output (Default value: See boot configuration)	RW	0
1	GPIO_STS	Status of the GPIO pad	RO	1
0	GPIO_SET	Value set on the GPIO output when configured in output mode GPIO assigned to power-up sequence, this bit will be in TURNOFF reset	RW	0

- (1) The GPIO_SLEEP bit is a bit available only for GPIO_0/2/6/7. This bit will be taken into account and be effective only if the GPIO_0/2/6/7 is associated to a TIME_SLOT. It means that this bit is useful only if the GPIO is part of the POWER UP SEQUENCE. Please note that in this case the associated GPIO will be set as GPO. GPIO_SLEEP bit is a bit related to the PMU sleep mode only, No action in ACTIVE mode. It is used to define SLEEP mode state for GPIO 0/2/6/7.

Table 11-68. GPIO1_REG

Address Offset		0x61					
Physical Address		Instance				(RESET DOMAIN: GENERAL RESET)	
Description		GPIO1 configuration register					

Table 11-68. GPIO1_REG (continued)

Type	RW						
7	6	5	4	3	2	1	0
Reserved		GPIO_SEL	GPIO_DEB	GPIO_PDEN	GPIO_CFG	GPIO_STS	GPIO_SET

Bits	Field Name	Description	Type	Reset
7:6	Reserved		RO R returns 0s	0x0
5	GPIO_SEL	Select signal to be available at GPIO when configured as output: 0: GPIO_SET 1: LED1 out	RW	0
4	GPIO_DEB	GPIO input debouncing time configuration: When 0, the debouncing is 91.5 μs using a 30.5 μs clock rate When 1, the debouncing is 150 ms using a 50 ms clock rate	RW	0
3	GPIO_PDEN	GPIO pad pulldown control: 1: Pulldown is enabled 0: Pulldown is disabled	RW	1
2	GPIO_CFG	Configuration of the GPIO pad direction: When 0, the pad is configured as an input When 1, the pad is configured as an output	RW	0
1	GPIO_STS	Status of the GPIO pad	RO	1
0	GPIO_SET	Value set on the GPIO output when configured in output mode	RW	0

Table 11-69. GPIO2_REG

Address Offset		0x62													
Physical Address		Instance				(RESET DOMAIN: GENERAL RESET)									
Description		GPIO2 configuration register													
Type		RW													
7		6		5		4		3		2		1		0	
GPIO_SLEEP		Reserved		GPIO_DEB		GPIO_PDEN		GPIO_CFG		GPIO_STS		GPIO_SET			

Bits	Field Name	Description	Type	Reset
7	GPIO_SLEEP	1: as GPO, force low 0: no impact, keep as in active mode	RW	0
6:5	Reserved		RO R returns 0s	0x0
4	GPIO_DEB	GPIO input debouncing time configuration: When 0, the debouncing is 91.5 μs using a 30.5 μs clock rate When 1, the debouncing is 150 ms using a 50 ms clock rate	RW	0
3	GPIO_PDEN	GPIO pad pulldown control: 1: Pulldown is enabled 0: Pulldown is disabled GPIO assigned to power-up sequence, this bit will be set to 0 by a TURNOFF reset	RW	1
2	GPIO_CFG	Configuration of the GPIO pad direction: When 0, the pad is configured as an input When 1, the pad is configured as an output (Default value: See boot configuration) GPIO assigned to power-up sequence, this bit will be set to 1 by a TURNOFF reset	RW	0
1	GPIO_STS	Status of the GPIO pad	RO	1
0	GPIO_SET	Value set on the GPIO output when configured in output mode GPIO assigned to power-up sequence, this bit will be in TURNOFF reset	RW	0

Table 11-70. GPIO3_REG

Address Offset	0x63					
Physical Address	Instance					
	(RESET DOMAIN: GENERAL RESET)					
Description	GPIO3 configuration register					
Type	RW					
7	6	5	4	3	2	1 0
Reserved	GPIO_SEL		GPIO_DEB	GPIO_PDEN	GPIO_CFG	GPIO_STS GPIO_SET

Bits	Field Name	Description	Type	Reset
7	Reserved		RO R returns 0s	0
6:5	GPIO_SEL	Select signal to be available at GPIO when configured as output: 00: GPIO_SET 01: LED2 out 10: PWM out	RW	0x0
4	GPIO_DEB	GPIO input debouncing time configuration: When 0, the debouncing is 91.5 μ s using a 30.5 μ s clock rate When 1, the debouncing is 150 ms using a 50 ms clock rate	RW	0
3	GPIO_PDEN	GPIO pad pulldown control: 1: Pulldown is enabled 0: Pulldown is disabled	RW	1
2	GPIO_CFG	Configuration of the GPIO pad direction: When 0, the pad is configured as an input When 1, the pad is configured as an output	RW	0
1	GPIO_STS	Status of the GPIO pad	RO	1
0	GPIO_SET	Value set on the GPIO output when configured in output mode	RW	0

Table 11-71. GPIO4_REG

Address Offset	0x64					
Physical Address	Instance					
	(RESET DOMAIN: GENERAL RESET)					
Description	GPIO4 configuration register					
Type	RW					
7	6	5	4	3	2	1 0
Reserved			GPIO_DEB	GPIO_PDEN	GPIO_CFG	GPIO_STS GPIO_SET

Bits	Field Name	Description	Type	Reset
7:5	Reserved		RO R returns 0s	0x0
4	GPIO_DEB	GPIO input debouncing time configuration: When 0, the debouncing is 91.5 μ s using a 30.5 μ s clock rate When 1, the debouncing is 150 ms using a 50 ms clock rate	RW	0
3	GPIO_PDEN	GPIO pad pulldown control: 1: Pulldown is enabled 0: Pulldown is disabled	RW	1
2	GPIO_CFG	Configuration of the GPIO pad direction: When 0, the pad is configured as an input When 1, the pad is configured as an output	RW	0
1	GPIO_STS	Status of the GPIO pad	RO	1
0	GPIO_SET	Value set on the GPIO output when configured in output mode	RW	0

Table 11-72. GPIO5_REG

Address Offset	0x65						
Physical Address	Instance (RESET DOMAIN: GENERAL RESET)						
Description	GPIO5 configuration register						
Type	RW						
7	6	5	4	3	2	1	0
Reserved			GPIO_DEB	GPIO_PDEN	GPIO_CFG	GPIO_STS	GPIO_SET

Bits	Field Name	Description	Type	Reset
7:5	Reserved		RO R returns 0s	0x0
4	GPIO_DEB	GPIO input debouncing time configuration: When 0, the debouncing is 91.5 μs using a 30.5 μs clock rate When 1, the debouncing is 150 ms using a 50 ms clock rate	RW	0
3	GPIO_PDEN	GPIO pad pulldown control: 1: Pulldown is enabled 0: Pulldown is disabled	RW	1
2	GPIO_CFG	Configuration of the GPIO pad direction: When 0, the pad is configured as an input When 1, the pad is configured as an output	RW	0
1	GPIO_STS	Status of the GPIO pad	RO	1
0	GPIO_SET	Value set on the GPIO output when configured in output mode	RW	0

Table 11-73. GPIO6_REG

Address Offset		0x66													
Physical Address				Instance				(RESET DOMAIN: GENERAL RESET)							
Description		GPIO6 configuration register													
Type		RW													
7		6		5		4		3		2		1		0	
GPIO_SLEEP		Reserved				GPIO_DEB		GPIO_PDEN		GPIO_CFG		GPIO_STS		GPIO_SET	

Bits	Field Name	Description	Type	Reset
7	GPIO_SLEEP	1: as GPO, force low 0: no impact, keep as in active mode	RW	0
6:5	Reserved		RO R returns 0s	0x0
4	GPIO_DEB	GPIO input debouncing time configuration: When 0, the debouncing is 91.5 μs using a 30.5 μs clock rate When 1, the debouncing is 150 ms using a 50 ms clock rate	RW	0
3	GPIO_PDEN	GPIO pad pulldown control: 1: Pulldown is enabled 0: Pulldown is disabled GPIO assigned to power-up sequence, this bit will be set to 0 by a TURNOFF reset	RW	1
2	GPIO_CFG	Configuration of the GPIO pad direction: When 0, the pad is configured as an input When 1, the pad is configured as an output (Default value: See boot configuration) GPIO assigned to power-up sequence, this bit will be set to 1 by a TURNOFF reset	RW	0
1	GPIO_STS	Status of the GPIO pad	RO	1

Bits	Field Name	Description	Type	Reset
0	GPIO_SET	Value set on the GPIO output when configured in output mode GPIO assigned to power-up sequence, this bit will be in TURNOFF reset	RW	0

Table 11-74. GPIO7_REG

Address Offset		0x67													
Physical Address		Instance				(RESET DOMAIN: GENERAL RESET)									
Description		GPIO7 configuration register													
Type		RW													
7		6		5		4		3		2		1		0	
GPIO_SLEEP		Reserved		GPIO_DEB		GPIO_PDEN		GPIO_CFG		GPIO_STS		GPIO_SET			

Bits	Field Name	Description	Type	Reset
7	GPIO_SLEEP	1: as GPO, force low 0: no impact, keep as in active mode	RW	0
6:5	Reserved		RO R returns 0s	0x0
4	GPIO_DEB	GPIO input debouncing time configuration: When 0, the debouncing is 91.5 μs using a 30.5 μs clock rate When 1, the debouncing is 150 ms using a 50 ms clock rate	RW	0
3	GPIO_PDEN	GPIO pad pulldown control: 1: Pulldown is enabled 0: Pulldown is disabled GPIO assigned to power-up sequence, this bit will be set to 0 by a TURNOFF reset	RW	1
2	GPIO_CFG	Configuration of the GPIO pad direction: When 0, the pad is configured as an input When 1, the pad is configured as an output (Default value: See boot configuration) GPIO assigned to power-up sequence, this bit will be set to 1 by a TURNOFF reset	RW	0
1	GPIO_STS	Status of the GPIO pad	RO	1
0	GPIO_SET	Value set on the GPIO output when configured in output mode GPIO assigned to power-up sequence, this bit will be in TURNOFF reset	RW	0

Table 11-75. GPIO8_REG

Address Offset		0x68													
Physical Address		Instance (RESET DOMAIN: GENERAL RESET)													
Description		GPIO8 configuration register													
Type		RW													
7		6		5		4		3		2		1		0	
Reserved		GPIO_SEL		GPIO_DEB		GPIO_PDEN		GPIO_CFG		GPIO_STS		GPIO_SET			

Bits	Field Name	Description	Type	Reset
7:6	Reserved		RO R returns 0s	0x0
5	GPIO_SEL	Select signal to be available at GPIO when configured as output: 0: GPIO_SET 1: PWM out	RW	0

Bits	Field Name	Description	Type	Reset
4	GPIO_DEB	GPIO input debouncing time configuration: When 0, the debouncing is 91.5 μ s using a 30.5 μ s clock rate When 1, the debouncing is 150 ms using a 50 ms clock rate	RW	0
3	GPIO_PDEN	GPIO pad pulldown control: 1: Pulldown is enabled 0: Pulldown is disabled	RW	1
2	GPIO_CFG	Configuration of the GPIO pad direction: When 0, the pad is configured as an input When 1, the pad is configured as an output	RW	0
1	GPIO_STS	Status of the GPIO pad	RO	1
0	GPIO_SET	Value set on the GPIO output when configured in output mode	RW	0

Table 11-76. WATCHDOG_REG

Address Offset	0x69					
Physical Address				Instance	(RESET DOMAIN: GENERAL RESET)	
Description	Watchdog					
Type	RW					
7	6	5	4	3	2	1 0
Reserved				WTCHDG_MODE	WTCHDG_TIME	

Bits	Field Name	Description	Type	Reset
7:4	Reserved		RO R returns 0s	0x0
3	WTCHDG_MODE	0: Periodic operation: A periodical interrupt is generated based on WTCHDG_TIME setting. IC will generate WTCHDOG shutdown if interrupt is not cleared during the period. 1: Interrupt mode: IC will generate WTCHDOG shutdown if an interrupt is pending (no cleared) more than WTCHDG_TIME s.	RW	0
2:0	WTCHDG_TIME	000: Watchdog disabled 001: 5 seconds 010: 10 seconds 011: 20 Seconds 100: 40 seconds 101: 60 seconds 110: 80 seconds 111: 100 seconds (EEPROM bit) (Default value: See boot configuration)	RW	0x0

Table 11-77. VMBCH_REG

Address Offset	0x6A						
Physical Address				Instance	(RESET DOMAIN: GENERAL RESET)		
Description	Comparator control register						
Type	RW						
7	6	5	4	3	2	1	0
Reserved		VMBCH_SEL					Reserved

Bits	Field Name	Description	Type	Reset
7:6	Reserved		RO R returns 0s	0x0
5:1	VMBCH_SEL	Battery voltage comparator threshold (EEPROM) 11000 to 11111: 3.5 V 10111: 3.45 V ... 01110: 3 V (default) ... 00101: 2.55 V 00001 to 00100: 2.5 V 00000: Bypass (Default value: See boot configuration)	RW	0x00
0	Reserved		RO R returns 0s	0

Table 11-78. VMBCH2_REG

Address Offset		0x6B					
Physical Address		Instance			(RESET DOMAIN: GENERAL RESET)		
Description		Comparator for detecting battery discharge below threshold level					
Type		RW					
7	6	5	4	3	2	1	0
Reserved		VMBDCH2_SEL					VMBDCH2_DEB

Bits	Field Name	Description	Type	Reset
7:6	Reserved		RO R returns 0s	0x0
5:1	VMBDCH2_SEL	Battery voltage comparator threshold 11000 to 11111: 3.5 V 10111: 3.45 V ... 00101: 2.55 V 00001 to 00100: 2.5 V 00000: Bypass	RW	0x00
0	VMBDCH2_DEB	Comp2 input debouncing time configuration: When 0, the debouncing is 91.5 μs using a 30.5 μs clock rate When 1, the debouncing is 150 ms using a 50 ms clock rate	RW	0

Table 11-79. LED_CTRL1_REG

Address Offset	0x6C						
Physical Address				Instance	(RESET DOMAIN: GENERAL RESET)		
Description	LED ON/OFF control register.						
Type	RW						
7	6	5	4	3	2	1	0
Reserved		LED2 PERIOD			LED1 PERIOD		

Bits	Field Name	Description	Type	Reset
7:6	Reserved		RO R returns 0s	0x0
5:3	LED2_PERIOD	Period of LED2 signal: 000: LED2 OFF 001: 0.125 s 010: 0.25 s ... 110: 4 s 111: 8 s	RW	0x0
2:0	LED1_PERIOD	Period of LED1 signal: 000: LED1 OFF 001: 0.125 s 010: 0.25 s ... 10: 2 s 110: 4 s 111: 8 s	RW	0x0

Table 11-80. LED_CTRL2_REG1

Address Offset		0x6D			
Physical Address		Instance		(RESET DOMAIN: GENERAL RESET)	
Description		LED ON/OFF control register.			
Type		RW			
7	6	5	4	3	2
Reserved		LED2_SEQ	LED1_SEQ	LED2_ON_TIME	
				LED1_ON_TIME	

Bits	Field Name	Description	Type	Reset
7:6	Reserved		RO R returns 0s	0x0
5	LED2_SEQ	When 1, LED2 will repeat 2 pulse sequence: ON (ON_TIME) - OFF (ON TIME) - ON (ON TIME) - OFF remainder of the period When 0, LED2 will generate 1 pulse: ON (ON_TIME) - OFF (ON TIME))	RW	0
4	LED1_SEQ	When 1, LED1 will repeat 2 pulse sequence: ON (ON_TIME) - OFF (ON TIME) - ON (ON TIME) - OFF remainder of the period. When 0, LED1 will generate 1 pulse: ON (ON_TIME) - OFF (ON TIME))	RW	0
3:2	LED2_ON_TIME	LED2 ON time: 00: 62.5 ms 01: 125 ms 10: 250 ms 11: 500 ms	RW	0x0
1:0	LED1_ON_TIME	LED1 ON time: 00: 62.5 ms 01: 125 ms 10: 250 ms 11: 500 ms	RW	0x0

Table 11-81. PWM_CTRL1_REG

Address Offset	0x6E		
Physical Address		Instance	(RESET DOMAIN: GENERAL RESET)
Description	PWM frequency		
Type	RW		

7	6	5	4	3	2	1	0
Reserved						PWM_FREQ	

Bits	Field Name	Description	Type	Reset
7:2	Reserved	Reserved bit	RO R returns 0s	0x00
1:0	PWM_FREQ	Frequency of PWM: 00: 500 Hz 01: 250 Hz 10: 125 Hz 11: 62.5 Hz	RW	0x0

Table 11-82. PWM_CTRL2_REG

Address Offset	0x6F								
Physical Address		Instance					(RESET DOMAIN: GENERAL RESET)		
Description	PWM duty cycle.								
Type	RW								
		7	6	5	4	3	2	1	0
		FREQ DUTY CYCLE							

Bits	Field Name	Description	Type	Reset
7:0	FREQ_DUTY_CYCLE	Duty cycle of PWM: 00000000: 0/256 ... 11111111: 255/256	RW	0x00

Table 11-83. SPARE_REG

Address Offset	0x70								
Physical Address		Instance (RESET DOMAIN: FULL RESET)							
Description	Spare functional register								
Type	RW								
		7	6	5	4	3	2	1	0
		SPARE							

Bits	Field Name	Description	Type	Reset
7:0	SPARE	Spare bits	RW	0x00

Table 11-84. VERNUM_REG

Address Offset		0x80		Instance		(RESET DOMAIN: FULL RESET)									
Physical Address															
Description		Silicon version number													
Type		RW													
7		6		5		4		3		2		1		0	
READ_BOOT		Reserved						VERNUM							

Bits	Field Name	Description	Type	Reset
7	READ_BOOT	To enable the read of the BOOT mode if you want to enter JTAG mode, this be must set to 1.	RW	0
6:4	Reserved	Reserved bit	RO R returns 0s	0x0
3:0	VERNUM	Value depending on silicon version number 0000 - Revision 1.0	RO	0x0

12 Device and Documentation Support

12.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 12-1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
TPS659110	Click here	Click here	Click here	Click here	Click here
TPS659112	Click here	Click here	Click here	Click here	Click here
TPS659113	Click here	Click here	Click here	Click here	Click here
TPS659116	Click here	Click here	Click here	Click here	Click here

12.2 Trademarks

JTAG is a registered trademark of JTAG Technologies, Inc.
All other trademarks are the property of their respective owners.

12.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.4 Glossary

12.4.1 Acronyms, Abbreviations, and Definitions

ACRONYM	DEFINITION
DDR	Dual-Data Rate (memory)
ES	Engineering Sample
ESD	Electrostatic Discharge
FET	Field Effect Transistor
EPC	Embedded Power Controller
FSM	Finite State Machine
GND	Ground
GPIO	General-Purpose I/O
HBM	Human Body Model
HD	Hot-Die
HS-I ² C	High-Speed I ² C
I ² C	Inter-Integrated Circuit
IC	Integrated Circuit
ID	Identification
IDDQ	Quiescent supply current
IEEE	Institute of Electrical and Electronics Engineers
IR	Instruction Register
I/O	Input/Output
JEDEC	Joint Electron Device Engineering Council
JTAG	Joint Test Action Group
LBC7	Lin Bi-CMOS 7 (360 nm)
LDO	Low Drop Output voltage linear regulator
LP	Low-Power application mode
LSB	Least Significant Bit
MMC	Multimedia Card

ACRONYM	DEFINITION
MOSFET	Metal Oxide Semiconductor Field Effect Transistor
NVM	Nonvolatile Memory
OD	Open Drain
OMAP™	Open Multimedia Application Platform™
RTC	Real-Time Clock
SMPS	Switched Mode Power Supply
SPI	Serial Peripheral Interface
POR	Power-On Reset

For additional terms, see [SLYZ022](#)–*TI Glossary*.

13 Detailed Revision History

Table 13-1. Detailed Revision History

Version	Literature Number	Date	Notes
*	SWCS049	June 2010	See ⁽¹⁾ .
A	SWCS049A	February 2011	See ⁽²⁾ .
B	SWCS049B	February 2011	See ⁽³⁾ .
C	SWCS049C	May 2011	See ⁽⁴⁾ .

(1) *TPS65911 Data Manual*, SWCS049 - Initial release.

(2) *TPS65911 Data Manual*, SWCS049A - Version A:

- Update [Figure 1-1](#): LDO1, LDO2, LDO3, LDO6, and LDO7.
- Remove table, *SUPPORTED PROCESSORS AND CORRESPONDING PART NUMBERS*
- Update [Section 5.3](#): Adjust pin names and add exception.
- Update [Section 5.5](#): VDDCtrl SMPS, update FET part number.
- Update: [Section 5.7](#): Add updated BOOT1 characteristics.
- Update: [Section 5.19](#): Update LDO1 and LDO2 characteristics.
- Update [Section 5.21](#): Update LDO5.
- Update [Section 5.22](#): Update LDO6, LDO7, and LDO8.
- Update [Table 8-1](#): Update LDO1, LDO2, LDO3, LDO7, and LDO8
- Update [Table 8-2](#): Remove SEL [6:0] selection bits.
- Update [Section 8.3.3.6](#): Add more explanation and reorganize section.
- Add explanation to: [Section 8.3.3.6](#), [Section 8.3.3.9](#), [Section 8.3.3.10](#), and [Section 8.3.3.11](#).
- Update [Section 8.10](#): Add [Section 8.10.1](#).
- Update [Table 11-1](#), Register Rest values.
- Update Register Table: [Table 11-38](#), [Table 11-39](#), [Table 11-48](#), and [Table 11-50](#).
- Update [Table 4-1](#): BGA Pin column.
- Update .

(3) *TPS65911 Data Manual*, SWCS049B - Version B:

- Update VCC6 in [Section 5.1](#).

(4) *TPS65911 Data Manual*, SWCS049C - Version C:

- Update [Table 4-1](#), BGA Pins: NRESPWRON, VCC1, GND1, VCCIO, GNDIO, AGND, and AGND2.

Table 13-1. Detailed Revision History (continued)

Version	Literature Number	Date	Notes
D	SWCS049D	July 2011	See ⁽⁵⁾ .
E	SWCS049E	July 2011	See ⁽⁶⁾ .
F	SWCS049F	August 2011	See ⁽⁷⁾ .

(5) *TPS65911 Data Manual*, SWCS049D - Version D:

- Update [Section 5.1](#):
 - Add VBACKUP
 - Voltage range on balls HDRST - Replace "VRTCMAX + 0.32 by "7"
- Update [Section 5.3](#):
 - Add VCC4 and VBACKUP
 - Input voltage range on pins or balls - Remove VCC4
- Update [Section 5.6](#): Change "HDRST programmable.." to "HDREST, PWRDN programmable.."
- Update [Section 5.14](#): Specify Input voltage range of VCC7
- Update [Section 5.15](#): Add discharge resistance
- Update [Section 5.16](#):
 - Add DC output voltage maximum value
 - Add discharge resistance
 - Update VGAIN_SEL test conditions and typ value
- Update [Section 5.17](#):
 - Add DC output voltage maximum value
 - Add discharge resistance
 - Update VGAIN_SEL test conditions
- Update [Section 5.18](#): Add tablenote to Rated output current 6000 mA
- Update [Section 6](#):
 - Update introductory statement
 - Add note to [Figure 6-1](#)
 - Align Parameters in [Table 6-1](#) with [Figure 6-1](#)
- Update [Section 7](#): Add note to [Figure 7-1](#)
- Update : Add J3 to AGND in [Table 4-1](#)
- Update [Section 8](#):
 - Update [Table 8-1](#): VDD1 and VDD2 voltages
 - Device POWER ON enable conditions: Add additional device power enable condition
 - Device SLEEP enable conditions: Replace "... keeping the SLEEP signal floating, or ..." with "... keeping the SLEEP signal in the active polarity state, or..."
 - Device reset scenarios: Replace "VCC7 < VBNPR" with " VDD7 < VBNPR and BB < VBNPR"
 - Update introduction for [Table 8-2](#)
 - Update [Table 8-2](#): Remove all values in EEPROM Boot column
 - Update [Table 8-3](#):
 - Remove all values in EEPROM Boot column
 - Update INT_MSK_REG.VMBHI_IT_MSK description
- Update [Section 5.4](#): Pin count from 96 to 98
- Update [Section 11](#):
 - Update [Table 11-32](#), [Table 11-33](#), [Table 11-35](#), and [Table 11-36](#): SEL bit description
 - Update [Table 11-62](#): Update VMBHI_IT_MSK bit description
 - Update [Table 11-75](#): Update GPIO_SEL bit description - Replace LED1 out with PWM out

(6) *TPS65911 Data Manual*, SWCS049E - Version E: Update .

(7) *TPS65911 Data Manual*, SWCS049F - Version F:

- Add .
- Add [Section 10](#).
- Update [Table 11-62](#): Update bit 1, VMBHI_IT_MSK description.
- Update [Section 8.3.1](#): Device reset scenarios: Replace "VDD7 < VBNPR" with " VCC7 < VBNPR"
- Add [Section 3.1](#).

Table 13-1. Detailed Revision History (continued)

Version	Literature Number	Date	Notes
G	SWCS049G	October 2011	See ⁽⁸⁾ .
H	SWCS049H	May 2012	See ⁽⁹⁾ .
I	SWCS049I	June 2012	See ⁽¹⁰⁾ .
J	SWCS049J	September 2012	See ⁽¹¹⁾ .
K	SWCS049K	December 2012	See ⁽¹²⁾ .
L	SWCS049L	February 2014	See ⁽¹³⁾ .
M	SWCS049M	May 2014	See ⁽¹⁴⁾ .

- (8) *TPS65911 Data Manual*, SWCS049G - Version G:
- Update [Section 5.19](#), [Section 5.20](#), [Section 5.21](#), [Section 5.22](#):
 - Update turn-on time
 - Update DC line regulation
 - Update [Section 5.15](#)
 - Update rated output current I_{OUTmax} .
 - Update [Section 5.16](#) and [Section 5.17](#)
 - Update rated output current I_{OUTmax} .
 - Update DC line regulation
 - Update DC load regulation
 - Update [Section 5.7](#)
 - Update Related Open-Drain I/Os: GPIO2, GPIO7
 - Update [Section 5.18](#)
 - Add Supply Current, Internal Reference Voltage, Output discharge, Output drivers, Boot strap switch, Duty and frequency control, softstart, current sense protection, UVLO, and thermal shutdown.
 - Remove DC line regulation, DC load regulation, Transient load regulation, Overshoot/undershoot, Rated output I_{OUTmax} , and Conversion efficiency.
 - [Section 5.15](#) and [Section 5.17](#) - Remove $I_{out} = 1500$ mA value
 - [Table 8-1](#) - Update VIO, VDD1, VDD2, and VDDCtrl
 - [Figure 1-1](#) - Update VIO, VDD1, and VDD2
- (9) *TPS65911 Data Manual*, SWCS049H - Version H:
- Update [Section 5.15](#)
 - Update Rated output current description- add ILMAX bit configuration
 - Update PMOS current limit (high-side) description
 - Update NMOS current limit (high-side) description
 - Update [Figure 7-1](#) - CLK32KOUT out pin name (fixed typo)
 - Update [Figure 8-1](#)
 - Update [Table 11-30](#), VIO_REG - Update ILMAX description
 - Update [Table 11-31](#), VDD1_REG - Update ILMAX and TSTEP field numbers and VGAIN_SEL description
 - Update [Table 11-34](#), VDD2_REG - Update VGAIN_SEL description; align bit field numbering
 - Update [Table 11-38](#), VDDCTRL_OP_REG - Update SEL description
 - Update [Table 11-39](#), VDDCTRL_SR_REG - Update SEL description
 - Update [Table 7-1](#) - $t_{dbPWRONF}$: PWRON falling-edge debouncing delay - Update unit of measure
 - Update [Table 7-2](#) - Replace tACT2SLP by tACT2SLPCK32K
 - Update [Figure 7-4](#) - Replace $t_{dONVMBHI}$ by $t_{dONPWHOLD}$
 - Update [Table 7-3](#) - Replace $t_{dONVMBHI}$ by $t_{dONPWHOLD}$
 - Update [Section 8.3.3.6](#) - Replace 100 μ s by 100 ms
 - Update [Table 11-51](#) - Add Bit 0,1, and 3 : TURN OFF RESET to the description
 - Update [Table 11-52](#) - Add TSLT_LENGTH: TURN OFF RESET to the description
 - Update [Table 11-67](#) - Add footnote
- (10) *TPS65911 Data Manual*, SWCS049I - Version I:
- Update [Section 5.1](#) - Add VDDIO
 - Update [Section 5.3](#) - Add VDDIO
 - Update [Section 5.6](#) - Remove PWRDN
 - Update [Table 4-1](#) - Remove PD from PWRDN
- (11) *TPS65911 Data Manual*, SWCS049J - Version J:
- Update [Section 5.3](#): Fix typo on HDRST pin
 - Update [Section 11](#): Update full reset:
 - Full reset: All digital logic of device is reset.
 - Caused by POR (power on reset) when $VCC7 < VBNPR$ and $BB < VBNPR$
- (12) *TPS65911 Data Manual*, SWCS049K - Version K
- Update [Table 8-3](#) - Changed VMBCH_REG to EEPROM
- (13) *TPS65911 Data Manual*, SWCS049L - Version L
- Update [Section 3.1](#) - Added TPS659116
- (14) *TPS65911 Data Manual*, SWCS049M - Version M
- Update [Section 3.1](#) - Added TPS65911062

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPS6591102A2ZRC	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	240	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS6591102A2	Samples
TPS6591102A2ZRCR	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS6591102A2	Samples
TPS6591102AA2ZRC	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	240	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS6591102AA2	Samples
TPS6591102AA2ZRCR	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR		TPS6591102AA2	Samples
TPS6591103A2ZRC	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	240	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS6591103A2	Samples
TPS6591103A2ZRCR	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS6591103A2	Samples
TPS6591104A2ZRC	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	240	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS6591104A2	Samples
TPS6591104A2ZRCR	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS6591104A2	Samples
TPS6591104DA2ZRC	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	240	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS6591104DA2	Samples
TPS6591104DA2ZRCR	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS6591104DA2	Samples
TPS6591104EA2ZRC	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	240	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	T6591104EA2	Samples
TPS6591104EA2ZRCR	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	T6591104EA2	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPS6591106A2ZRC	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	240	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	T6591106A2	Samples
TPS6591106A2ZRCR	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	T6591106A2	Samples
TPS6591109A2ZRC	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	240	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS6591109A2	Samples
TPS6591109A2ZRCR	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS6591109A2	Samples
TPS659110A2ZRC	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	240	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS659110A2	Samples
TPS659110A2ZRCR	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS659110A2	Samples
TPS659112A2ZRC	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	240	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS659112A2	Samples
TPS659112A2ZRCR	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS659112A2	Samples
TPS6591133A2ZRC	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	240	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS6591133A2	Samples
TPS6591133A2ZRCR	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS6591133A2	Samples
TPS659113A2ZRC	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	240	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS659113A2	Samples
TPS659113A2ZRCR	ACTIVE	BGA MICROSTAR JUNIOR	ZRC	98	2500	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR	-40 to 85	TPS659113A2	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

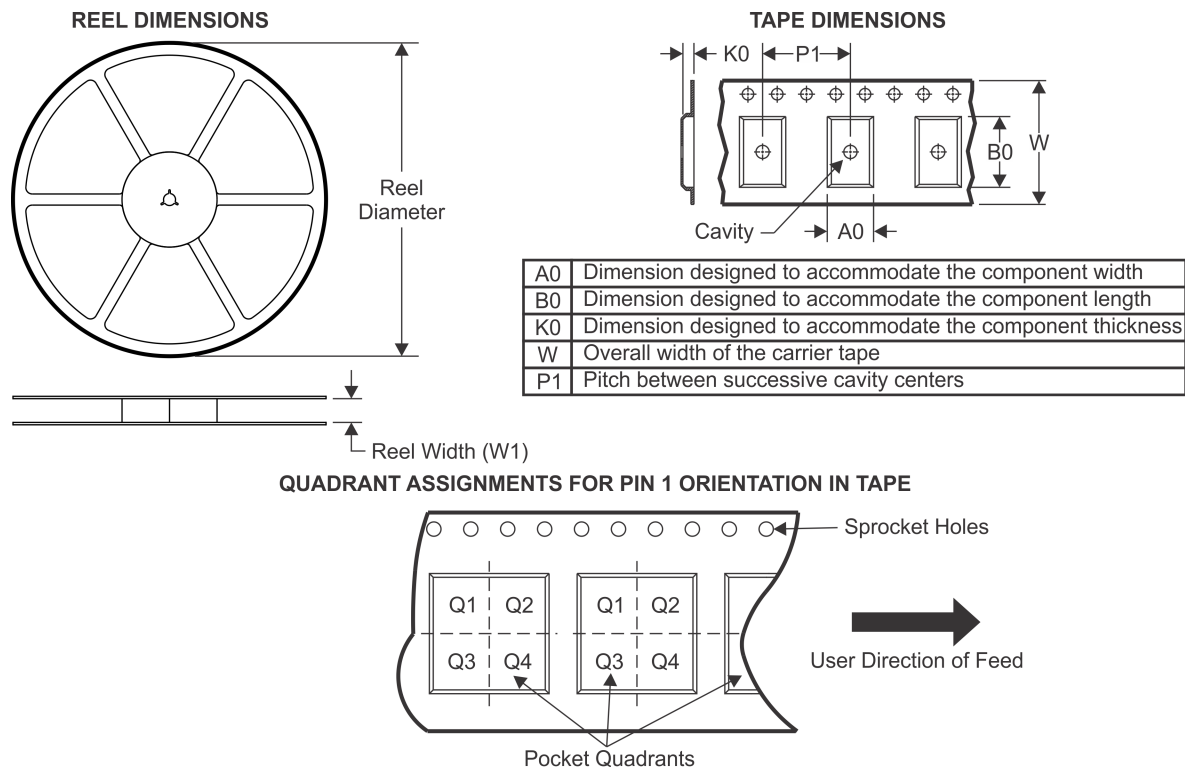
⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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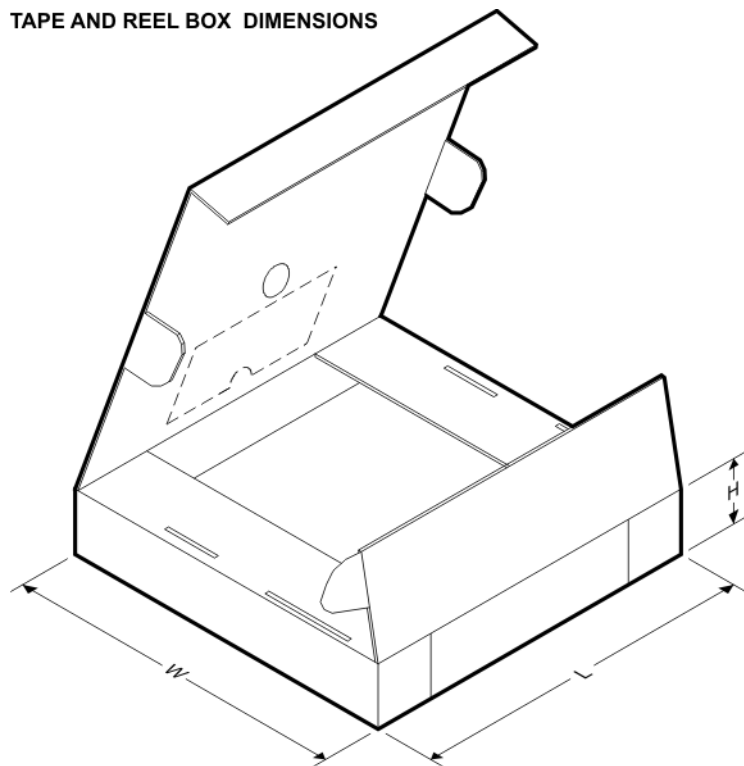
TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS6591102A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	330.0	16.4	6.3	9.3	1.5	12.0	16.0	Q1
TPS6591104A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	330.0	16.4	6.3	9.3	1.5	12.0	16.0	Q1
TPS6591104EA2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	330.0	16.4	6.3	9.3	1.5	12.0	16.0	Q1
TPS6591106A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	330.0	16.4	6.3	9.3	1.5	12.0	16.0	Q1
TPS6591109A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	330.0	16.4	6.3	9.3	1.5	12.0	16.0	Q1
TPS659110A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	330.0	16.4	6.3	9.3	1.5	12.0	16.0	Q1

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
	OR											
TPS659112A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	330.0	16.4	6.3	9.3	1.5	12.0	16.0	Q1
TPS6591133A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	330.0	16.4	6.3	9.3	1.5	12.0	16.0	Q1
TPS659113A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	330.0	16.4	6.3	9.3	1.5	12.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS



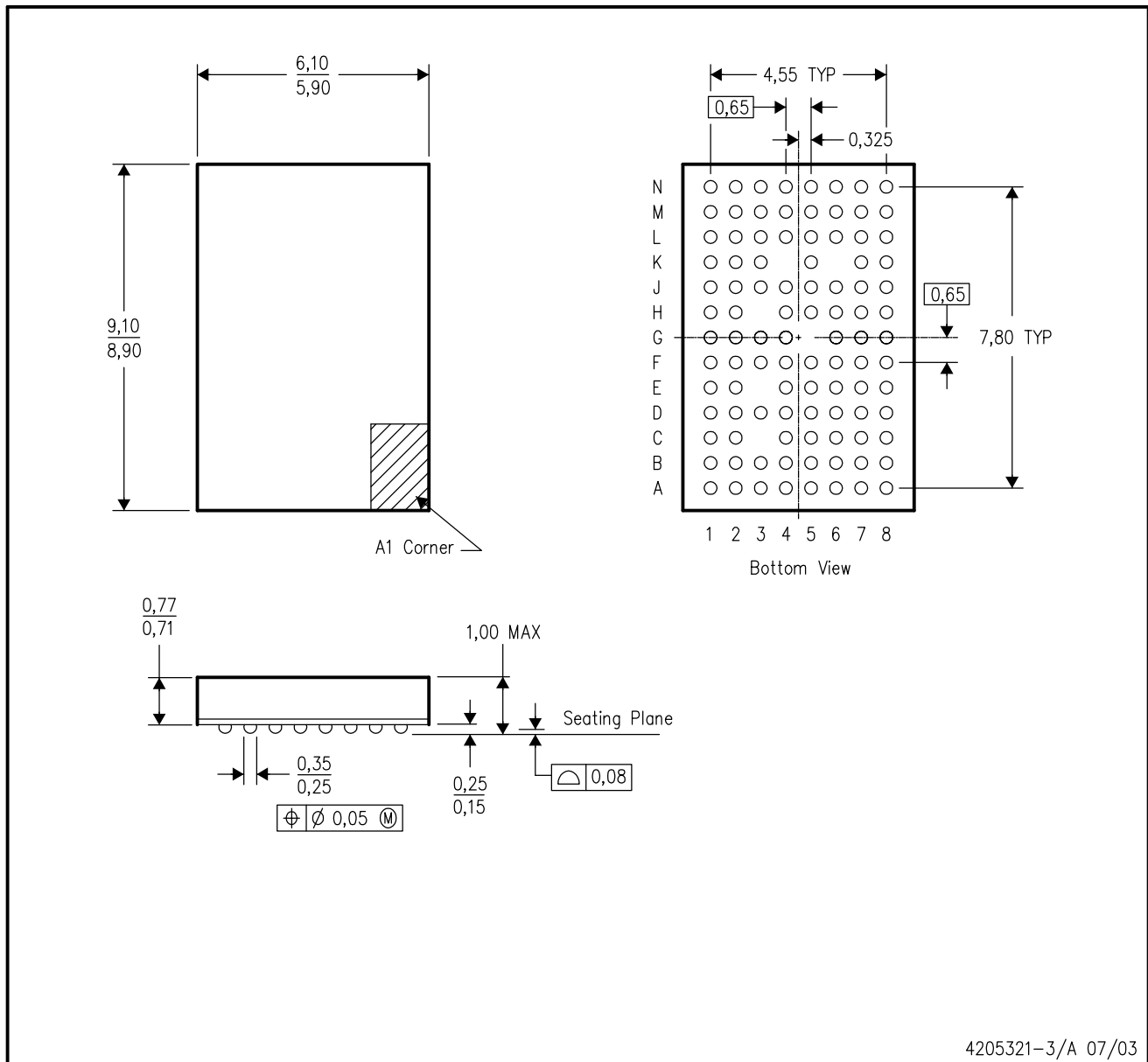
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS6591102A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	336.6	336.6	31.8
TPS6591104A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	336.6	336.6	31.8
TPS6591104EA2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	336.6	336.6	31.8
TPS6591106A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	336.6	336.6	31.8

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS6591109A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	336.6	336.6	31.8
TPS659110A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	336.6	336.6	31.8
TPS659112A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	336.6	336.6	31.8
TPS6591133A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	336.6	336.6	31.8
TPS659113A2ZRCR	BGA MICROSTAR JUNIOR	ZRC	98	2500	336.6	336.6	31.8

ZRC (S-PBGA-N98)

PLASTIC BALL GRID ARRAY



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. MicroStar Junior™ BGA configuration
 - D. Falls within JEDEC MO-225
 - E. This package is lead-free.

MicroStar Junior BGA is a trademark of Texas Instruments.

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